

Diagonal 8.923mm (Type 1/1.8) Progressive Scan CCD Image Sensor with Square Pixel for B/W Video Cameras

Description

The ICX274AL is a diagonal 8.923mm (Type 1/1.8) interline CCD solid-state image sensor with a square pixel array and 2.01M effective pixels. Progressive scan allows all pixels' signals to be output independently within approximately 1/15 second, and output is also possible using various addition and pulse elimination methods. This chip features an electronic shutter with variable charge-storage time which makes it possible to realize full-frame still images without a mechanical shutter. Further, high sensitivity and low dark current are achieved through the adoption of Super HAD CCD technology.

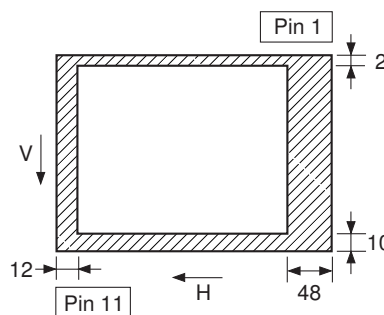
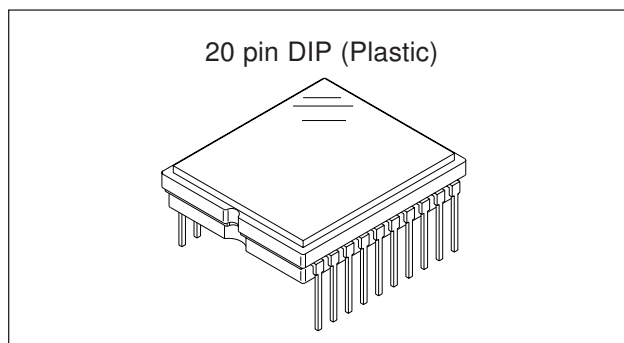
This chip is suitable for image input applications such as still cameras which require high resolution, etc.

Features

- High horizontal and vertical resolution
- Supports the following modes
 - Progressive scan mode (with/without mechanical shutter)
 - 2/8-line readout mode
 - 2/4-line readout mode
 - 2-line addition mode
 - Center scan modes (1), (2) and (3)
 - AF modes (1) and (2)
- Square pixel
- Horizontal drive frequency: 28.6364MHz (typ.), 36.0MHz (max.)
- Reset gate bias are not adjusted
- High sensitivity, low dark current
- Continuous variable-speed shutter function
- Excellent anti-blooming characteristics
- 20-pin high-precision plastic package

Device Structure

- Interline CCD image sensor
- Image size: Diagonal 8.923mm (Type 1/1.8)
- Total number of pixels: 1688 (H) × 1248 (V) approx. 2.11M pixels
- Number of effective pixels: 1628 (H) × 1236 (V) approx. 2.01M pixels
- Number of active pixels: 1620 (H) × 1220 (V) approx. 1.98M pixels
- Recommended number of recording pixels: 1600 (H) × 1200 (V) approx. 1.92M pixels
- Chip size: 8.50mm (H) × 6.80mm (V)
- Unit cell size: 4.40μm (H) × 4.40μm (V)
- Optical black:
 - Horizontal (H) direction: Front 12 pixels, rear 48 pixels
 - Vertical (V) direction: Front 10 pixels, rear 2 pixels
- Number of dummy bits:
 - Horizontal 28
 - Vertical 1
- Substrate material: Silicon

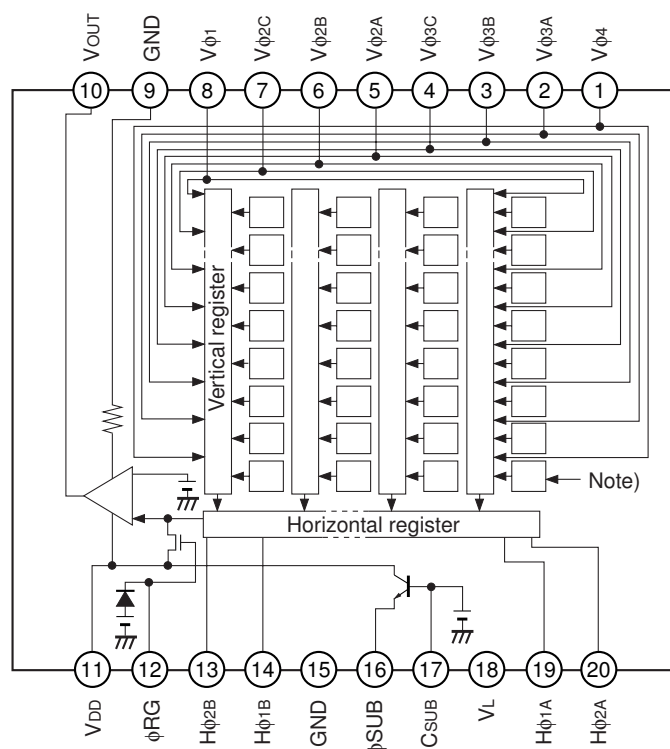


**Optical black position
(Top View)**

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Block Diagram and Pin Configuration

(Top View)



Note)  : Photo sensor

Pin Description

Pin No.	Symbol	Description	Pin No.	Symbol	Description
1	Vφ4	Vertical register transfer clock	11	V _{DD}	Supply voltage
2	Vφ3A	Vertical register transfer clock	12	φRG	Reset gate clock
3	Vφ3B	Vertical register transfer clock	13	Hφ2B	Horizontal register transfer clock
4	Vφ3C	Vertical register transfer clock	14	Hφ1B	Horizontal register transfer clock
5	Vφ2A	Vertical register transfer clock	15	GND	GND
6	Vφ2B	Vertical register transfer clock	16	φSUB	Substrate clock
7	Vφ2C	Vertical register transfer clock	17	CSUB	Substrate bias*1
8	Vφ1	Vertical register transfer clock	18	VL	Protective transistor bias
9	GND	GND	19	Hφ1A	Horizontal register transfer clock
10	V _{OUT}	Signal output	20	Hφ2A	Horizontal register transfer clock

*1 DC bias is generated within the CCD, so that this pin should be grounded externally through a capacitance of 0.1μF.

Absolute Maximum Ratings

Item		Ratings	Unit	Remarks
Against ϕSUB	$V_{DD}, V_{OUT}, \phi\text{RG} - \phi\text{SUB}$	-40 to +12	V	
	$V\phi_{2\alpha}, V\phi_{3\alpha} - \phi\text{SUB}$ ($\alpha = A$ to C)	-50 to +15	V	
	$V\phi_1, V\phi_4, V_L - \phi\text{SUB}$	-50 to +0.3	V	
	$H\phi_{1\beta}, H\phi_{2\beta}, \text{GND} - \phi\text{SUB}$ ($\beta = A, B$)	-40 to +0.3	V	
	$C_{SUB} - \phi\text{SUB}$	-25 to	V	
Against GND	$V_{DD}, V_{OUT}, \phi\text{RG}, C_{SUB} - \text{GND}$	-0.3 to +22	V	
	$V\phi_1, V\phi_{2\alpha}, V\phi_{3\alpha}, V\phi_4 - \text{GND}$ ($\alpha = A$ to C)	-10 to +18	V	
	$H\phi_{1\beta}, H\phi_{2\beta} - \text{GND}$ ($\beta = A, B$)	-10 to +6.5	V	
Against V_L	$V\phi_{2\alpha}, V\phi_{3\alpha} - V_L$ ($\alpha = A$ to C)	-0.3 to +28	V	
	$V\phi_1, V\phi_4, H\phi_{1\beta}, H\phi_{2\beta}, \text{GND} - V_L$ ($\beta = A, B$)	-0.3 to +15	V	
Between input clock pins	Voltage difference between vertical clock input pins	to +15	V	*2
	$H\phi_{1\beta} - H\phi_{2\beta}$ ($\beta = A, B$)	-6.5 to +6.5	V	
	$H\phi_{1\beta}, H\phi_{2\beta} - V\phi_4$ ($\beta = A, B$)	-10 to +16	V	
Storage temperature		-30 to +80	°C	
Guaranteed temperature of performance		-10 to +60	°C	
Operating temperature		-10 to +75	°C	

*2 +24V (Max.) is guaranteed when clock width < 10 μ s, clock duty factor < 0.1%.

+16V (Max.) is guaranteed during power-on or power-off.

Bias Conditions

Item		Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply voltage		V _{DD}	14.55	15.0	15.45	V	
Protective transistor bias		V _L	*3				
Substrate voltage adjustment range	No line addition*1	V _{SUB}	Internally generated value				*4
	2-line addition*2	V _{SUB2}	8.8		14.4	V	
Substrate voltage adjustment accuracy		ΔV _{SUB}	Indicated voltage – 0.2	Indicated voltage	Indicated voltage + 0.2	V	
Reset gate clock		φ _{RG}		*5		V	

*1 Progressive scan mode, 2/8-line readout mode, 2/4-line readout mode, center scan modes (1) and (3), and AF modes (1) and (2)

*2 2-line addition mode and center scan mode (2)

*3 V_L setting is the V_{VL} voltage of the vertical clock waveform, or the same voltage as the V_L power supply for the V driver should be used.

*4 Substrate voltage (V_{SUB2}) setting value indication

The substrate voltage (V_{SUB}) for modes without line addition is generated internally.

The substrate voltage setting value for use with vertical 2-line addition is indicated by a code on the bottom surface of the image sensor. Adjust the substrate voltage to the indicated voltage.

V_{SUB2} code – 1-digit indication ☐



V_{SUB2} code

The code and the actual value correspond as follows.

V _{SUB2} code	1	2	3	4	6	7	8	9	A	C	d	E	f	G	h
Actual value	8.8	9.0	9.2	9.4	9.6	9.8	10.0	10.2	10.4	10.6	10.8	11.0	11.2	11.4	11.6

V _{SUB2} code	J	K	L	m	N	P	R	S	U	V	W	X	Y	Z
Actual value	11.8	12.0	12.2	12.4	12.6	12.8	13.0	13.2	13.4	13.6	13.8	14.0	14.2	14.4

[Example] "h" indicates a V_{SUB2} setting of 11.6V.

*5 Do not apply a DC bias to the reset gate clock pin, because a DC bias is generated within the CCD.

DC characteristics

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Supply current	I _{DD}	7.0	10.0	13.0	mA	

Clock Voltage Conditions

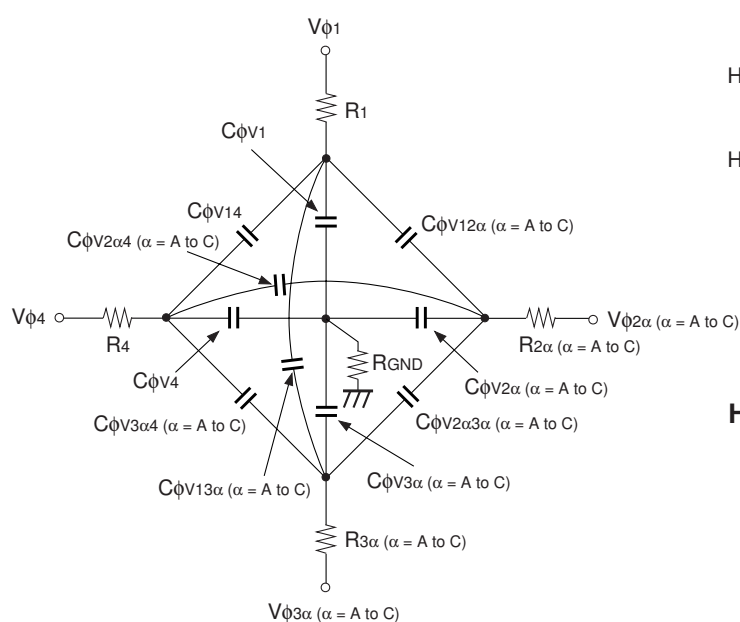
Item	Symbol	Min.	Typ.	Max.	Unit	Waveform diagram	Remarks
Readout clock voltage	V_{VT}	14.55	15.0	15.45	V	1	
Vertical transfer clock voltage	V_{VH1}, V_{VH2}	-0.05	0	0.05	V	2	$V_{VH} = (V_{VH1} + V_{VH2})/2$
	V_{VH3}, V_{VH4}	-0.2	0	0.05	V	2	
	$V_{VL1}, V_{VL2}, V_{VL3}, V_{VL4}$	-8.0	-7.5	-7.0	V	2	$V_{VL} = (V_{VL3} + V_{VL4})/2$
	$V_{\phi V}$	6.8	7.5	8.05	V	2	$V_{\phi V} = V_{VnH} - V_{VnL} (n = 1 \text{ to } 4)$
	$V_{VH3} - V_{VH}$	-0.25		0.1	V	2	
	$V_{VH4} - V_{VH}$	-0.25		0.1	V	2	
	V_{VHH}			0.5	V	2	High-level coupling
	V_{VHL}			0.5	V	2	High-level coupling
	V_{VLH}			0.5	V	2	Low-level coupling
	V_{VLL}			0.5	V	2	Low-level coupling
Horizontal transfer clock voltage	$V_{\phi H}$	4.75	5.0	5.25	V	3	
	V_{HL}	-0.05	0	0.05	V	3	
	V_{CR}	0.8	2.5		V	3	Cross-point voltage
Reset gate clock voltage	$V_{\phi RG}$	3.0	3.3	5.25	V	4	
	$V_{RGLH} - V_{RGLL}$			0.4	V	4	Low-level coupling
	$V_{RGL} - V_{RGLm}$			0.5	V	4	Low-level coupling
Substrate clock voltage	$V_{\phi SUB}$	21.5	22.5	23.5	V	5	

Clock Equivalent Circuit Constants

Item	Symbol	Min.	Typ.	Max.	Unit	Remarks
Capacitance between vertical transfer clock and GND	C ϕ V1		3300		pF	
	C ϕ V2A, C ϕ V2B		1200		pF	
	C ϕ V2C		2700		pF	
	C ϕ V3A, C ϕ V3B		1000		pF	
	C ϕ V3C		1800		pF	
	C ϕ V4		6800		pF	
Capacitance between vertical transfer clocks	C ϕ V12 (A, B)		120		pF	
	C ϕ V12C		220		pF	
	C ϕ V13 (A, B)		150		pF	
	C ϕ V13C		270		pF	
	C ϕ V14		2700		pF	
	C ϕ V2 (A, B), 3 (A, B)		470		pF	
	C ϕ V2 (A, B), 3C		680		pF	
	C ϕ V2 (A, B), 4		680		pF	
	C ϕ V2C, 3 (A, B)		1000		pF	
	C ϕ V2C, 3C		820		pF	
	C ϕ V2C, 4		1800		pF	
	C ϕ V3 (A, B), 4		820		pF	
	C ϕ V3C, 4		1500		pF	
Capacitance between horizontal transfer clock and GND	C ϕ H1		100		pF	
	C ϕ H2		100		pF	
Capacitance between horizontal transfer clocks	C ϕ HH		47		pF	
Capacitance between reset gate clock and GND	C ϕ RG		2		pF	
Capacitance between substrate clock and GND	C ϕ SUB		820		pF	
Vertical transfer clock series resistor	R1, R4		30		Ω	
	R2 (A, B, C), 3 (A, B, C)		62		Ω	
Vertical transfer clock ground resistor	R _{GND}		15		Ω	
Horizontal transfer clock series resistor	R ϕ H		7		Ω	
Horizontal transfer clock ground resistor	R ϕ H2		20		k Ω	
Reset gate clock and series resistor	R ϕ RG		4.7		Ω	

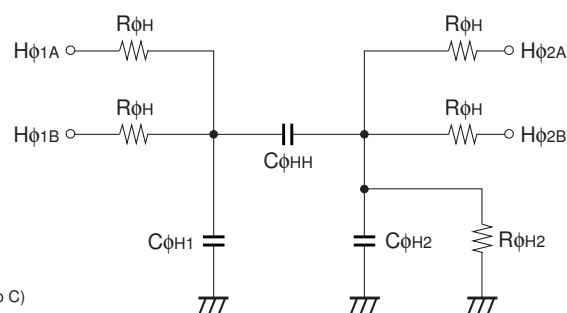
Note 1) Expressions using parentheses such as C ϕ V2 (A,B), 3C indicate items which include all combinations of the pins within the parentheses.

For example, C ϕ V2 (A, B), 3C indicates [C ϕ V2A3C, C ϕ V2B3C].

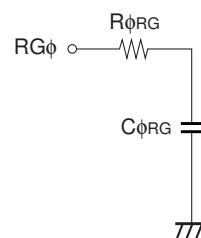


Note 2) $C\phi_{2\alpha 2\beta}$ and $C\phi_{3\alpha 3\beta}$ ($\alpha = A$ to C , $\beta = A$ to C other than α) are sufficiently small relative to other capacitance between other vertical clocks in the equivalent circuit, so these are omitted from the equivalent circuit diagram.

Vertical transfer clock equivalent circuit



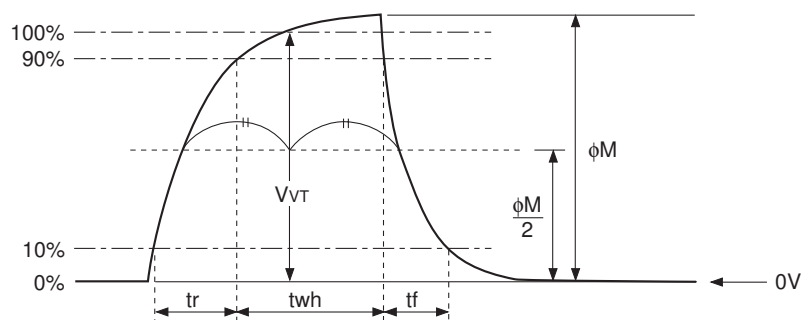
Horizontal transfer clock equivalent circuit



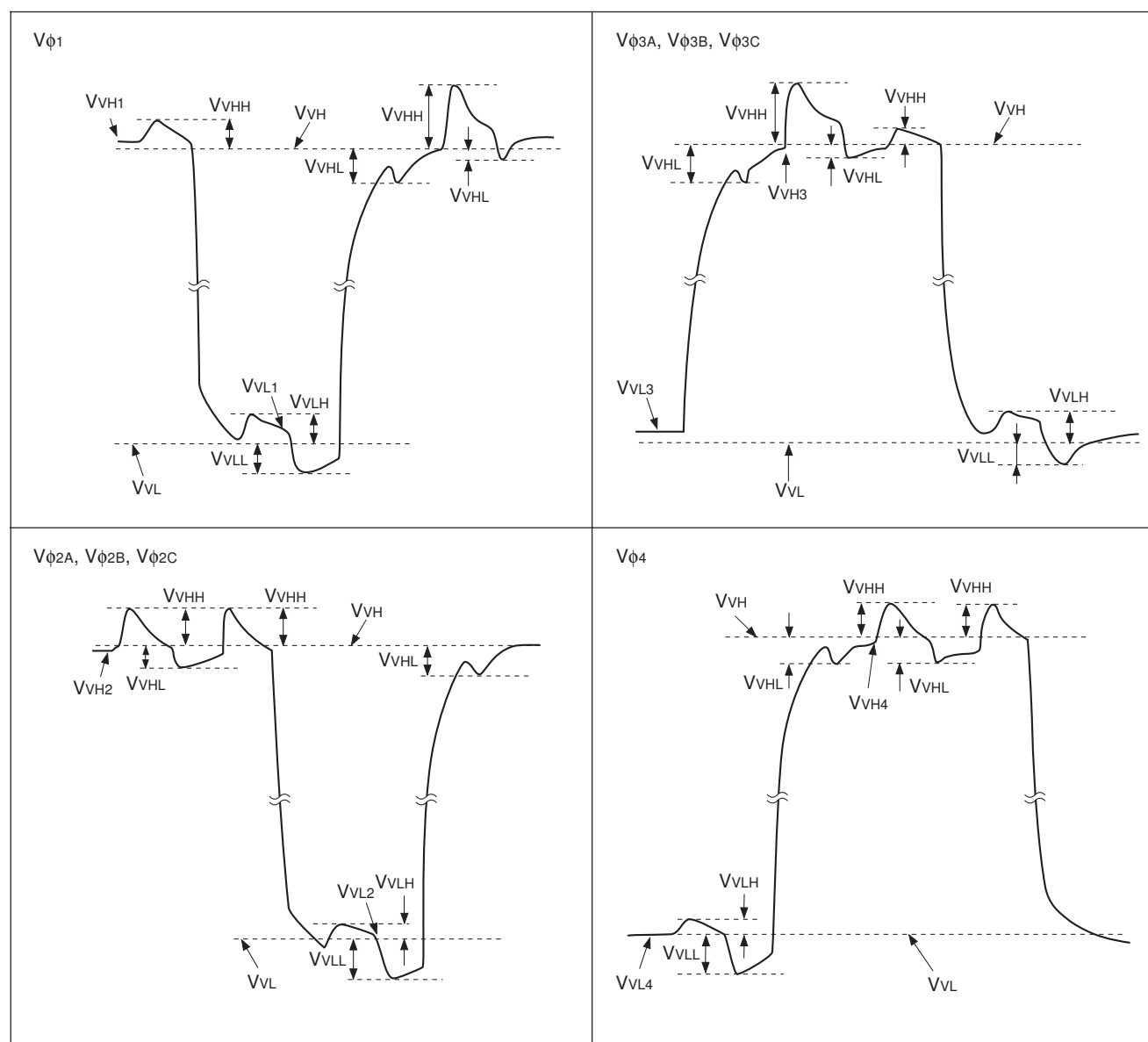
Reset gate clock equivalent circuit

Drive Clock Waveform Conditions

(1) Readout clock waveform



(2) Vertical transfer clock waveform

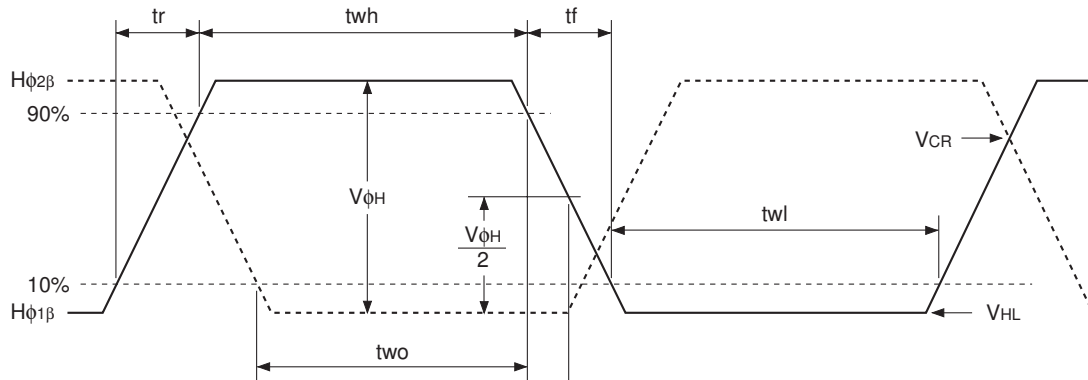


$$V_{VH} = (V_{VH1} + V_{VH2})/2$$

$$V_{VL} = (V_{VL3} + V_{VL4})/2$$

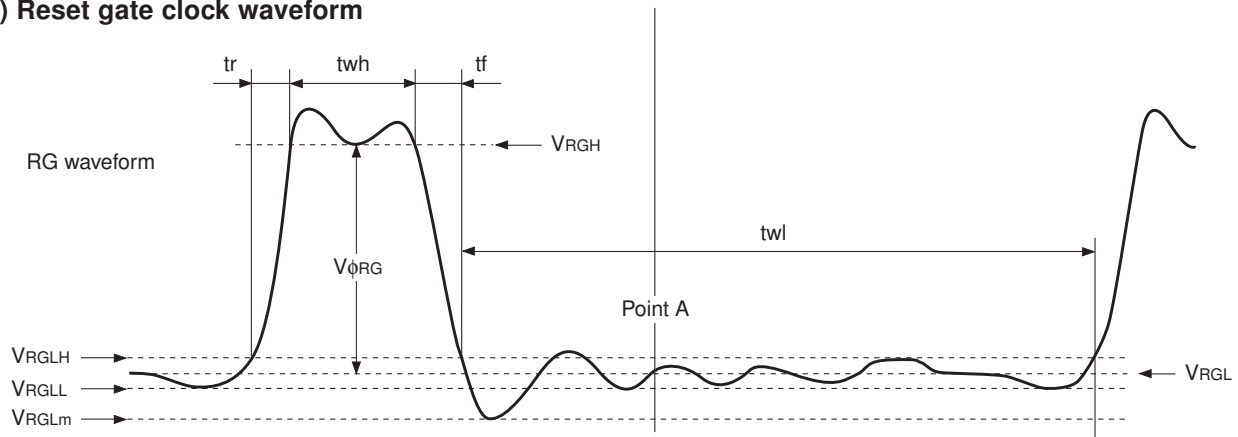
$$V_{\phi v} = V_{VHn} - V_{VLn} \quad (n = 1 \text{ to } 4)$$

(3) Horizontal transfer clock waveform



Cross-point voltage for the $H\phi_{1\beta}$ rising side of the horizontal transfer clocks $H\phi_{1\beta}$ and $H\phi_{2\beta}$ waveforms is V_{CR} . The overlap period for t_{wh} and t_{wl} of horizontal transfer clocks $H\phi_{1\beta}$ and $H\phi_{2\beta}$ is two . ($\beta = A, B$)

(4) Reset gate clock waveform



V_{RGLH} is the maximum value and V_{RGLL} is the minimum value of the coupling waveform during the period from Point A in the above diagram until the rising edge of RG.

In addition, V_{RGL} is the average value of V_{RGLH} and V_{RGLL} .

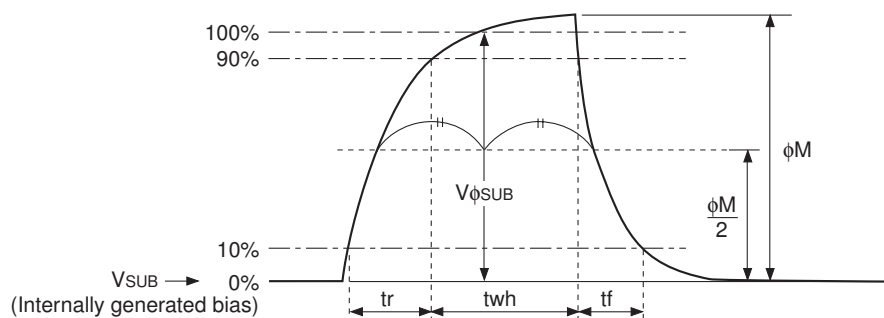
$$V_{RGL} = (V_{RGLH} + V_{RGLL})/2$$

Assuming V_{RGH} is the minimum value during the interval t_{wh} , then:

$$V_{\phi RG} = V_{RGH} - V_{RGL}$$

Negative overshoot level during the falling edge of RG is V_{RGLm} .

(5) Substrate clock waveform



Clock Switching Characteristics (Horizontal drive frequency: 28.6364MHz)

Item	Symbol	twh			twl			tr			tf			Unit	Remarks
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.		
Readout clock	V_T	3.3	3.5						0.5			0.5		μs	During readout
Vertical transfer clock	$V_{\phi 1}, V_{\phi 4}, V_{\phi 2\alpha}, V_{\phi 3\alpha}$ ($\alpha = A$ to C)										15		400	ns	*1
Horizontal transfer clock	$H_{\phi 1\beta}$ ($\beta = A, B$)	10	12.5		10	12.5			5	7.5		5	7.5	ns	*2
	$H_{\phi 2\beta}$ ($\beta = A, B$)	10	12.5		10	12.5			5	7.5		5	7.5		
Reset gate clock	ϕ_{RG}	4	7			24			2			3		ns	
Substrate clock	ϕ_{SUB}		2.1							0.5			0.5	μs	When draining charge

Item	Symbol	two			Unit	Remarks
		Min.	Typ.	Max.		
Horizontal transfer clock	$H_{\phi 1A}, H_{\phi 1B}, H_{\phi 2A}, H_{\phi 2B}$	8	10		ns	

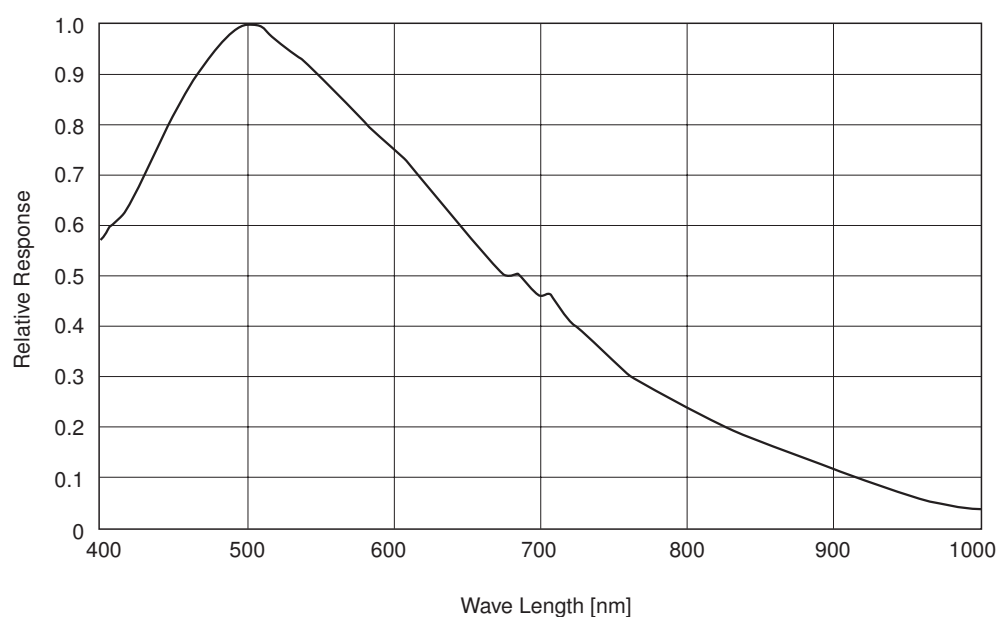
Clock Switching Characteristics (Horizontal drive frequency: 36MHz)

Item	Symbol	twh			twl			tr			tf			Unit	Remarks
		Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.	Min.	Typ.	Max.		
Readout clock	V_T	4.0	4.2						0.5			0.5		μs	During readout
Vertical transfer clock	$V_{\phi 1}, V_{\phi 4}, V_{\phi 2\alpha}, V_{\phi 3\alpha}$ ($\alpha = A$ to C)										15		400	ns	*1
Horizontal transfer clock	$H_{\phi 1\beta}$ ($\beta = A, B$)	8	9		8	9			5	6		5	6	ns	*2
	$H_{\phi 2\beta}$ ($\beta = A, B$)	8	9		8	9			5	6		5	6		
Reset gate clock	ϕ_{RG}	4	5.5			8			2			3		ns	
Substrate clock	ϕ_{SUB}		1.67							0.25			0.25	μs	When draining charge

Item	Symbol	two			Unit	Remarks
		Min.	Typ.	Max.		
Horizontal transfer clock	$H_{\phi 1A}, H_{\phi 1B}, H_{\phi 2A}, H_{\phi 2B}$	8	9		ns	

*1 When two vertical transfer clock drivers CXD3400N are used.

*2 $t_f \geq t_r - 2ns$, and the cross-point voltage (V_{CR}) for the $H_{\phi 1\beta}$ ($\beta = A, B$) rising side of the $H_{\phi 1\beta}$ and $H_{\phi 2\beta}$ waveforms must be $V_{\phi H}/2$ [V] or more.

Spectral Sensitivity Characteristics (excludes lens characteristics and light source characteristics)**Image Sensor Characteristics**

(Ta = 25 °C)

Item	Symbol	Min.	Typ.	Max.	Unit	Measurement method	Remarks
Sensitivity	S	335	420	545	mV	1	1/30s accumulation
Saturation signal	Vsat	400			mV	2	Ta = 60 °C No line addition* ² 2-line addition* ³
	Vsat2* ¹	400					
Smear	Sm		-100	-92	dB	3	Progressive scan mode* ⁴
			-94	-86			2/4-line readout mode* ⁵
			-88	-80			2/8-line readout mode* ⁶
Video signal shading	SH			20	%	4	Zone 0 and I
				25			Zone 0 to II'
Dark signal	Vdt			8	mV	5	Ta = 60 °C, 14.985 frame/s
Dark signal shading	ΔVdt			2	mV	6	Ta = 60 °C, 14.985 frame/s, * ⁷
Lag	Lag			0.5	%	7	

*¹ Vsat2 is the saturation signal level in 2-line addition mode, and is 200mV per pixel.

*² Progressive scan mode, 2/8-line readout mode, 2/4-line readout mode, and center scan modes (1) and (3).

*³ 2-line addition mode and center scan mode (2).

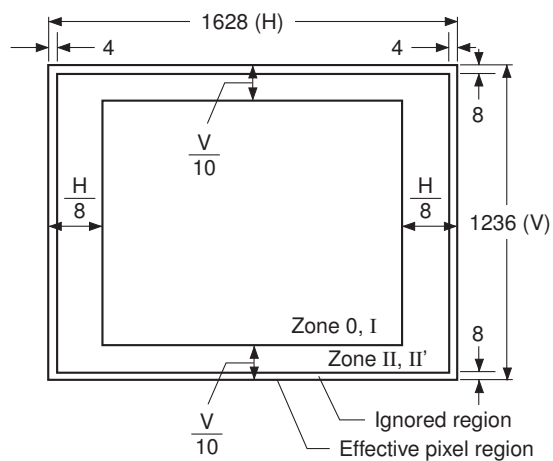
*⁴ Same for 2-line addition mode and center scan modes (2) and (3).

*⁵ Same for center scan mode (1).

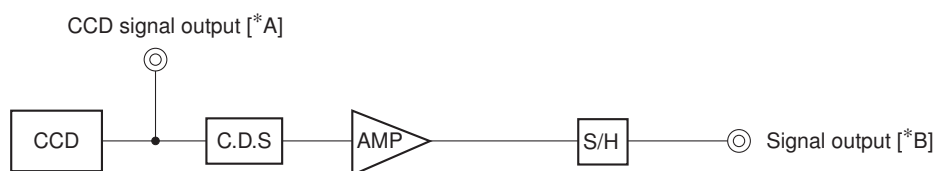
*⁶ Same for AF modes (1) and (2).

*⁷ Excludes vertical dark signal shading caused by vertical register high-speed transfer.

Zone Definition of Video Signal Shading



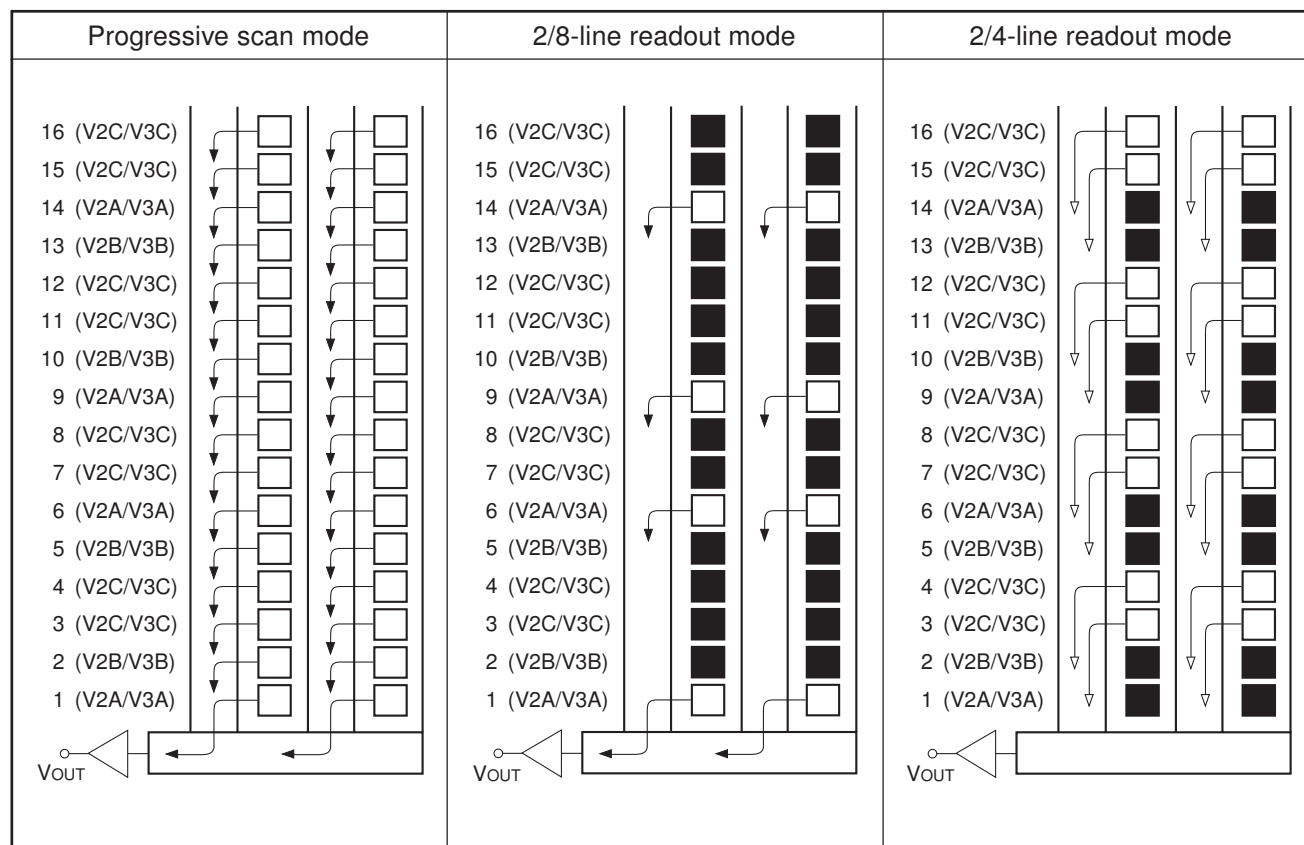
Measurement System



Note) Adjust the AMP gain so that the gain between [*A] and [*B] equals 1.

◎ Readout modes

The diagrams below and on the following pages show the output methods for the following nine readout modes.



Note) Blacked out portions in the diagram indicate pixels which are not read out.

Output starts from line 1 in 2/8-line decimation mode.

1. Progressive scan mode

In this mode, all pixel signals are output in non-interlace format in 1/14.985s.

All pixel signals within the same exposure period are read out simultaneously, making this mode suitable for high resolution image capturing.

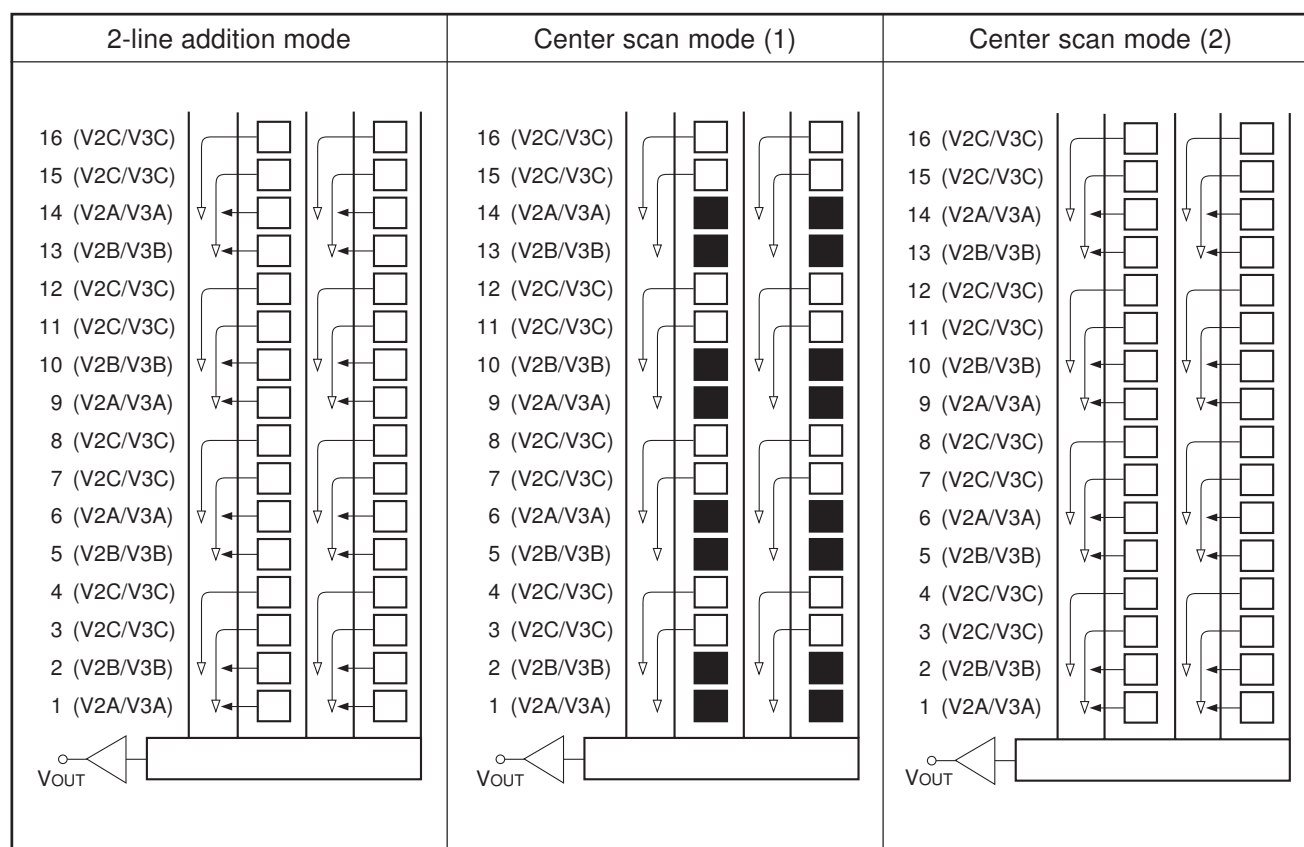
2. 2/8-line readout mode

All effective area signals are output in approximately 1/30s by reading out the signals for only two out of eight lines (1st and 6th lines, 9th and 14th lines).

This readout mode emphasizes processing speed over vertical resolution, making it suitable for AE/AF and other control and for checking images on LCD viewfinders.

3. 2/4-line readout mode

All effective area signals are output in approximately 1/20s by reading out the signals for only two out of four lines (3rd and 4th lines, 7th and 8th lines, and so on).



Note) Blacked out portions in the diagram indicate pixels which are not read out.

After reading out the pixels indicated by $\leftarrow$ and transferring two lines, the pixels indicated by $\leftarrow$ are read out and two pixels of the same color are added by the vertical transfer block.

4. 2-line addition mode

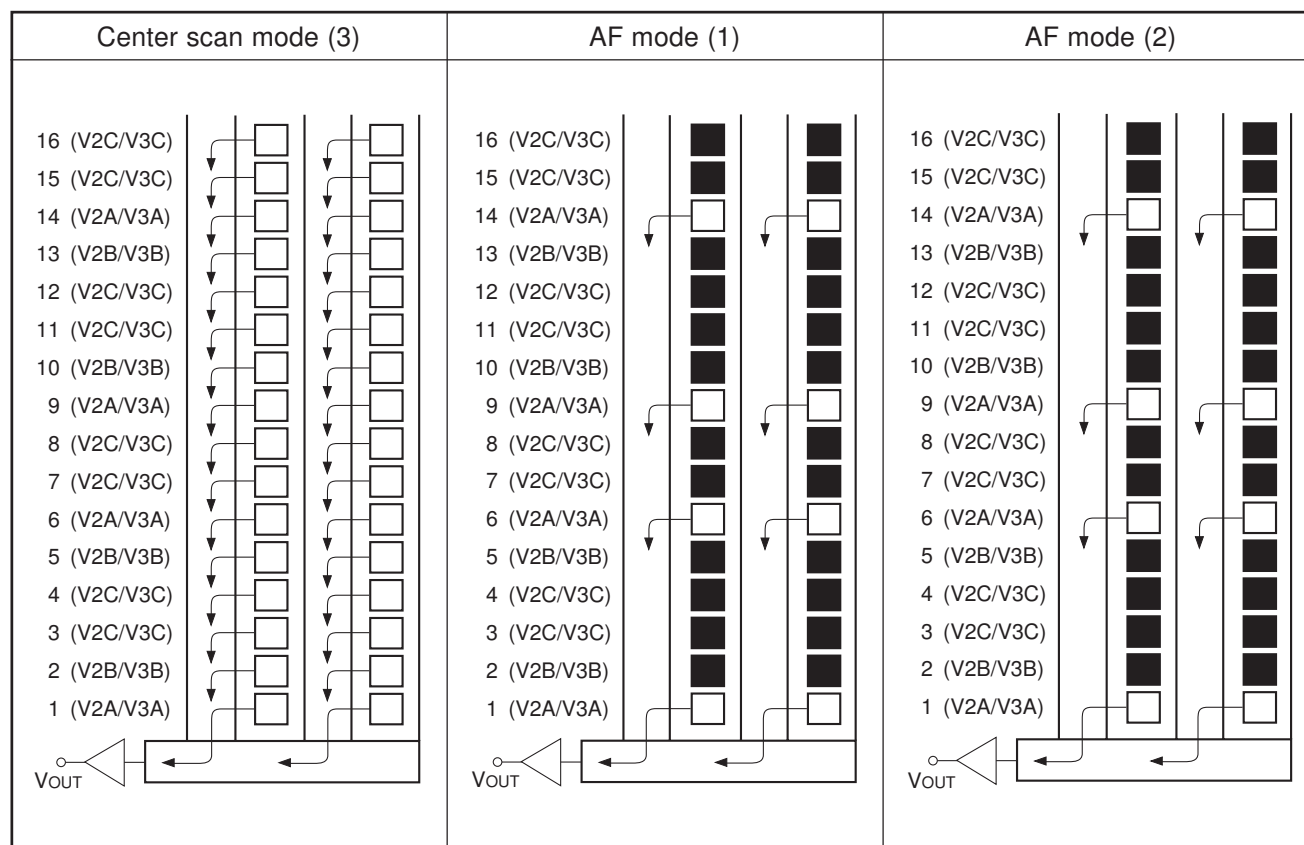
In this mode, the signals for only two out of four lines (3rd and 4th lines, 7th and 8th lines, and so on) are read out, the vertical register is shifted by 2 bits, and then the signals of the remaining two out of the four lines (1st and 2nd lines, 5th and 6th lines, and so on) are read out and added within the vertical register. All effective area signals are output in approximately 1/20s.

5. Center scan mode (1)

In this mode, the signals for only two out of four lines (3rd and 4th lines, 7th and 8th lines, and so on) are read out. The undesired portions are swept by vertical register high-speed transfer, and the vertical 1136-pixel region in the center of the picture is output by the above readout method. The number of output lines is 568 lines at 36MHz, and 434 lines at 28.6364MHz. The frame rate is increased (approximately 30 frames/s) by setting the number of output lines to that of VGA mode, making this mode suitable for VGA moving pictures. (However, the angle of view decreases.)

6. Center scan mode (2)

In this mode, the signals for only two out of four lines (3rd and 4th lines, 7th and 8th lines, and so on) are read out, the vertical register is shifted by 2 bits, and then the signals of the remaining two out of the four lines (1st and 2nd lines, 5th and 6th lines, and so on) are read out and added within the vertical register. The undesired portions are swept by vertical register high-speed transfer, and the vertical 1136-pixel region in the center of the picture is output by the above readout method. The number of output lines is 568 lines at 36MHz, and 434 lines at 28.6364MHz. The frame rate is increased (approximately 30 frames/s) by setting the number of output lines to that of VGA mode, making this mode suitable for VGA moving pictures. (However, the angle of view decreases.)



Note) Blacked out portions in the diagram indicate pixels which are not read out.

7. Center scan mode (3)

This is the center scan mode using the progressive scan method.

The undesired portions are swept by vertical register high-speed transfer, and the picture center is cut out. The number of output lines is 580 lines at 36MHz, and 444 lines at 28.6364MHz.

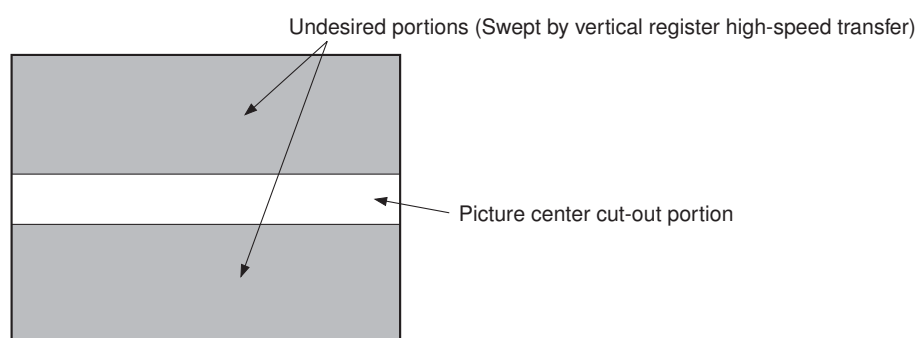
8. AF mode (1)

In this mode, the undesired portions are swept by vertical register high-speed transfer, and the vertical 940-pixel region in the center of the picture is output in approximately 1/60s by reading out the signals for only two out of eight lines (1st and 6th lines, 9th and 14th lines). The number of output lines is 235 lines at 36MHz, and 170 lines at 28.6364MHz. This mode aims for even faster AF control than 2/8-line readout mode.

9. AF mode (2)

In this mode, the undesired portions are swept by vertical register high-speed transfer, and the vertical 300-pixel region in the center of the picture is output in approximately 1/120s by reading out the signals for only two out of eight lines (1st and 6th lines, 9th and 14th lines). The number of output lines is 75 lines at 36MHz, and 43 lines at 28.6364MHz. This mode aims for even faster AF control than 2/8-line readout mode.

◎ Center scan and AF modes



Description of Center Scan and AF Mode Operation

The center scan and AF modes realize high frame rates by sweeping the top and bottom of the picture with high-speed transfer and cutting out the center of the picture.

The various readout modes during center scan and AF operation are described below.

- AF modes

AF mode (1), (2): The output method is the same as readout in 2/8-line readout mode.

- Center scan modes

Center scan mode (1): The output method is the same as 2/4-line readout mode.

Center scan mode (2): The output method consists of 2-line addition readout whereby the signals for only two out of four lines (3rd and 4th lines, 7th and 8th lines, and so on) are read out, the vertical register is shifted by 2 bits, and then the signals of the remaining two out of the four lines (1st and 2nd lines, 5th and 6th lines, and so on) are read out and added within the vertical register.

Center scan mode (3): The output method is the same as progressive scan mode.

The readout method, frame rate, number of output lines and other information for each readout mode are shown in the table below.

Mode	Readout method	Addition method	Frame rate (frame/s)		Number of output effective pixel data lines	
			28.6MHz	36MHz	28.6MHz	36MHz
Progressive scan mode	Progressive scan	None	9.99	14.985	1220	1220
2/8-line readout mode	2/8-line readout	None	29.97	29.97	305	305
2/4-line readout mode	2/4-line readout	None	19.98	19.98	610	610
2-line addition mode	2/4-line readout	Vertical 2-line	19.98	19.98	1220	1220
Center scan mode (1)	2/4-line readout	None	29.97	29.97	434	568
Center scan mode (2)	2-line addition readout	Vertical 2-line	29.97	29.97	434	568
Center scan mode (3)	Progressive scan	None	29.97	29.97	444	580
AF mode (1)	2/8-line readout	None	59.94	59.94	170	235
AF mode (2)	2/8-line readout	None	119.88	119.88	43	75

◎ Measurement conditions

- (1) In the following measurements, the device drive conditions are at the typical values of the bias and clock voltage conditions, and the progressive scan readout mode is used.
- (2) In the following measurements, spot blemishes are excluded and, unless otherwise specified, the optical black level (OB) is used as the reference for the signal output, which is taken as the value measured at point [*B] of the measurement system.

◎ Definition of standard imaging conditions

- (1) Standard imaging condition I:
Use a pattern box (luminance: 706cd/m², color temperature of 3200K halogen source) as a subject. (Pattern for evaluation is not applicable.) Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter and image at F8. The luminous intensity to the sensor receiving surface at this point is defined as the standard sensitivity testing luminous intensity.
- (2) Standard imaging condition II:
Image a light source (color temperature of 3200K) with a uniformity of brightness within 2% at all angles. Use a testing standard lens with CM500S (t = 1.0mm) as an IR cut filter. The luminous intensity is adjusted to the value indicated in each testing item by the lens diaphragm.

1. Sensitivity

Set to the standard imaging condition I. After selecting the electronic shutter mode with a shutter speed of 1/100s, measure the signal output (V_s) at the center of the screen, and substitute the values into the following formulas.

$$S = V_s \times \frac{100}{30} \text{ [mV]}$$

2. Saturation signal

Set to the standard imaging condition II. After adjusting the luminous intensity to 10 times the intensity with the average value of the G channel signal output, 150mV, measure the minimum values of the signal outputs.

3. Smear

Set to standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjust the luminous intensity to 500 times the intensity with the average value of the signal output, 150mV. After the readout clock is stopped and the charge drain is executed by the electronic shutter at the respective H blankings, measure the maximum value (V_{sm} [mV]) of the signal outputs, and substitute the values into the following formula. Smear in modes other than progressive scan mode is calculated from the storage time and signal addition method. As a result, 2-line addition mode and center scan modes (2) and (3) are the same as progressive scan mode, 2/4-line readout mode and center scan mode (1) are two times progressive scan mode, and 2/8-line readout mode and AF modes (1) and (2) are four times progressive scan mode.

$$Sm = 20 \times \log \left(\frac{V_{sm}}{200} \times \frac{1}{500} \times \frac{1}{10} \right) [\text{dB}] \text{ (1/10 V method conversion value)}$$

4. Video signal shading

Set to the standard imaging condition II. With the lens diaphragm at F5.6 to F8, adjusting the luminous intensity so that the average value of the signal output is 150mV. Then measure the maximum value ($V_{\max}$ [mV]) and minimum value ($V_{\min}$ [mV]) of the G signal output and substitute the values into the following formula.

$$SH = (V_{\max} - V_{\min}) / 150 \times 100 [\%]$$

5. Dark signal

Measure the average value of the signal output (V_{dt} [mV]) with the device ambient temperature of 60°C and the device in the light-obstructed state, using the horizontal idle transfer level as a reference.

6. Dark signal shading

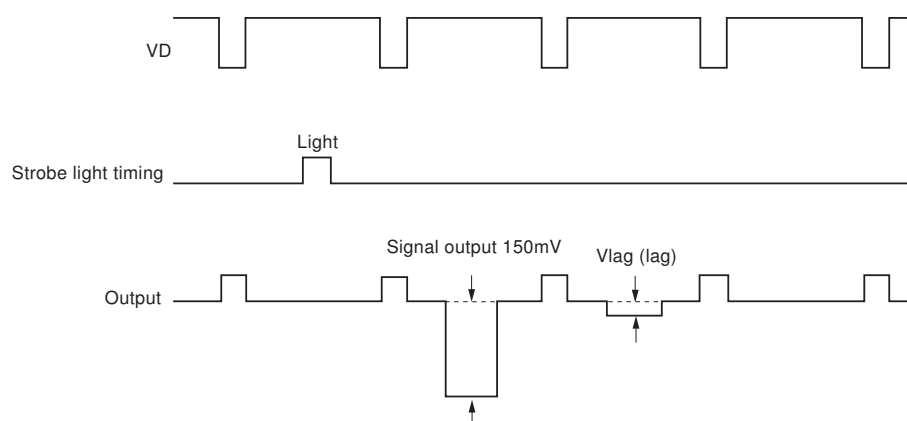
After measuring 5, measure the maximum ($V_{d\max}$ [mV]) and minimum ($V_{d\min}$ [mV]) values of the dark signal output and substitute the values into the following formula.

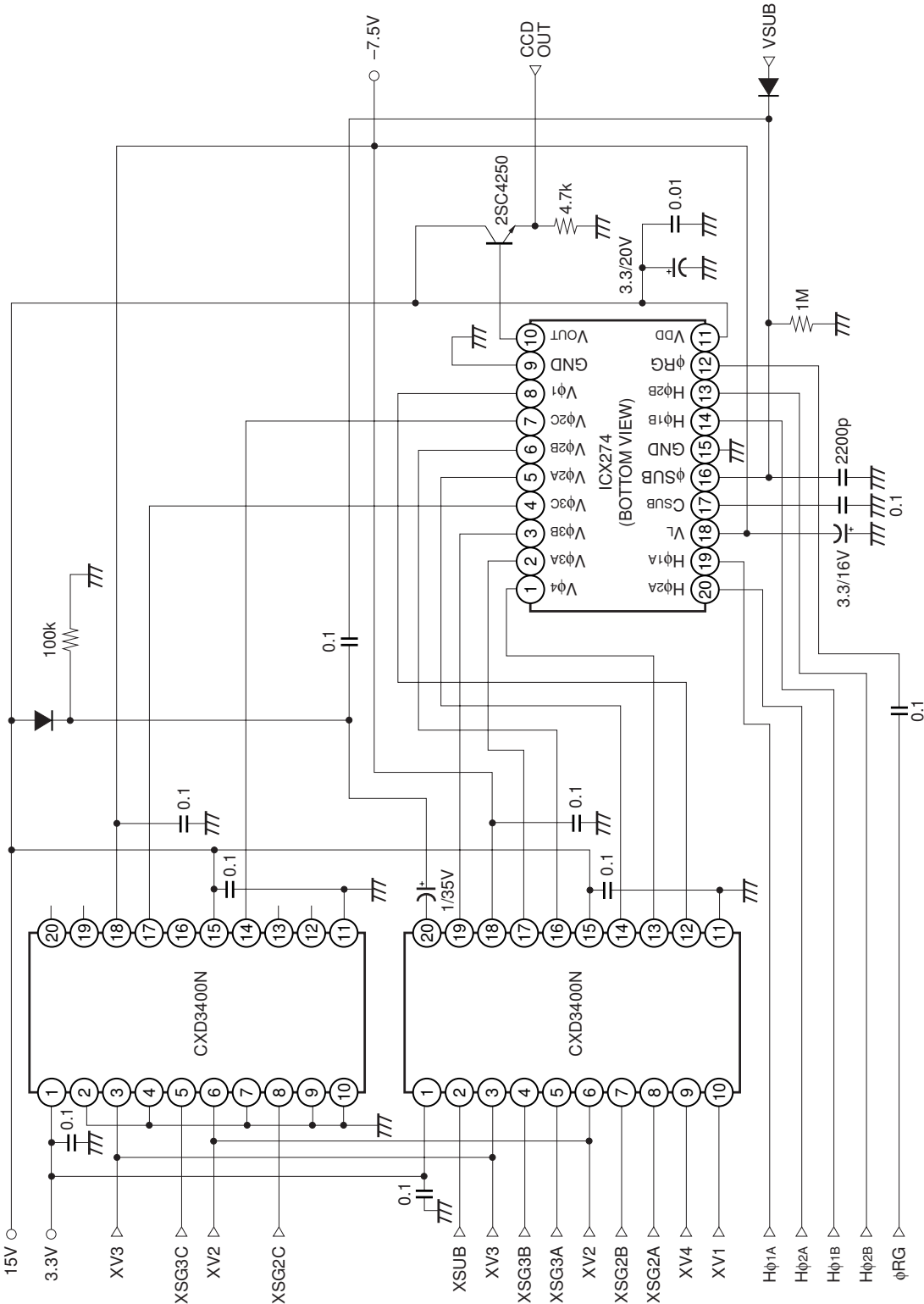
$$\Delta V_{dt} = V_{d\max} - V_{d\min} [\text{mV}]$$

7. Lag

Adjust the signal output generated by the strobe light to 150mV. After setting the strobe light so that it strobes with the following timing, measure the residual signal amount (V_{lag}). Substitute the value into the following formula.

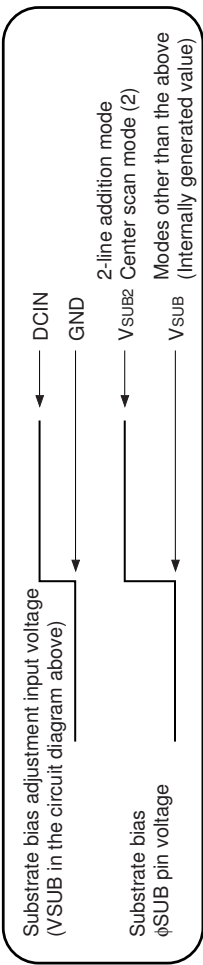
$$Lag = (V_{lag} / 150) \times 100 [\%]$$



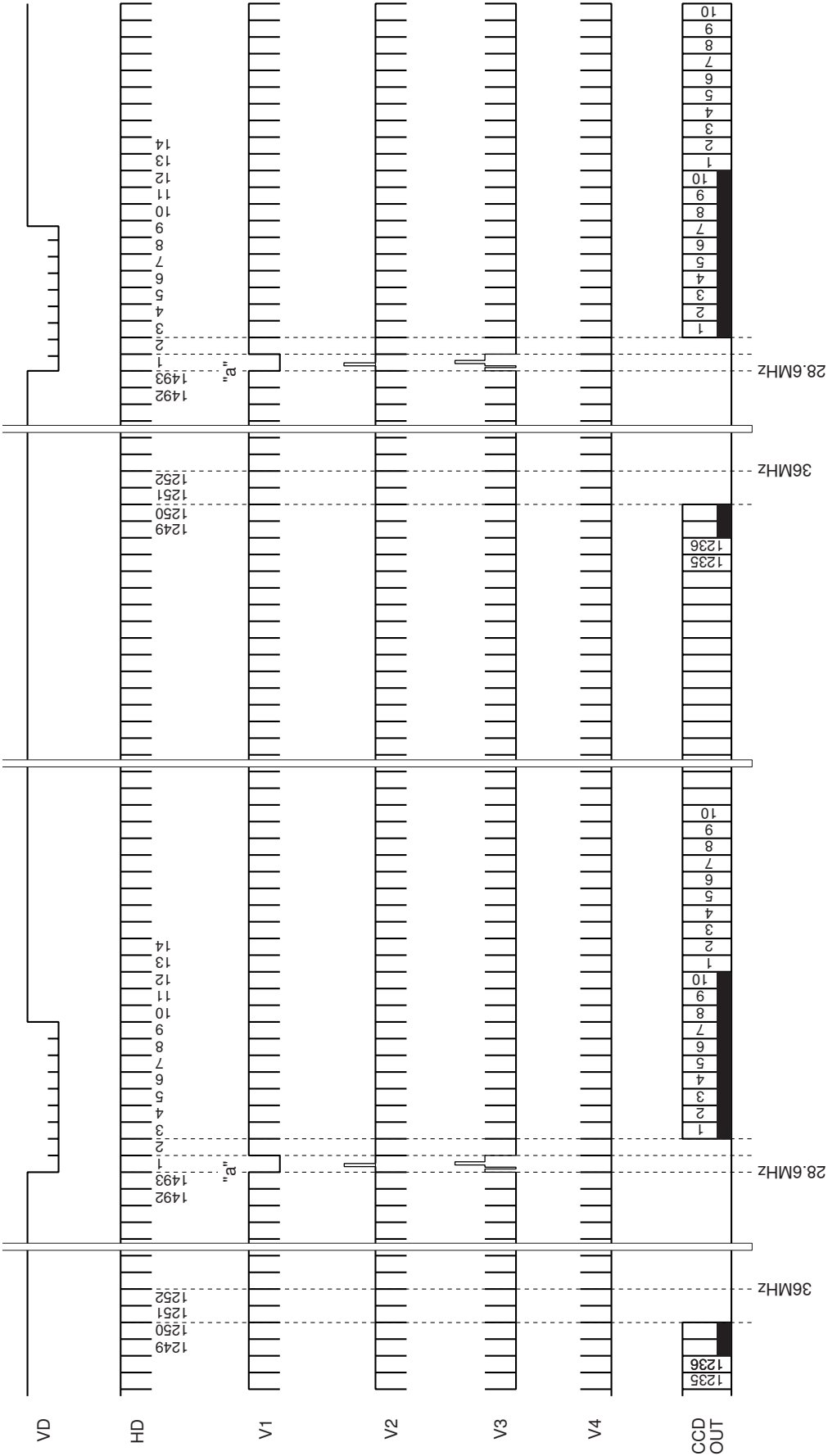


Note) Substrate bias control

Switch the substrate bias adjustment input voltage to DCIN before adjusting the substrate bias in 2-line addition mode and center scan mode (2).

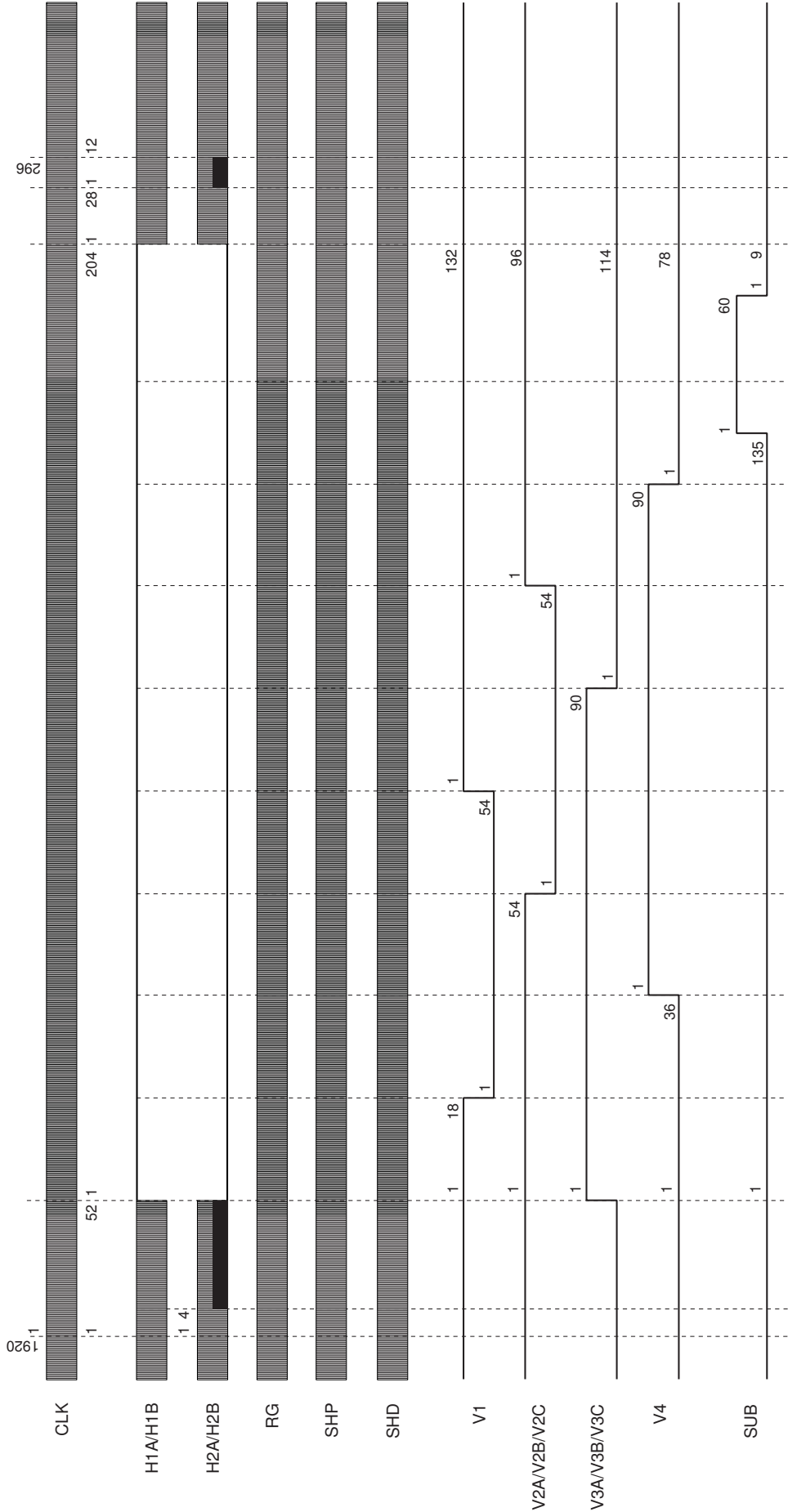


Drive Timing Chart (Vertical Sync) Progressive Scan Mode



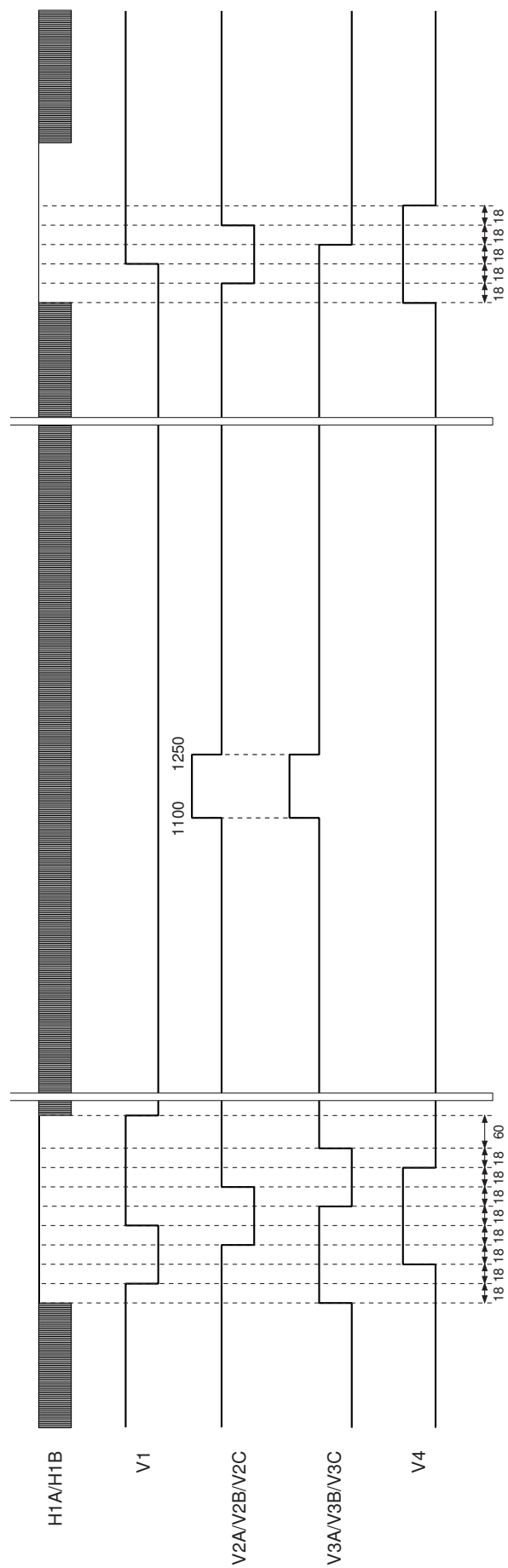
Note) The 1252H horizontal period at 36MHz is 480clk; the 1493H horizontal period at 28MHz is 1860clk.

Drive Timing Chart (Horizontal Sync) Progressive Scan Mode

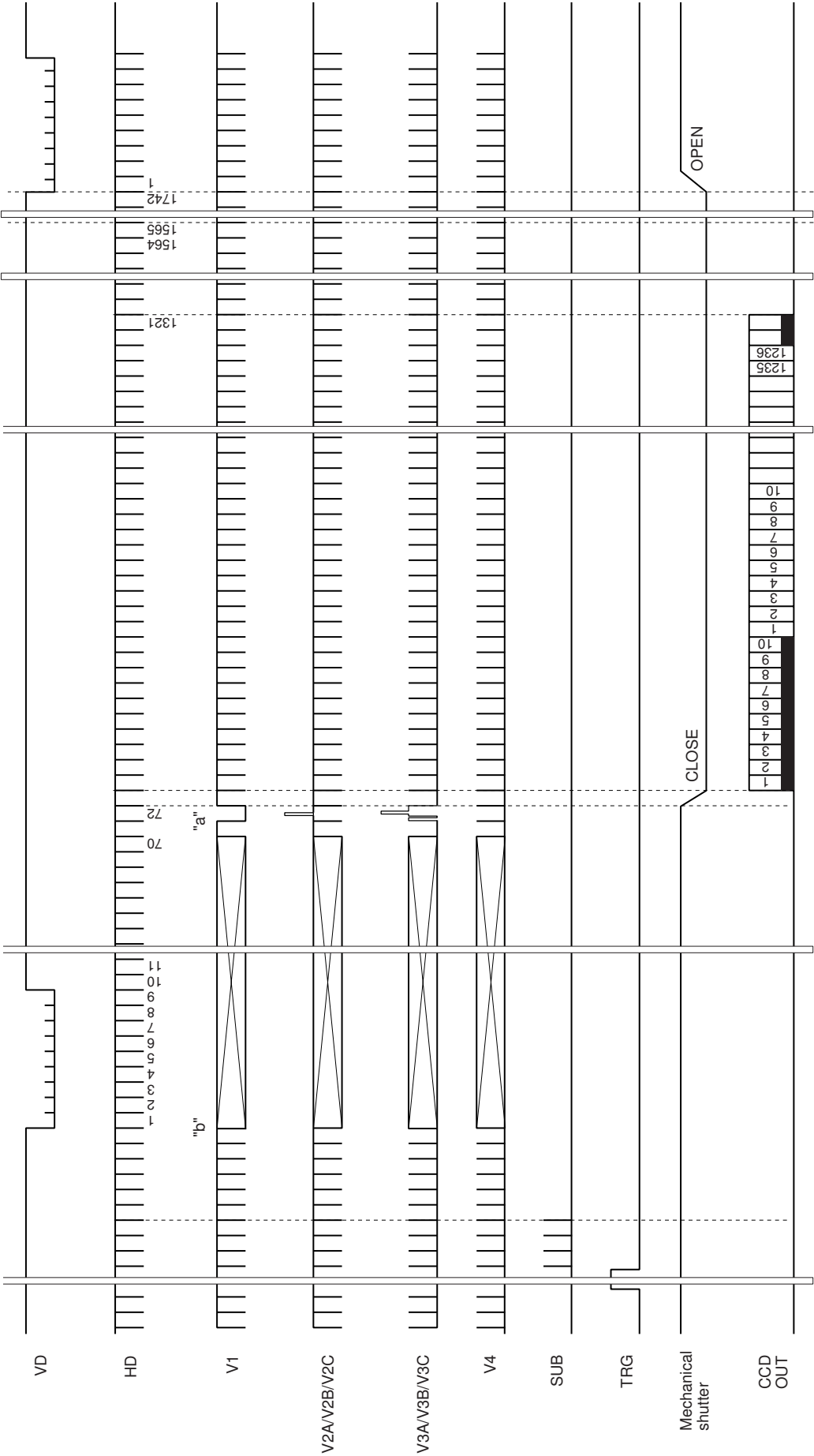


Drive Timing Chart (Vertical Sync)

"a" enlarged



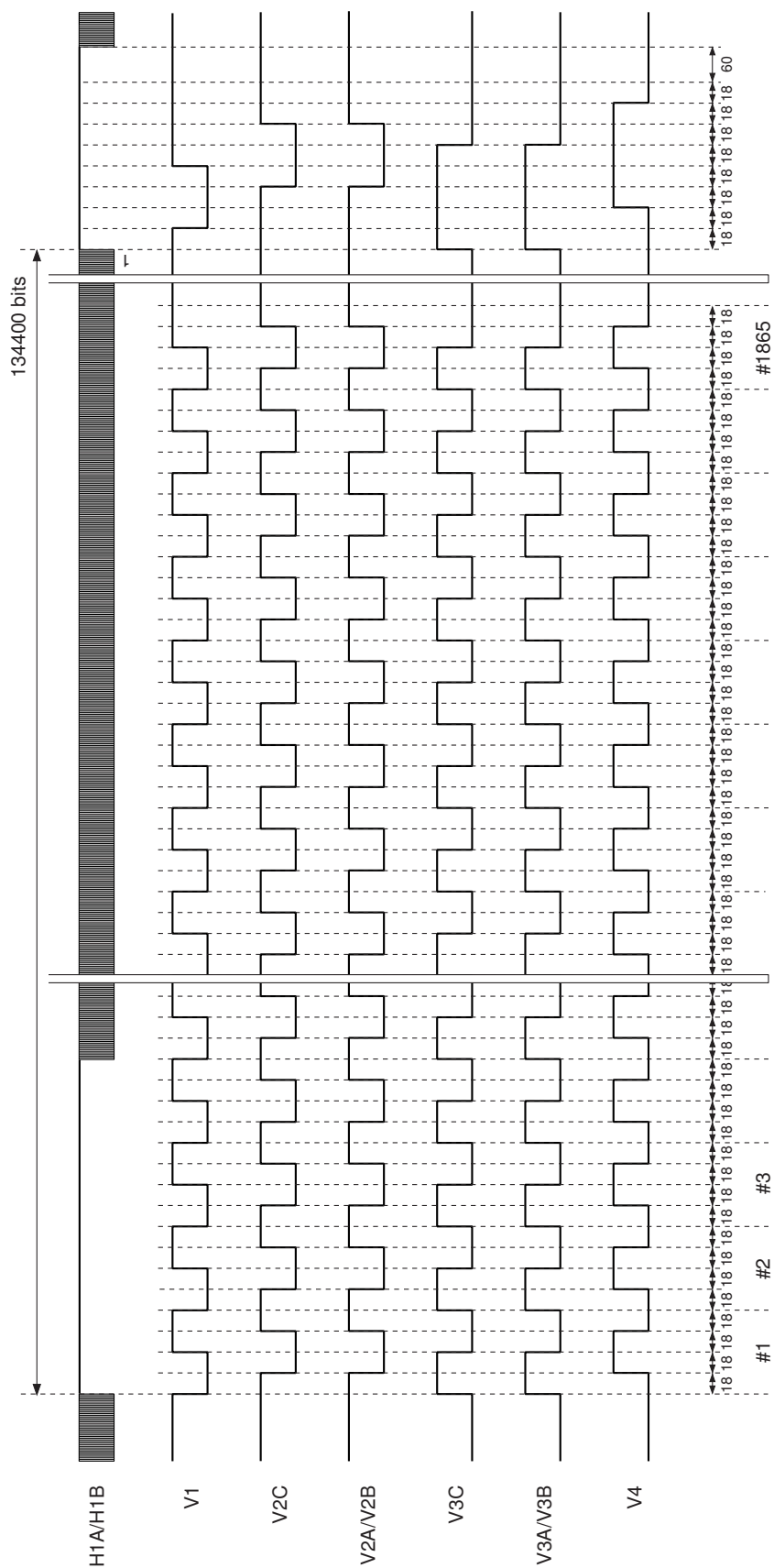
Drive Timing Chart (Vertical Sync) Progressive Scan Mode (With Mechanical Shutter)



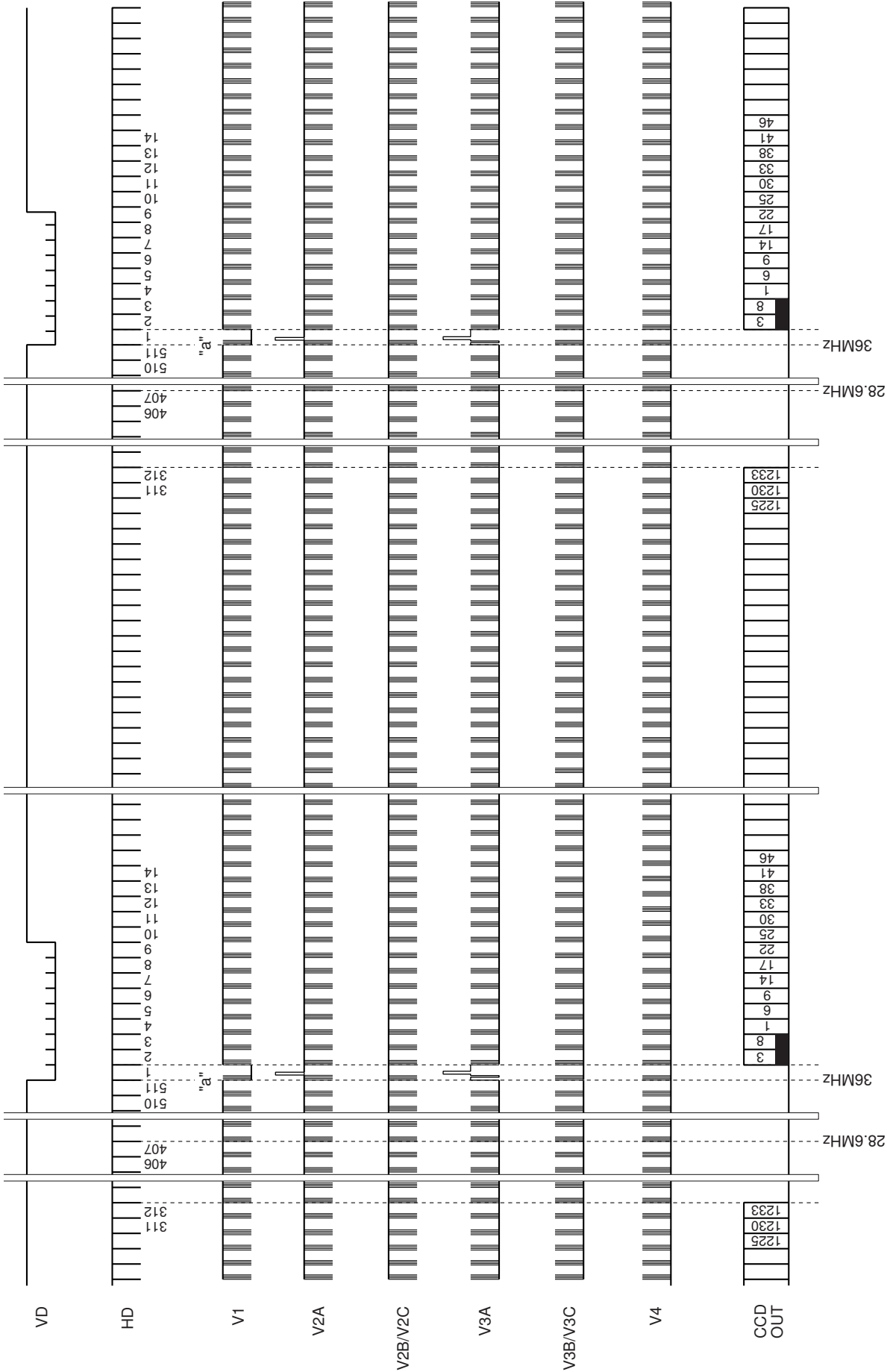
Progressive Scan Mode (With Mechanical Shutter)

Drive Timing Chart (Vertical Sync)

"b" enlarged

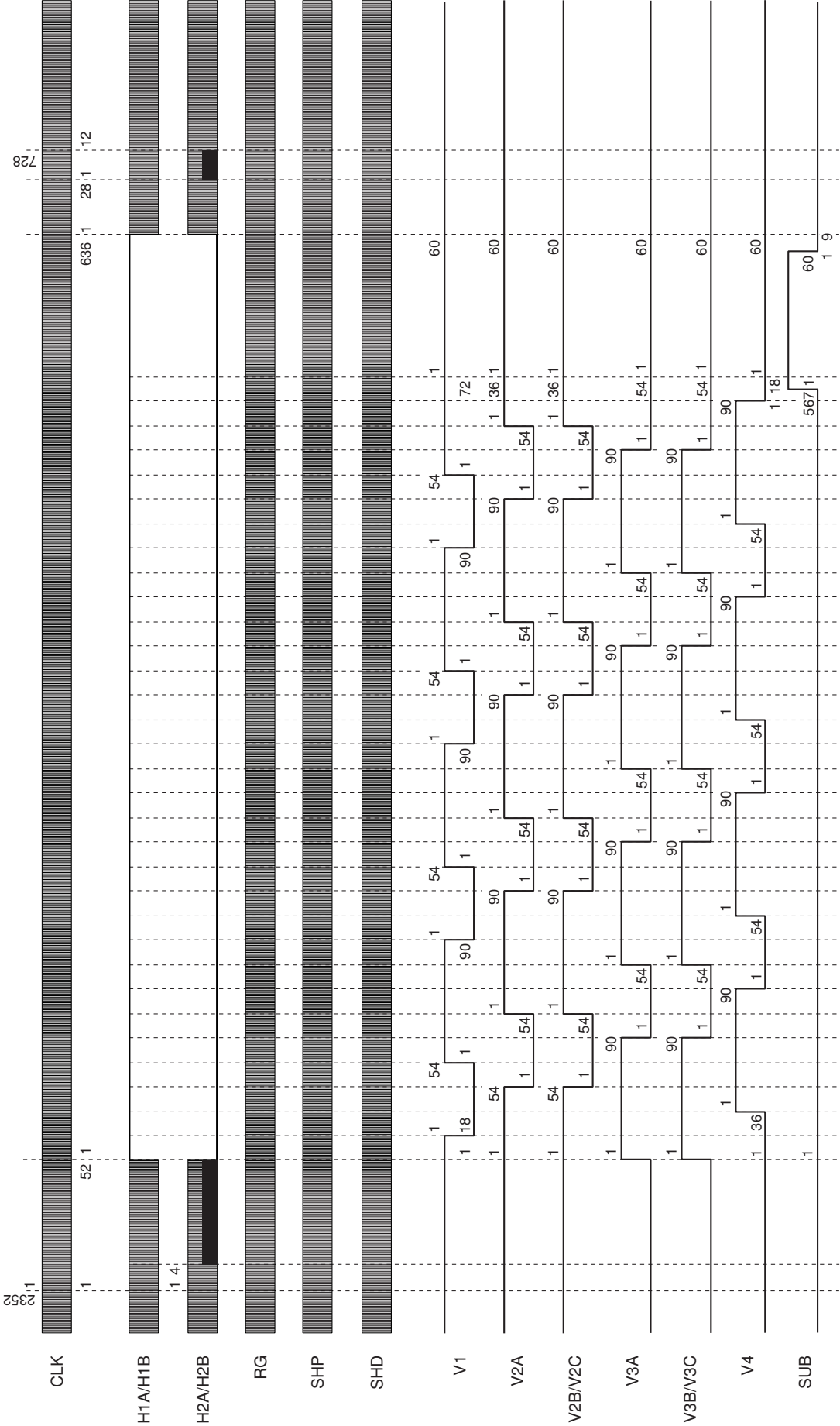


Drive Timing Chart (Vertical Sync) 2/8-line Readout Mode



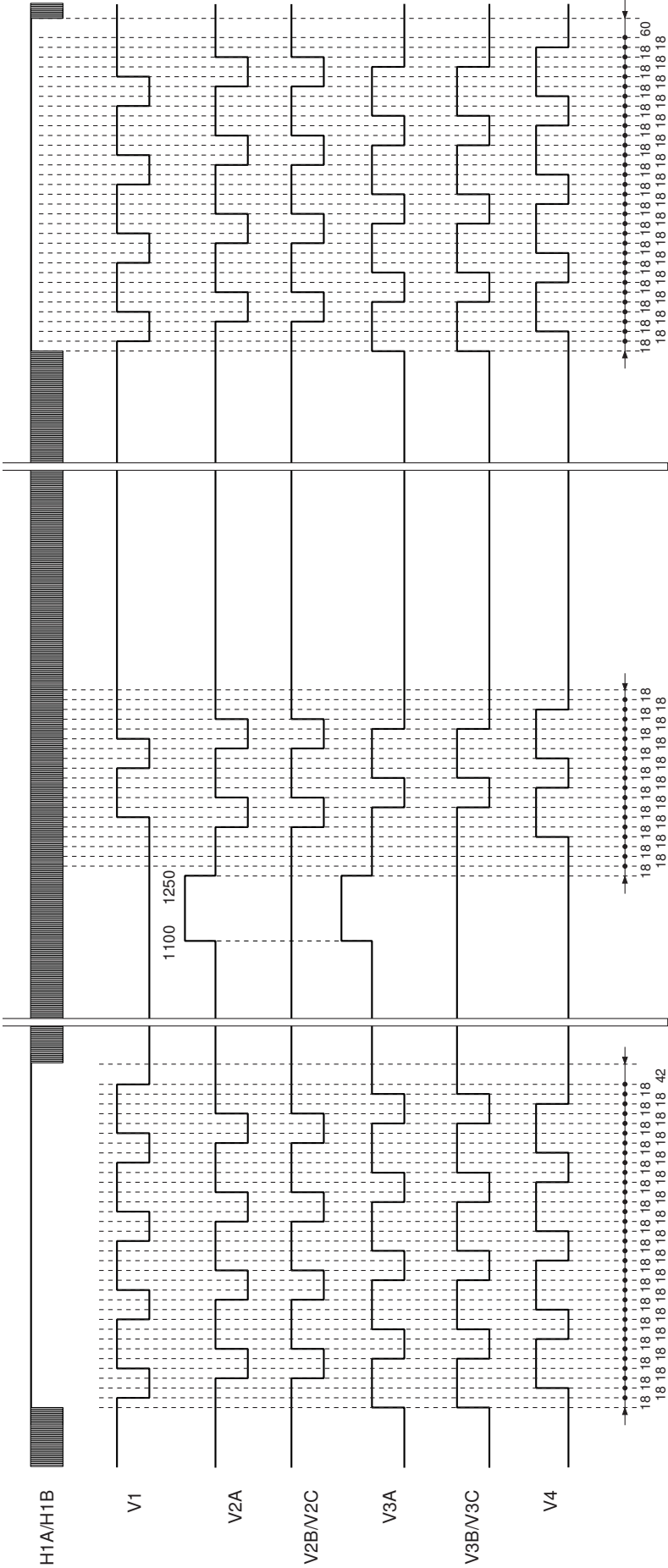
Note) The 511H horizontal period at 36MHz is 1680clk; the 406 and 407H horizontal periods at 28MHz are 1470clk.

Drive Timing Chart (Horizontal Sync) 2/8-line Readout Mode

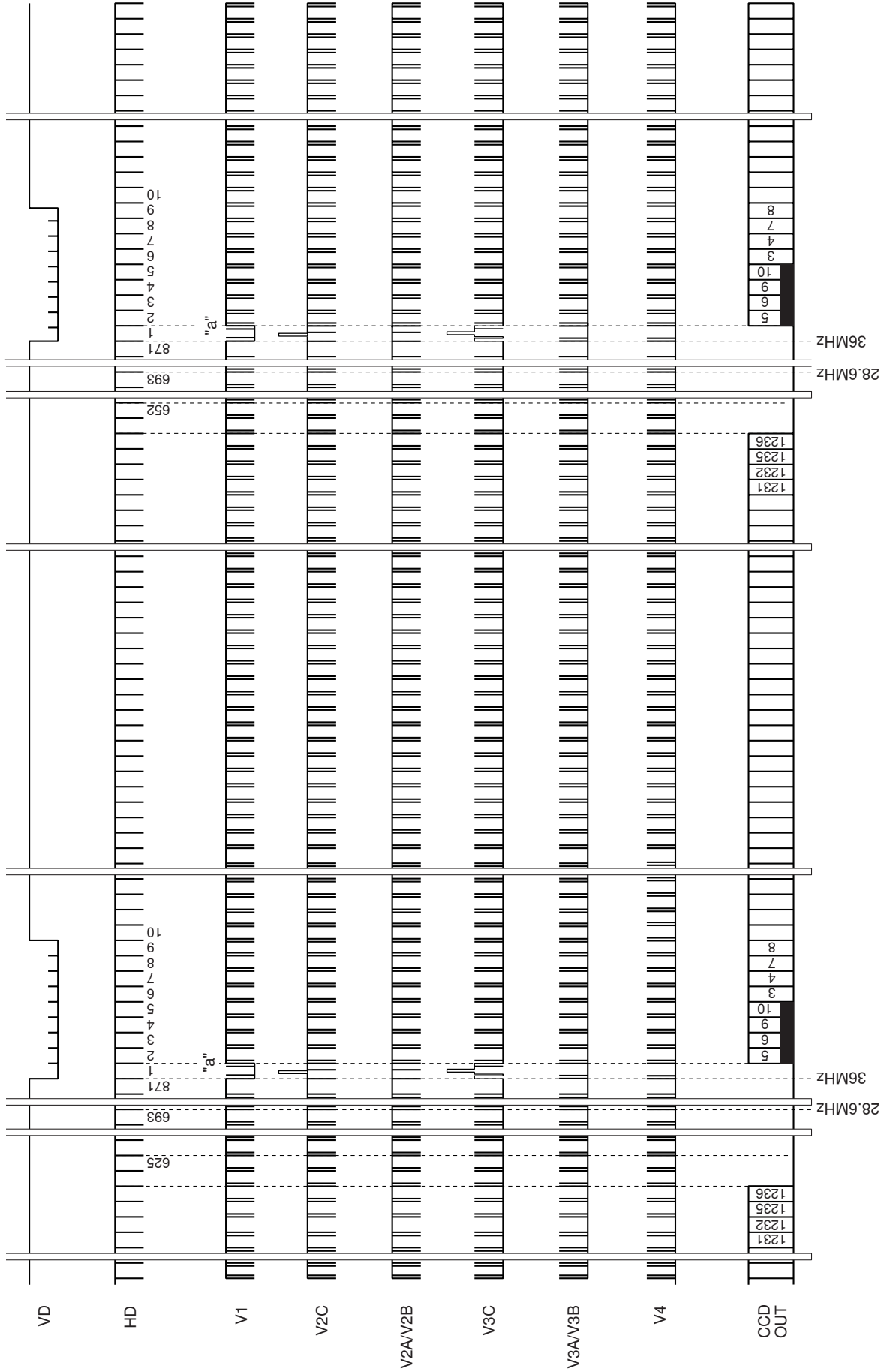


Drive Timing Chart (Vertical Sync) 2/8-line Readout Mode

"a" enlarged

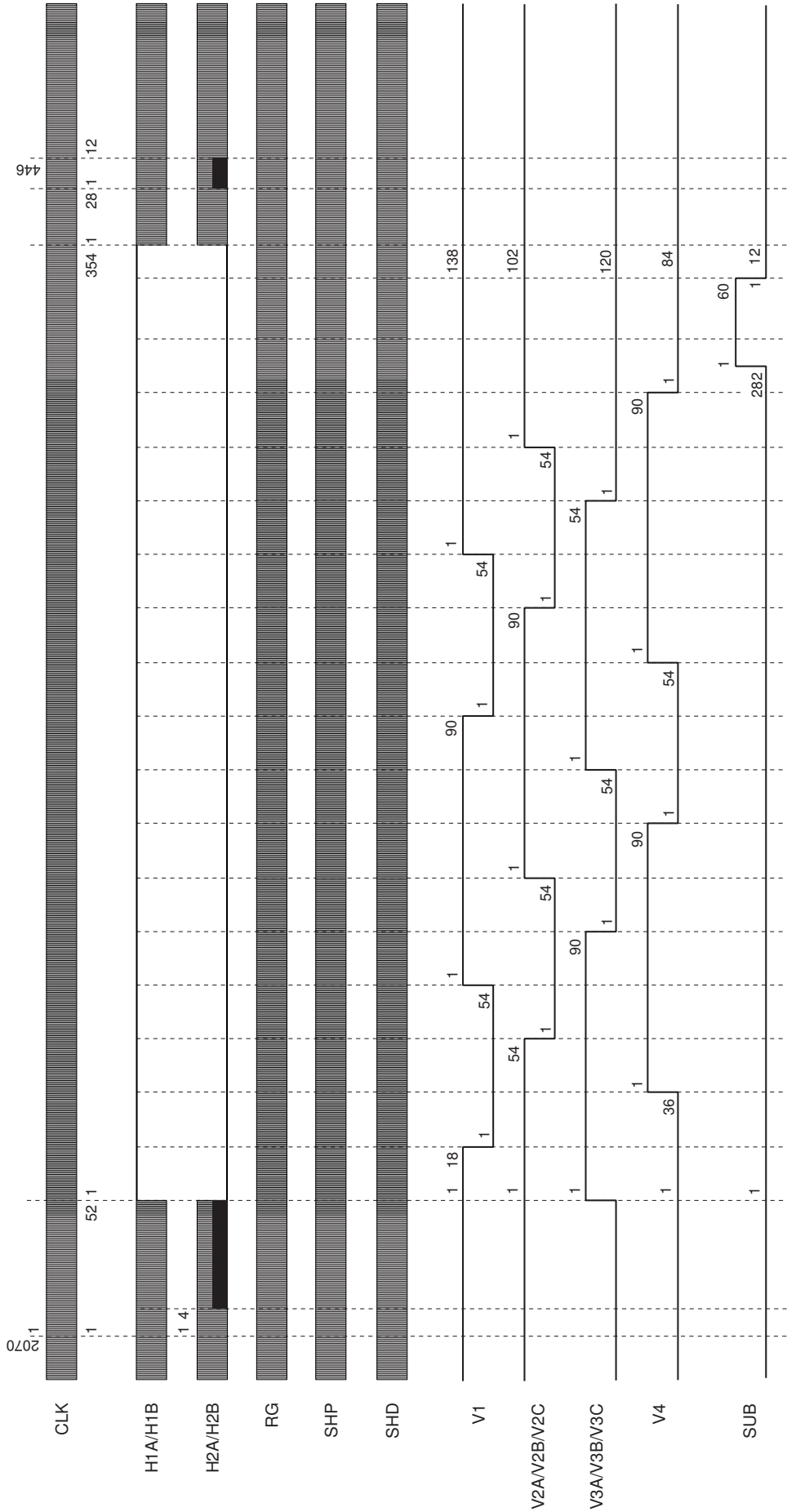


Drive Timing Chart (Vertical Sync) 2/4-line Readout Mode



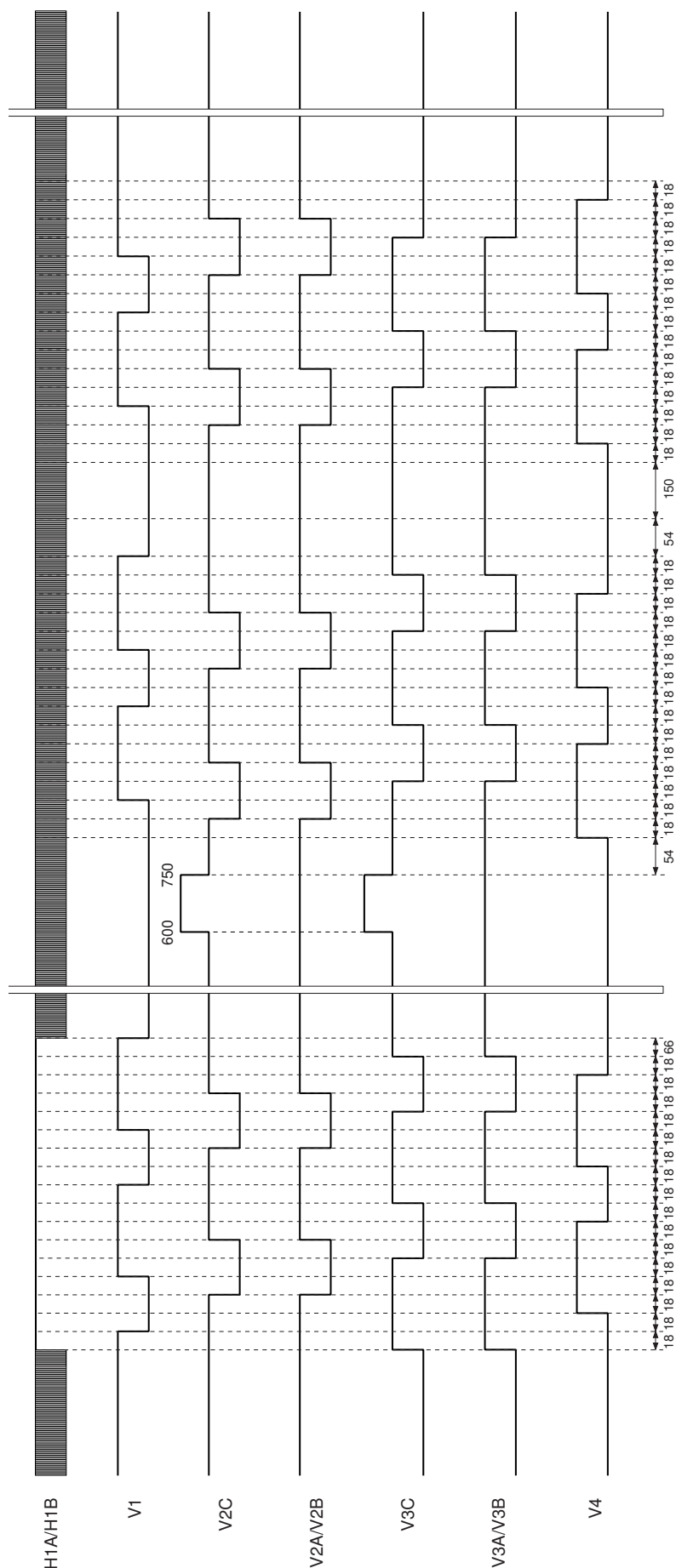
Note) The 871H horizontal period at 36MHz is 900clk; the 693H horizontal period at 28MHz is 810clk.

Drive Timing Chart (Horizontal Sync) 2/4-line Readout Mode

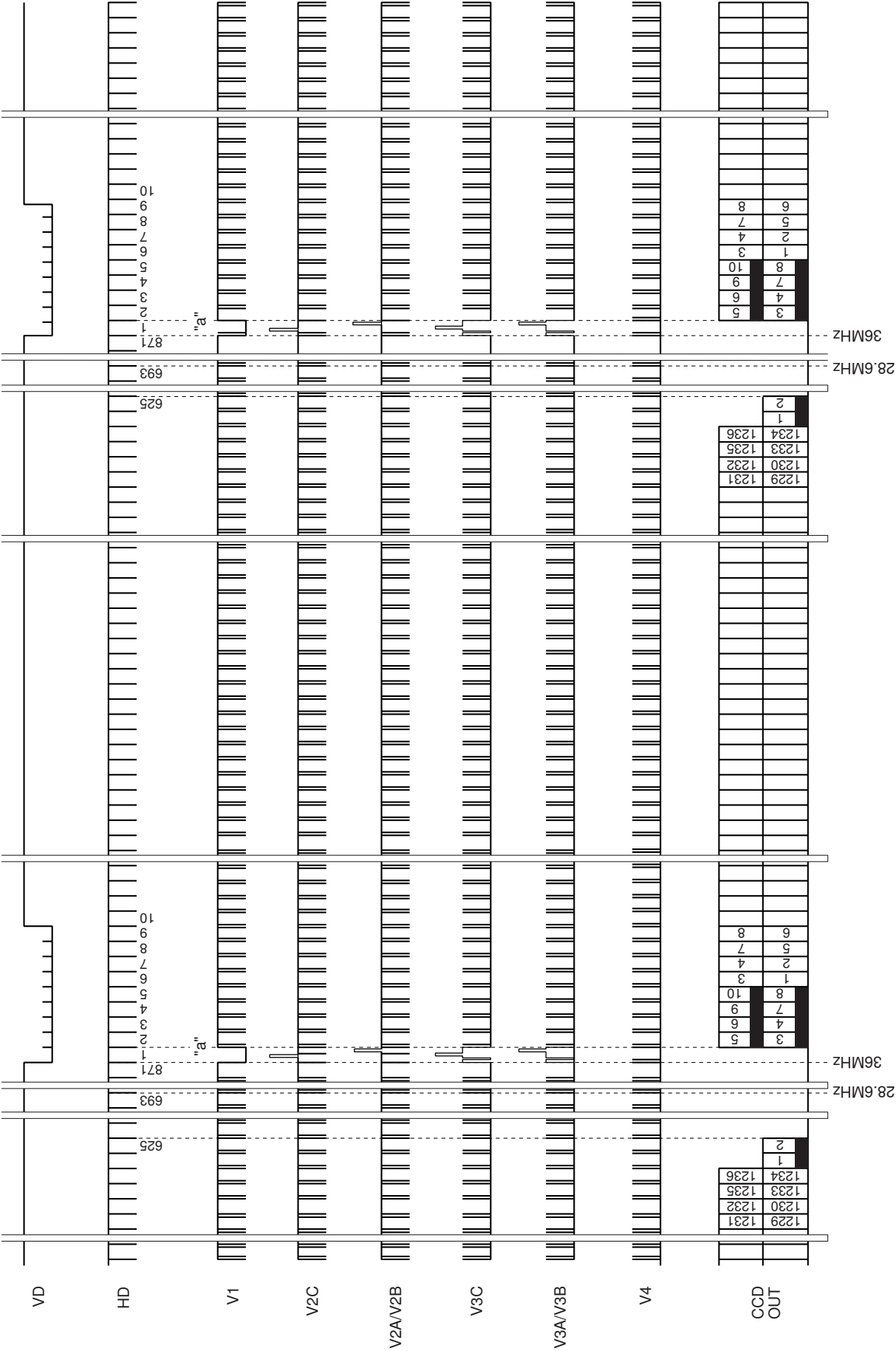


Drive Timing Chart (Vertical Sync)

"a" enlarged

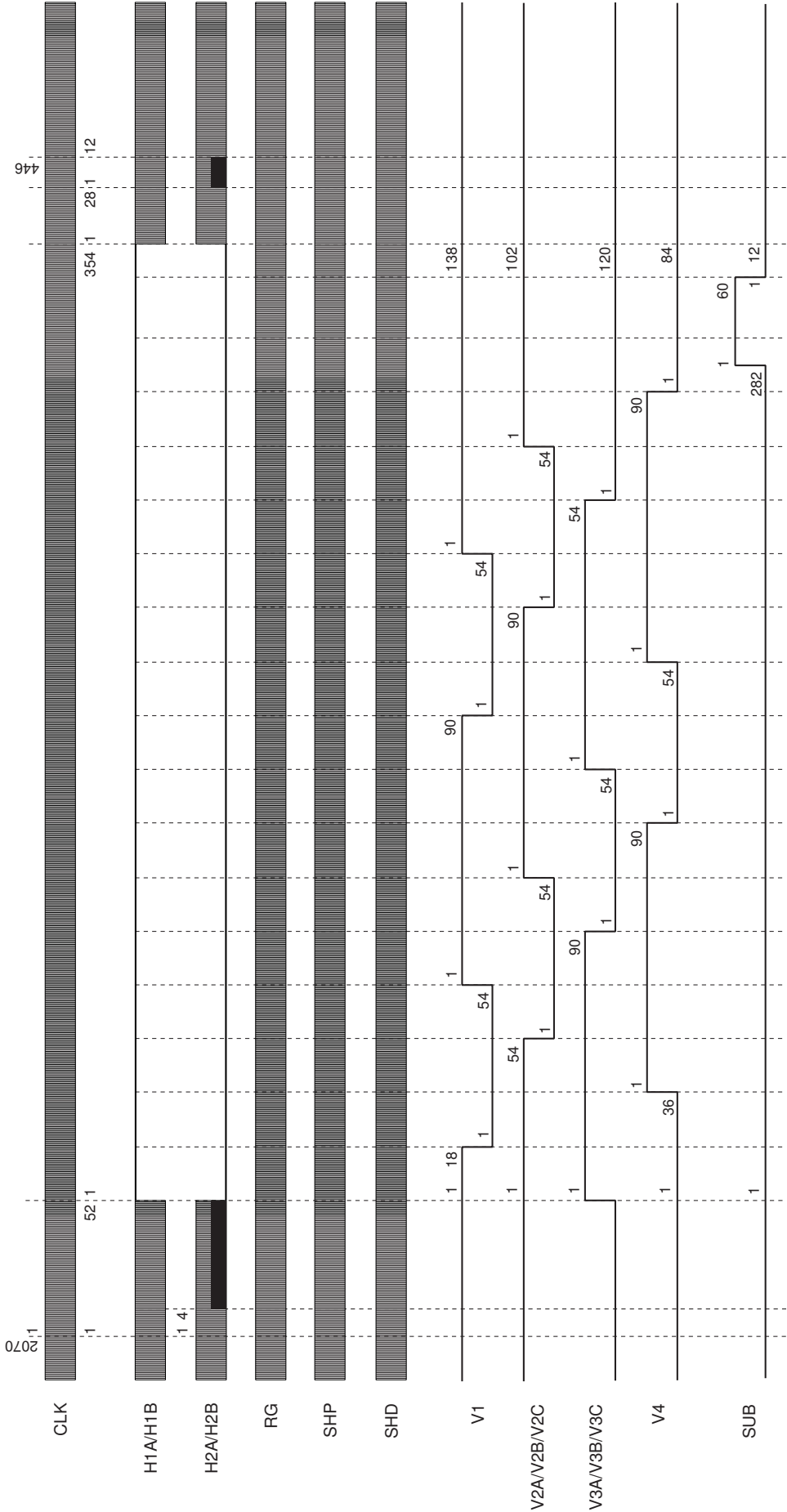


Drive Timing Chart (Vertical Sync) 2-line Addition Mode



Note) The 871H horizontal period at 36MHz is 900clk; the 693H horizontal period at 28MHz is 810clk.

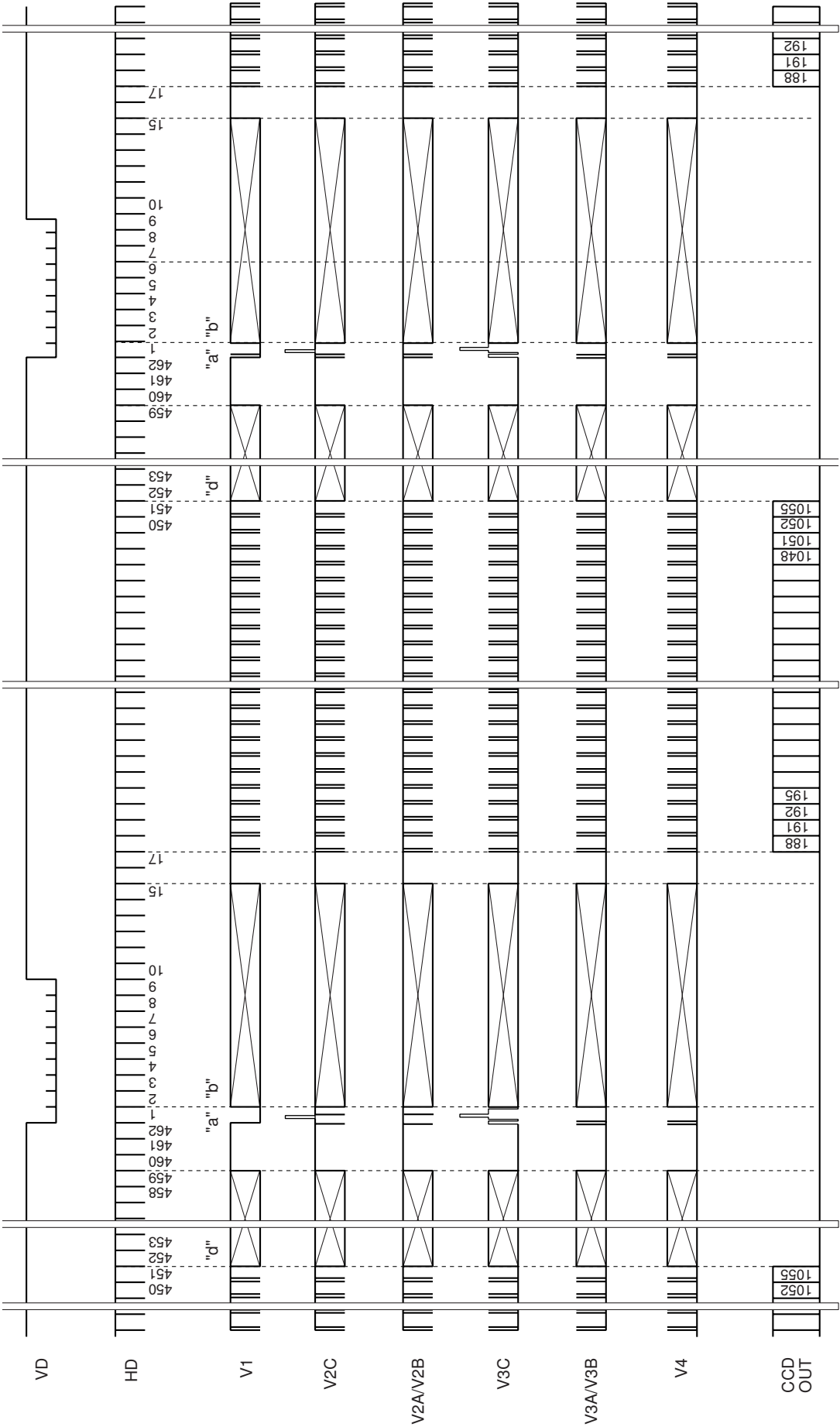
Drive Timing Chart (Horizontal Sync) 2-line Addition Mode



"a" enlarged

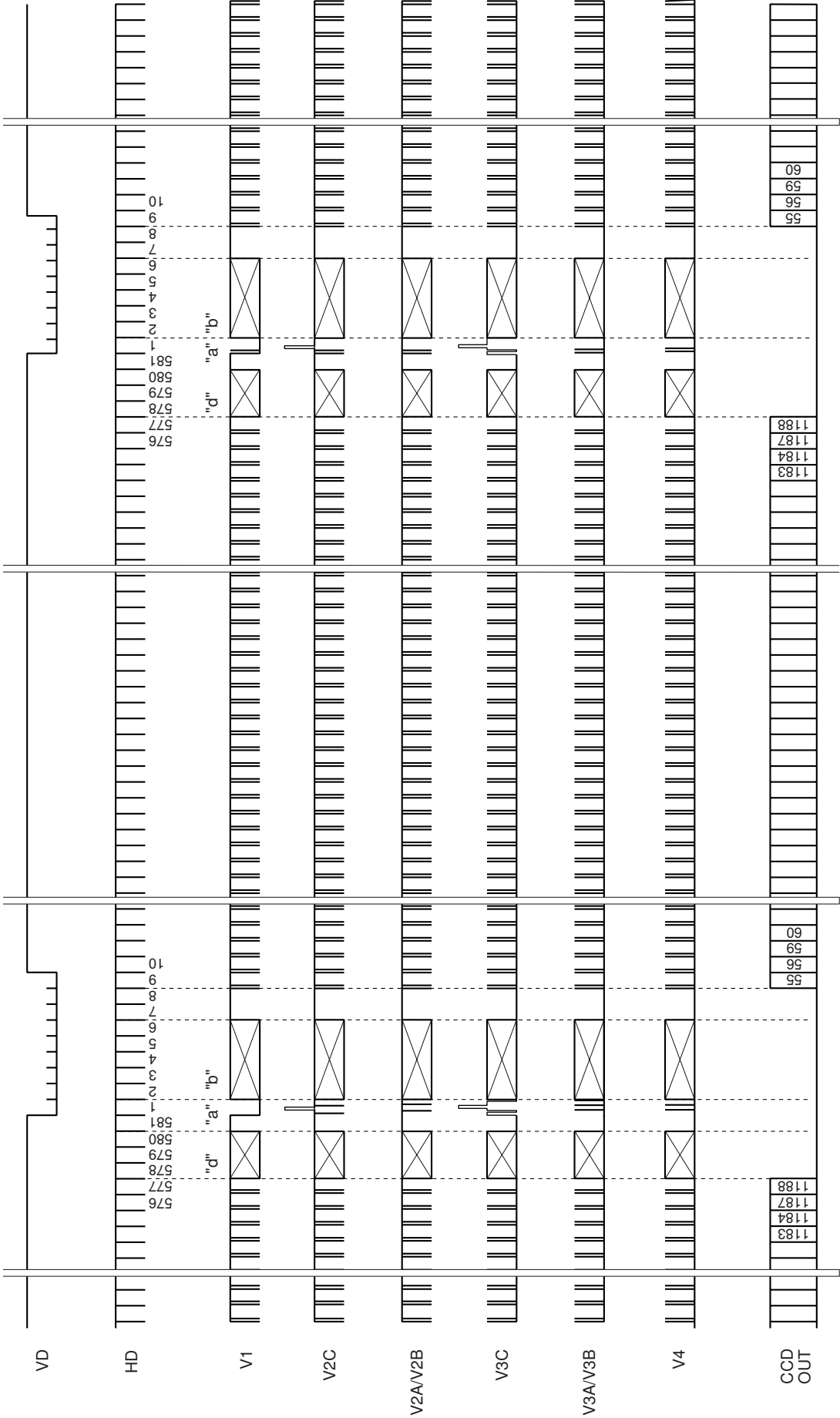


Drive Timing Chart (Vertical Sync) Center Scan Mode (1)/(28.6MHz)



Note) The 462H horizontal period is 1230clk.

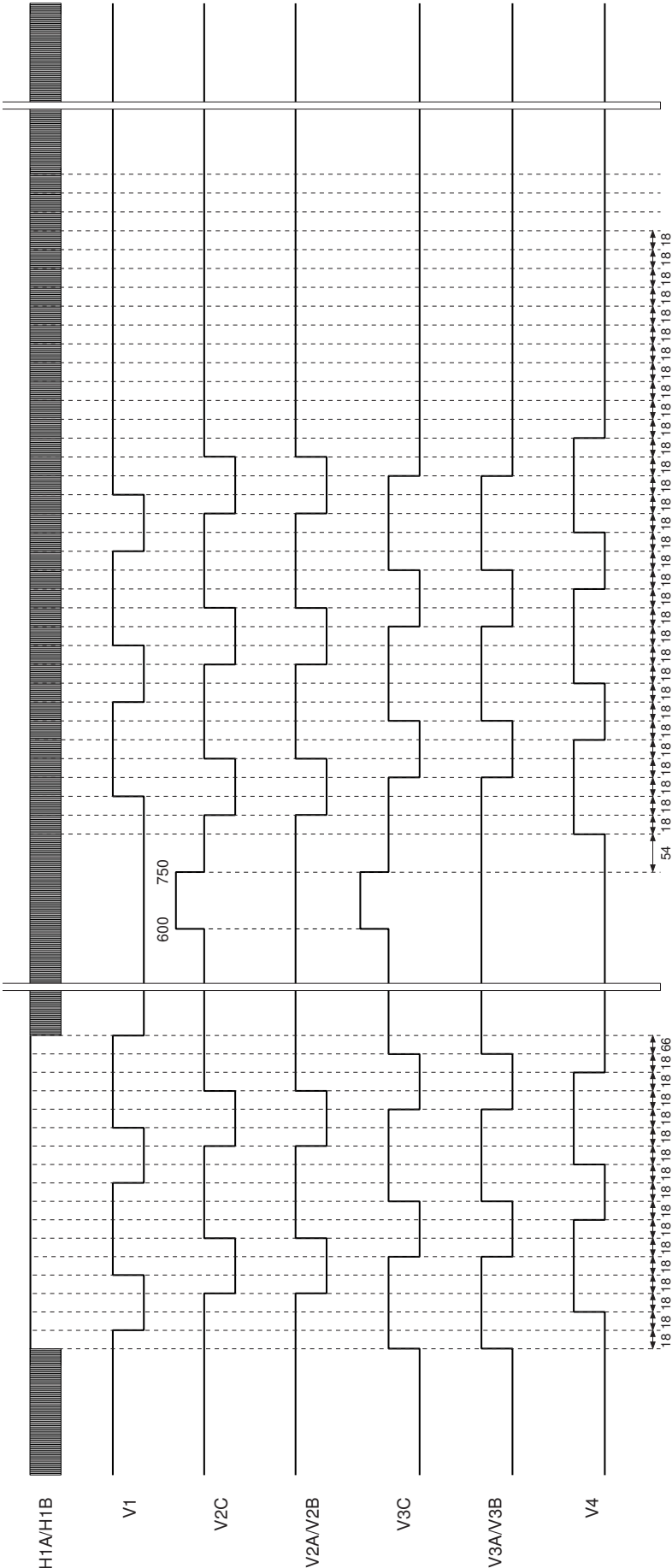
Drive Timing Chart (Vertical Sync) Center Scan Mode (1)/(36MHz)



Note) The 581H horizontal period is 601clk.

Drive Timing Chart (Vertical Sync) Center Scan Mode (1)

"a" enlarged



Drive Timing Chart (Vertical Sync)

28980 bits = 14H

27936 bits

V1

V2C

V2A/V2B

V3C

V3A/V3B

 V_4

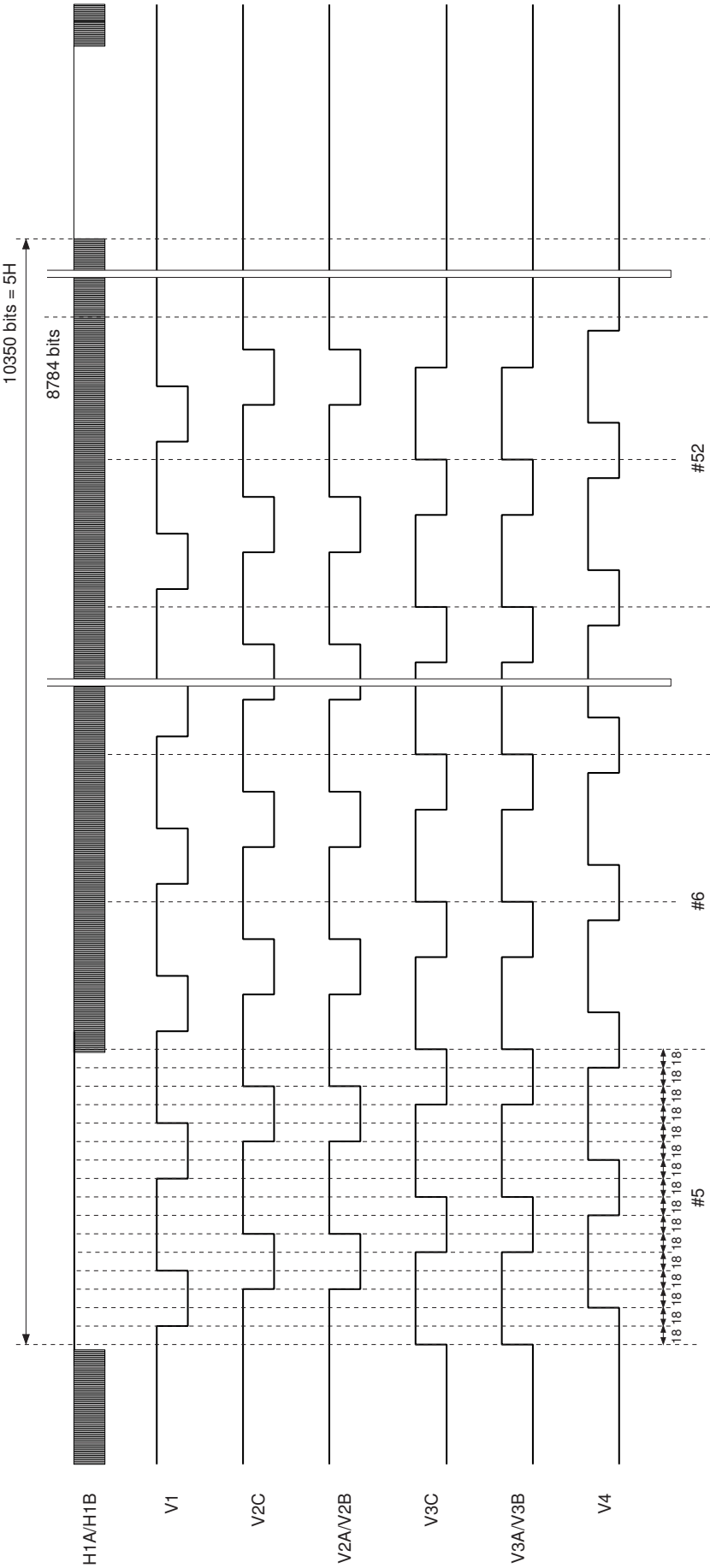
#187

#9

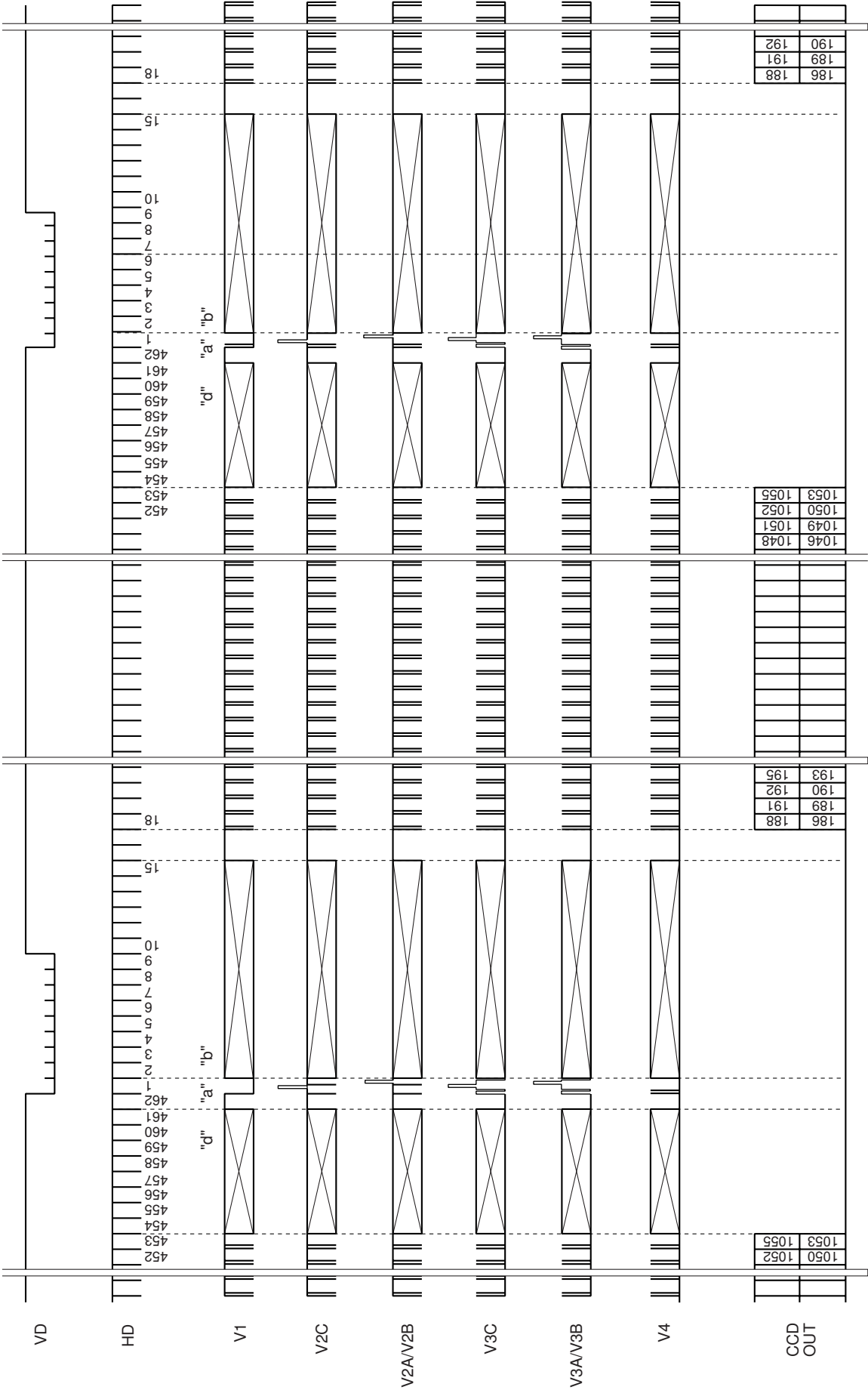
#5

Drive Timing Chart (Vertical Sync) Center Scan Mode (1)/(36MHz)

"b" enlarged

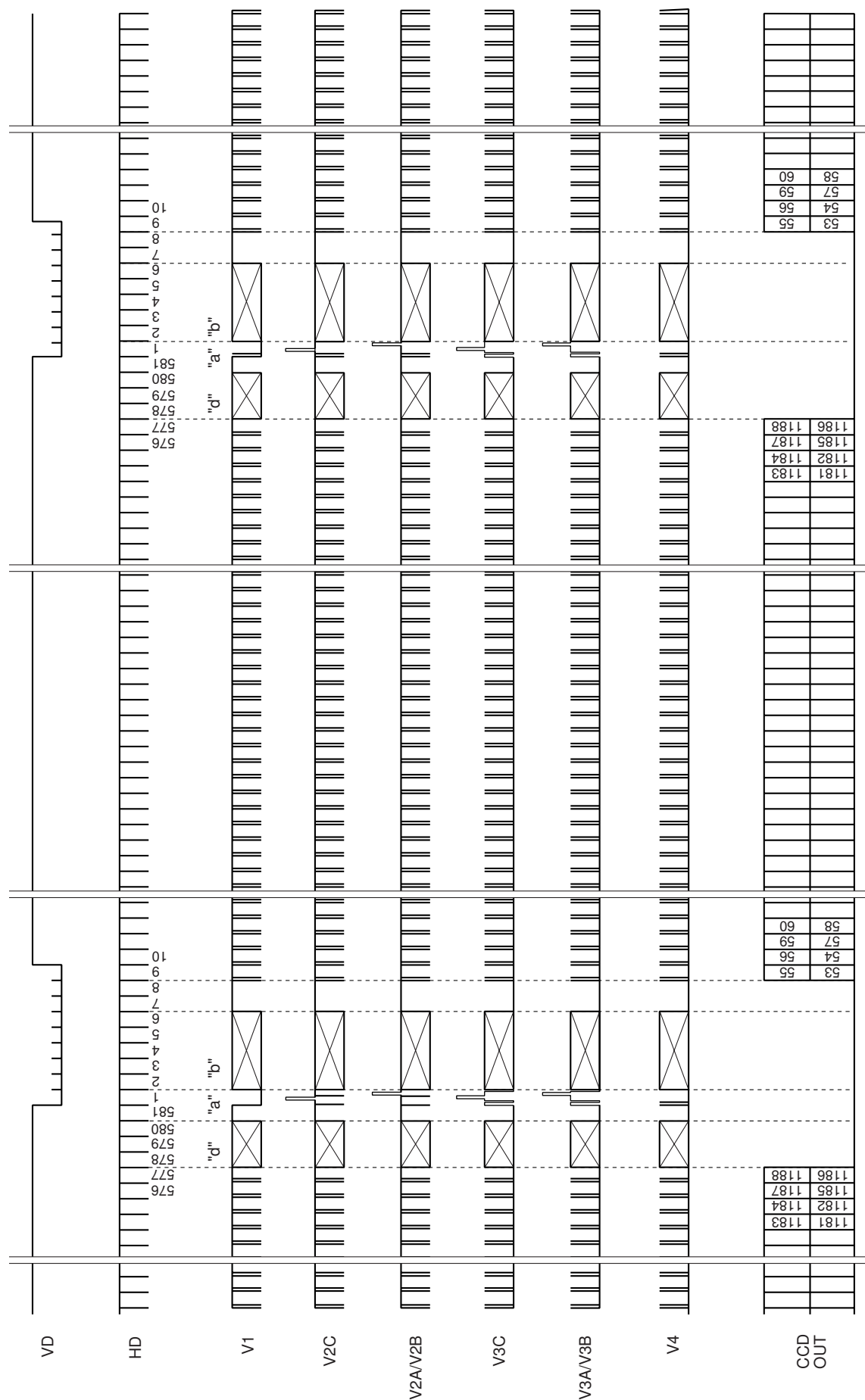


Drive Timing Chart (Vertical Sync) Center Scan Mode (2)/(28.6MHz)



Note) The 462H horizontal period is 1230clk.

Drive Timing Chart (Vertical Sync)

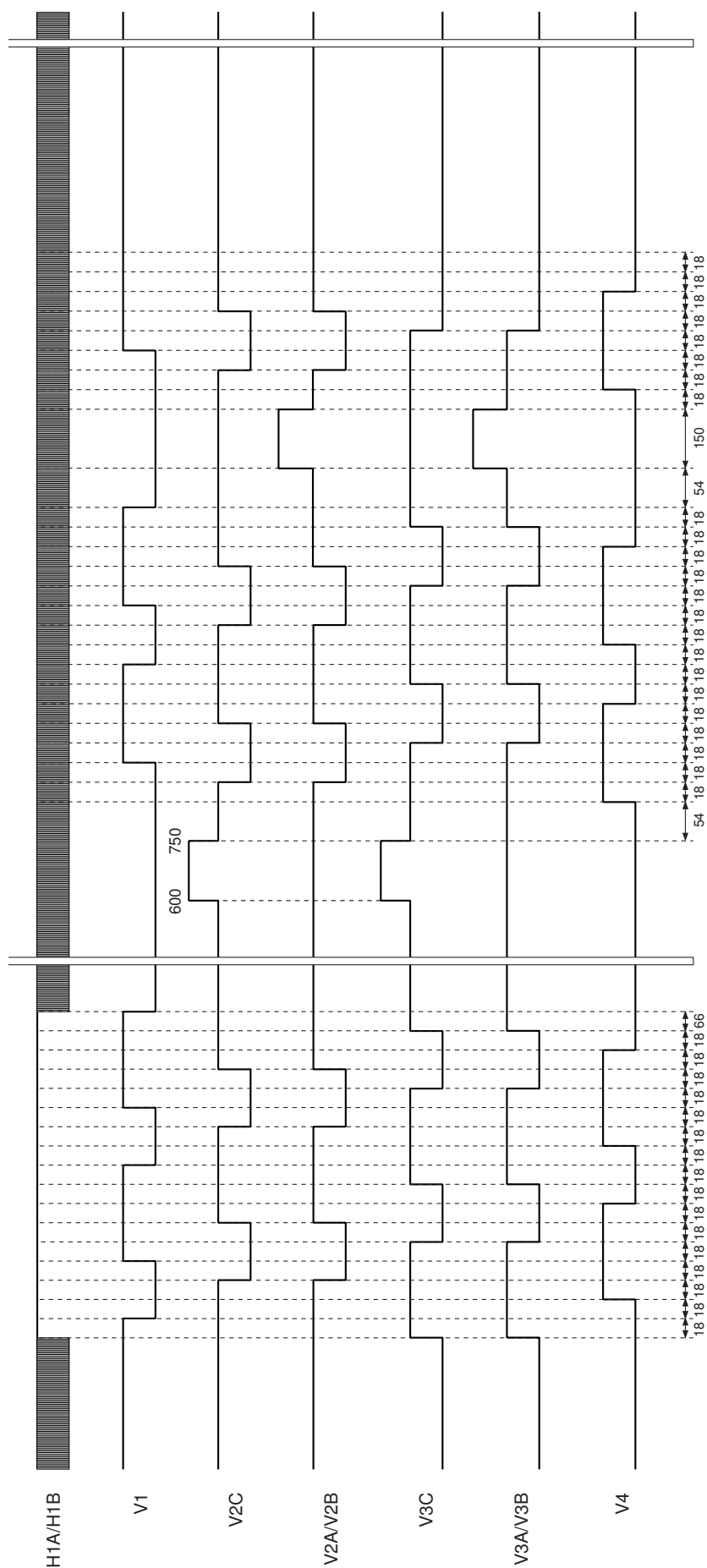


Note) The 581H horizontal period is 601 clk.

Center Scan Mode (2)

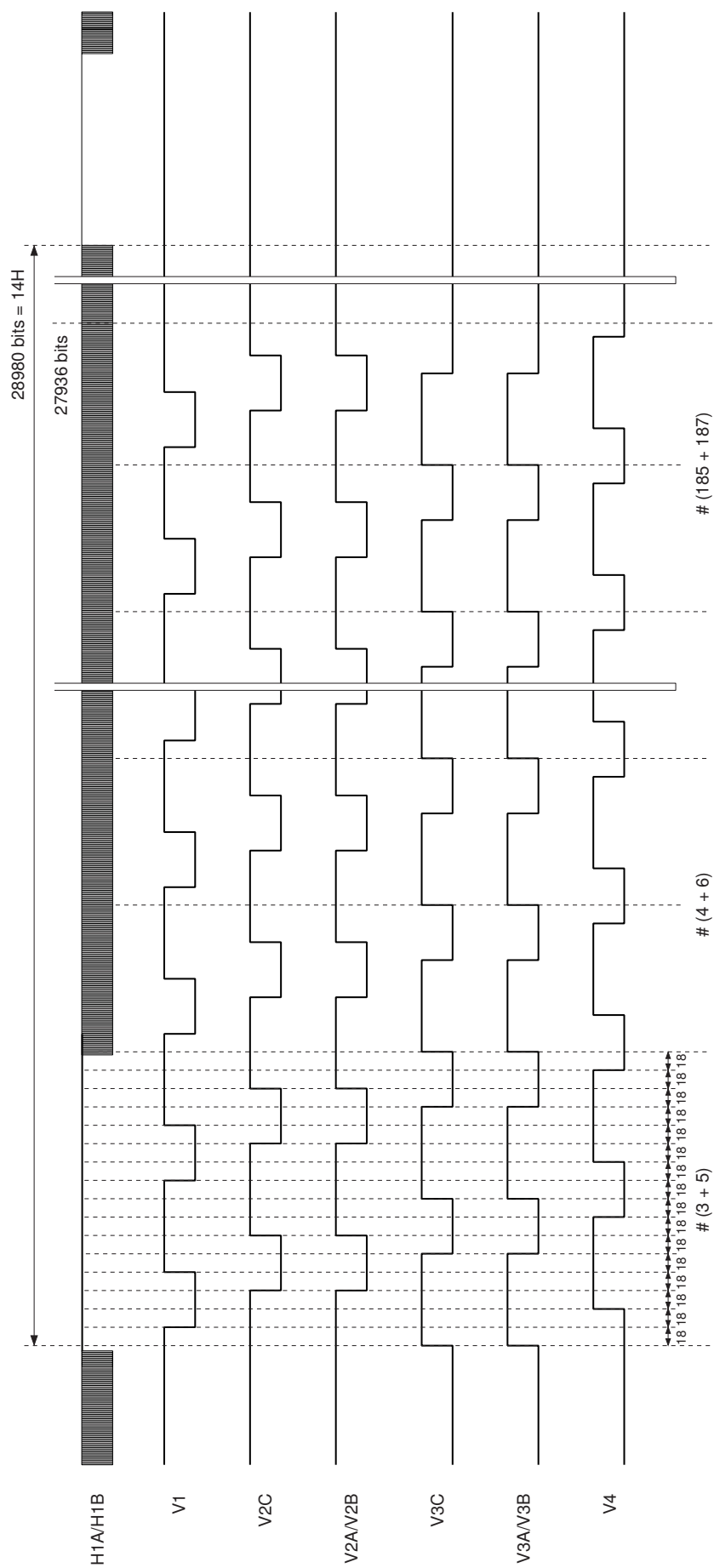
Drive Timing Chart (Vertical Sync)

"a" enlarged



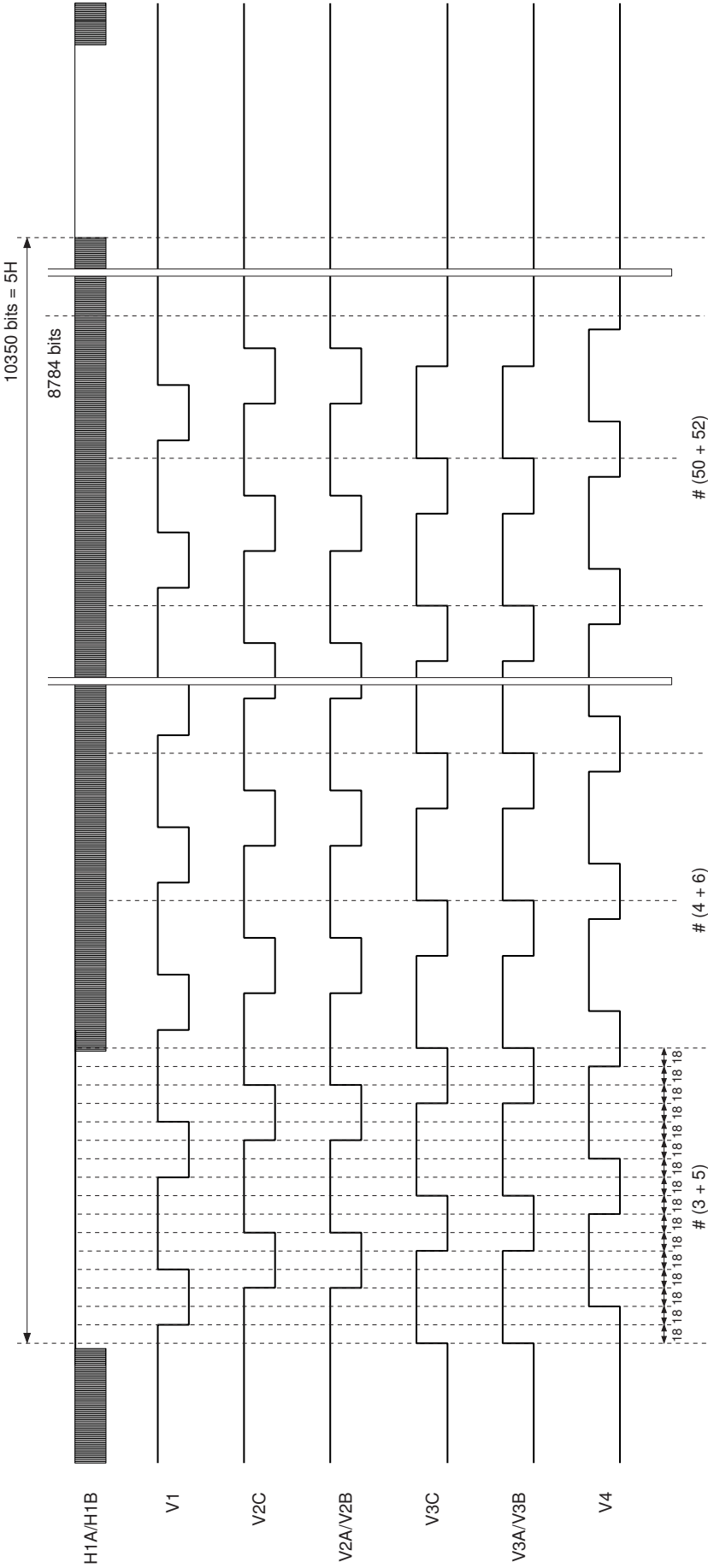
Drive Timing Chart (Vertical Sync)

"b" enlarged

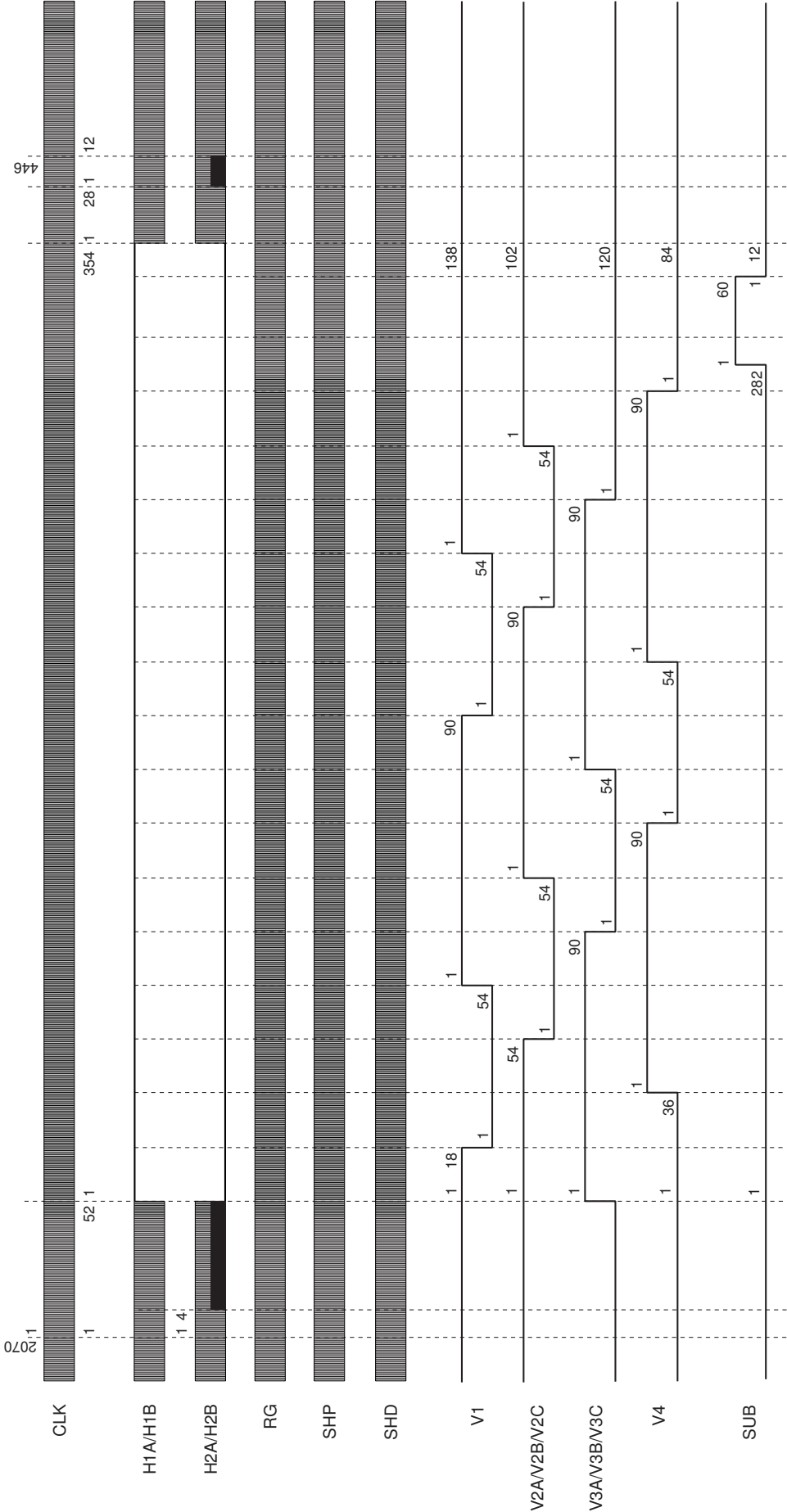


Drive Timing Chart (Vertical Sync) Center Scan Mode (2)/(36MHz)

"b" enlarged

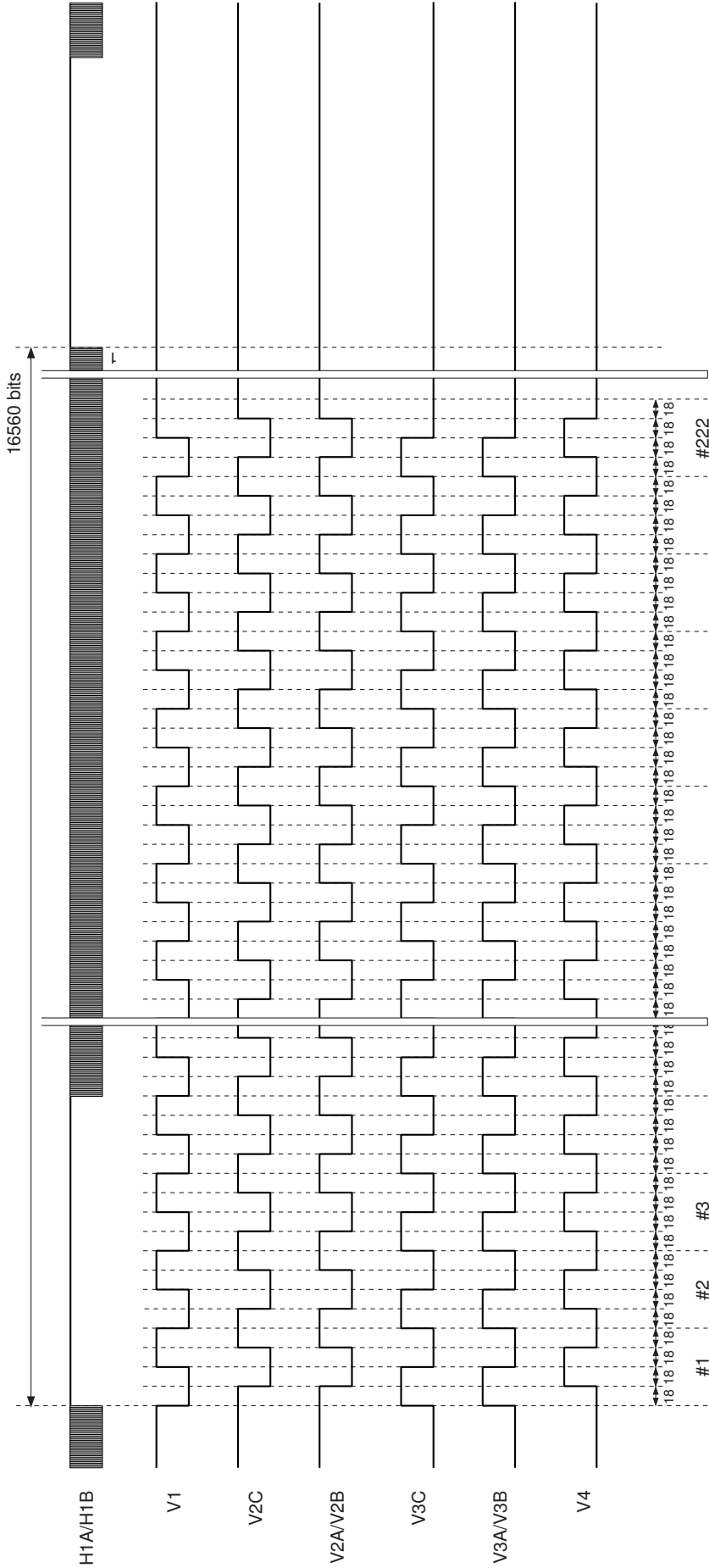


Drive Timing Chart (Horizontal Sync) Center Scan Modes (1) and (2)



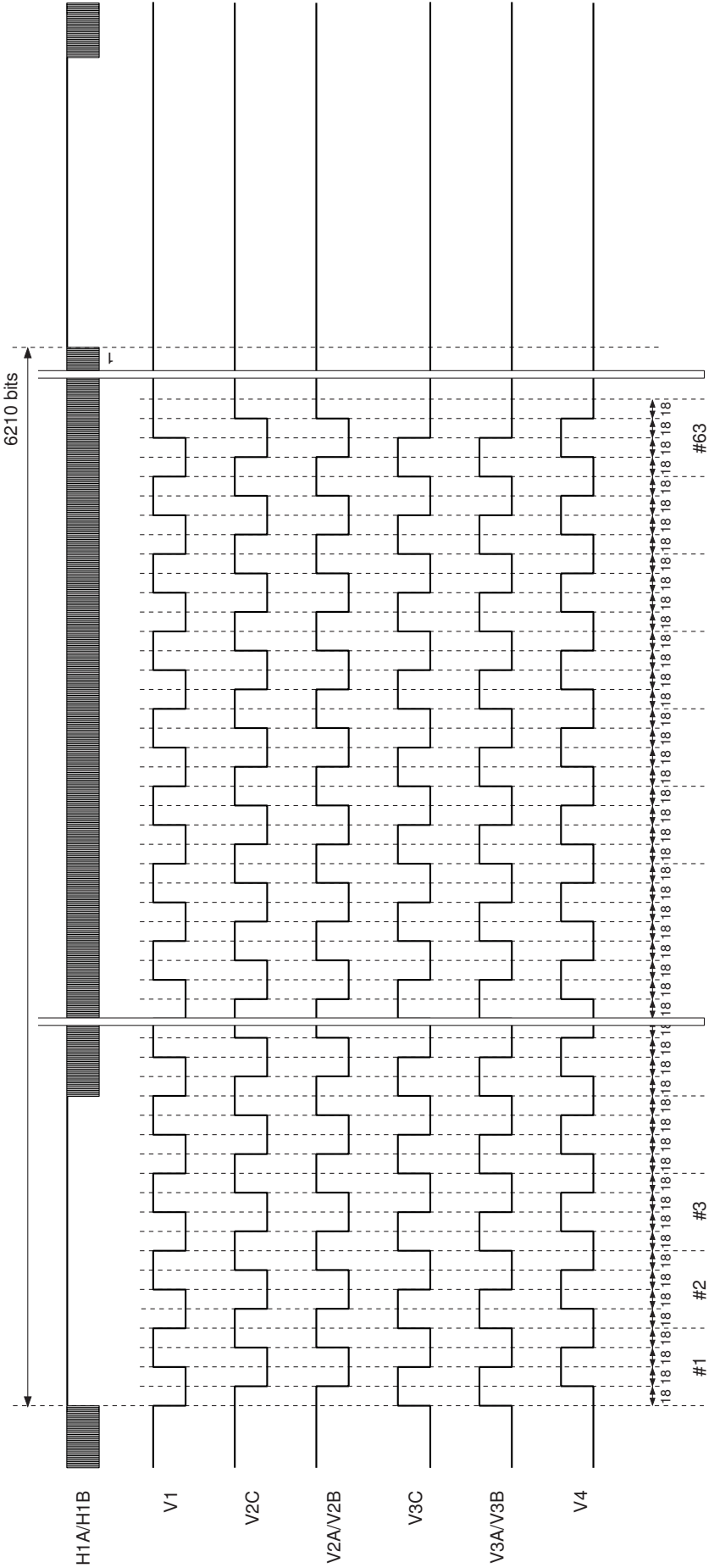
Drive Timing Chart (Vertical Sync) Center Scan Modes (1) and (2)/(28.6MHz)

"d" enlarged

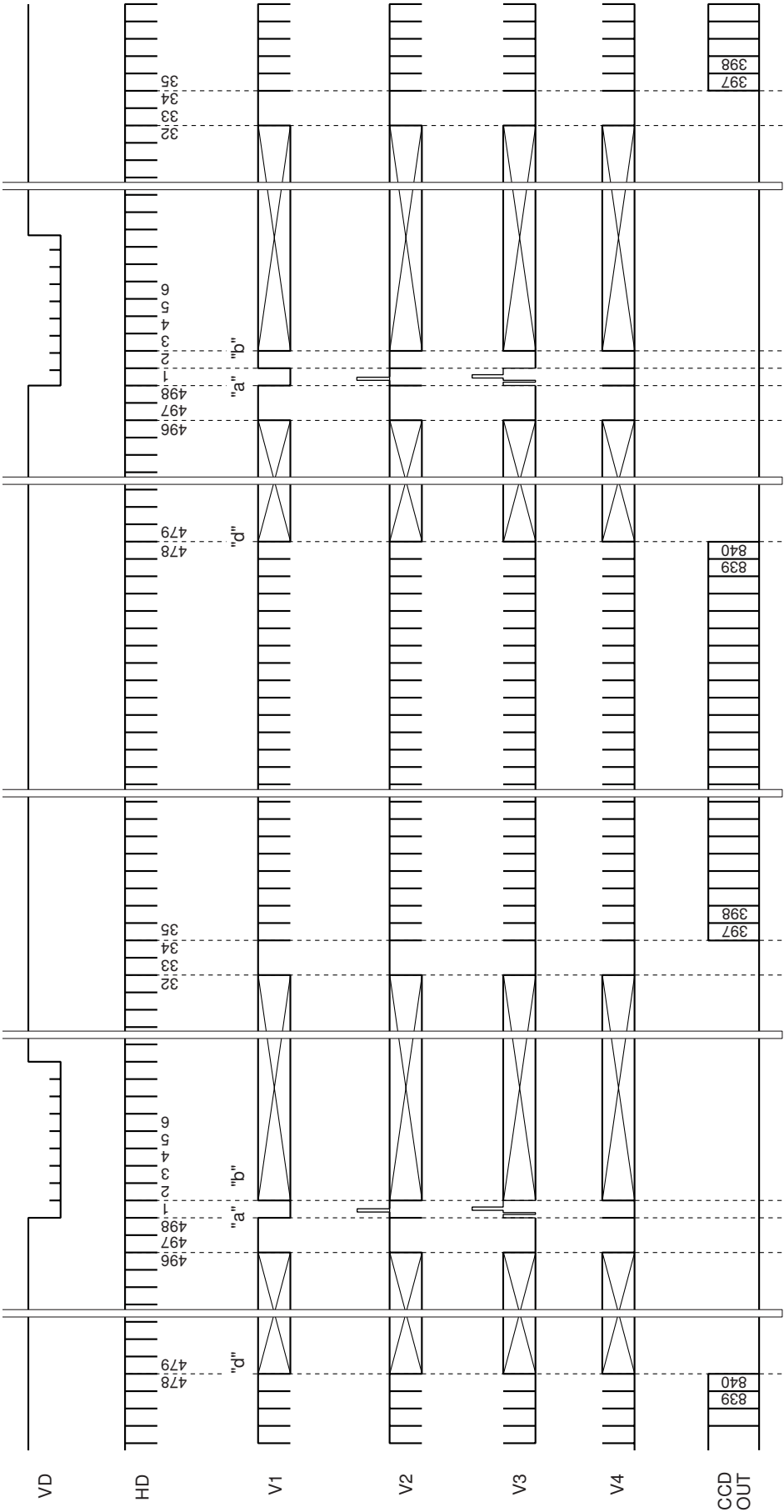


Drive Timing Chart (Vertical Sync) Center Scan Modes (1) and (2)/(36MHz)

"d" enlarged

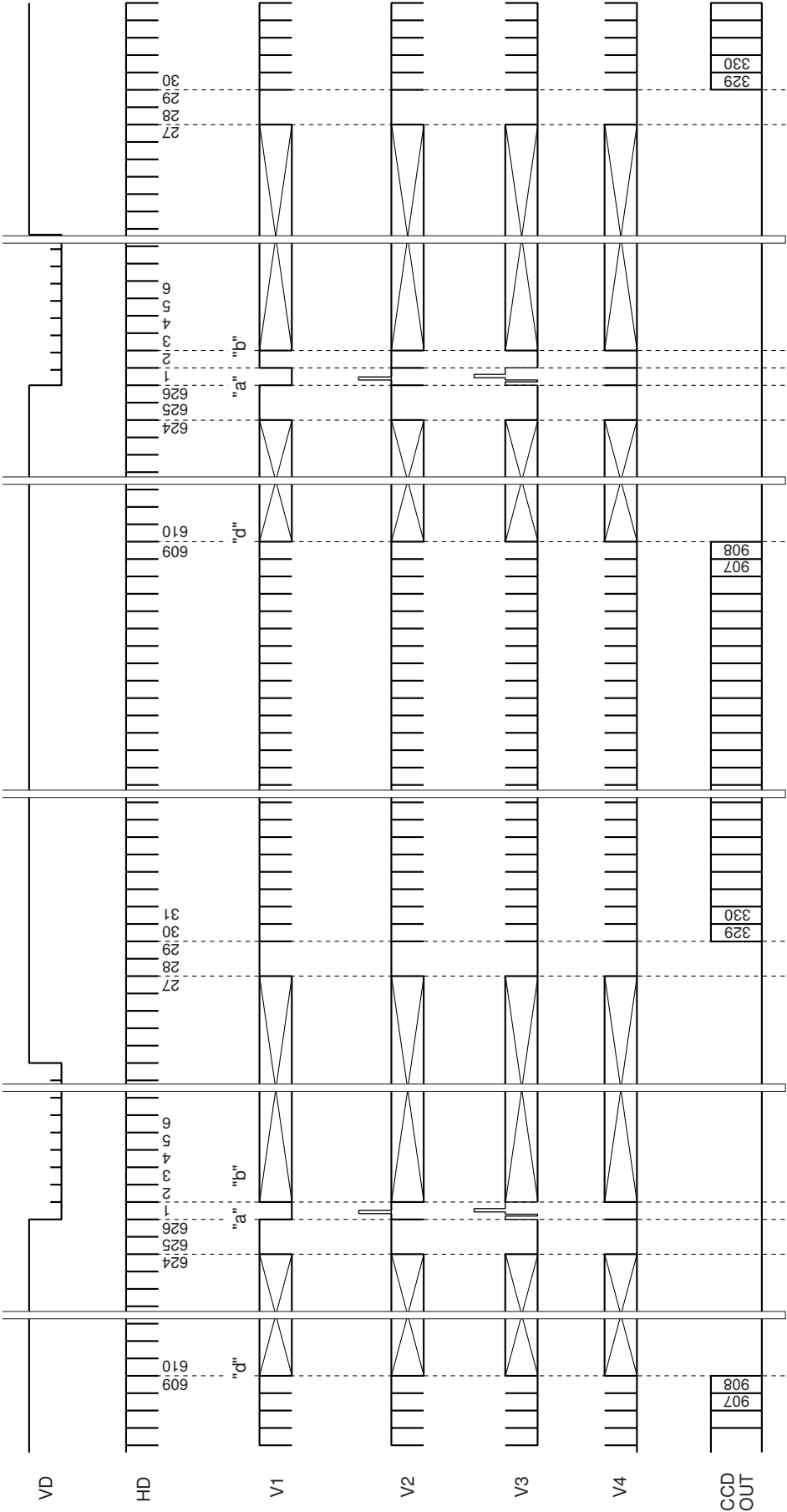


Drive Timing Chart (Vertical Sync) Center Scan Mode (3)/(28.6MHz)



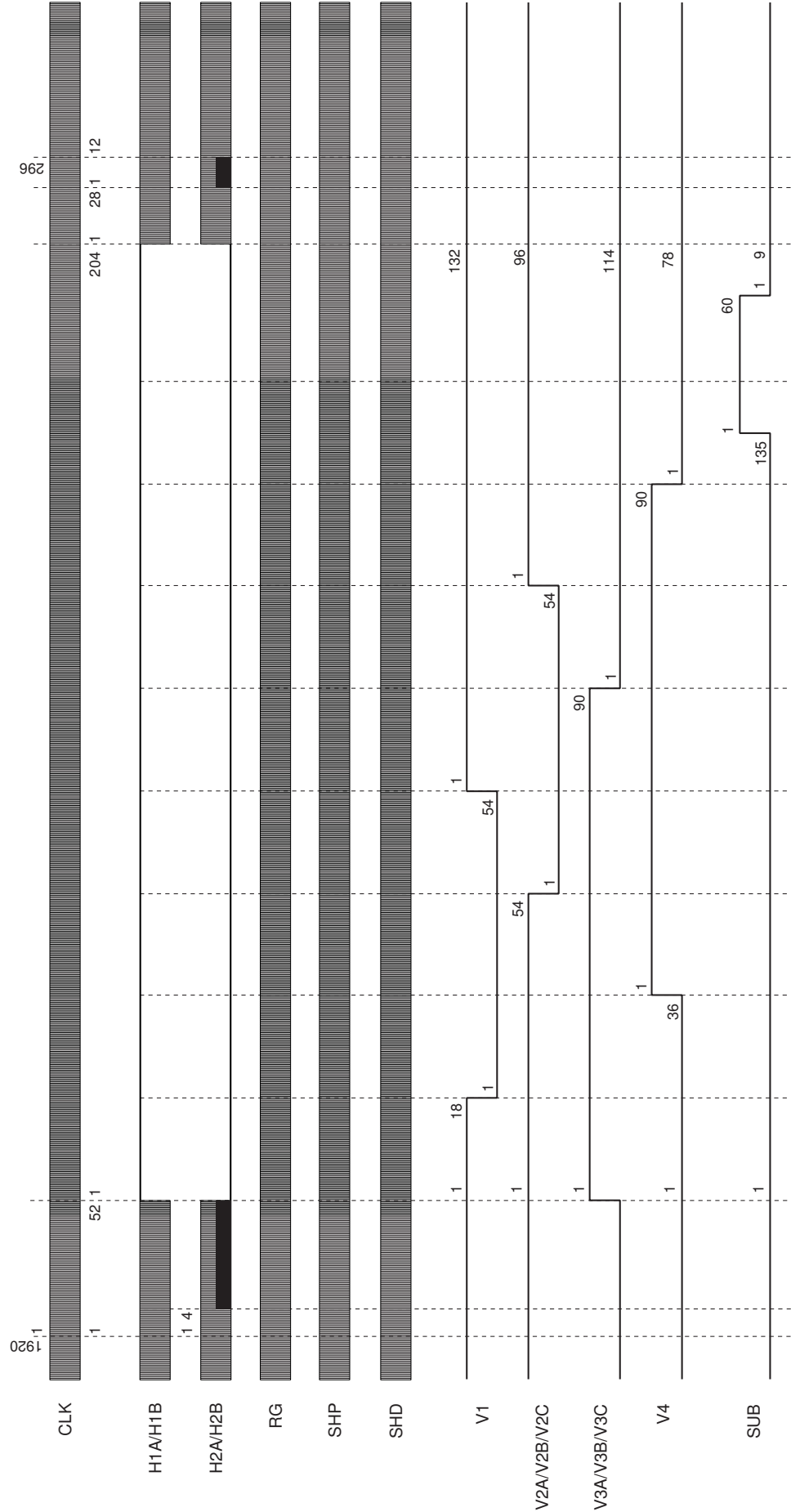
Note) The 498H horizontal period is 1260clk.

Drive Timing Chart (Vertical Sync) Center Scan Mode (3)/(36MHz)



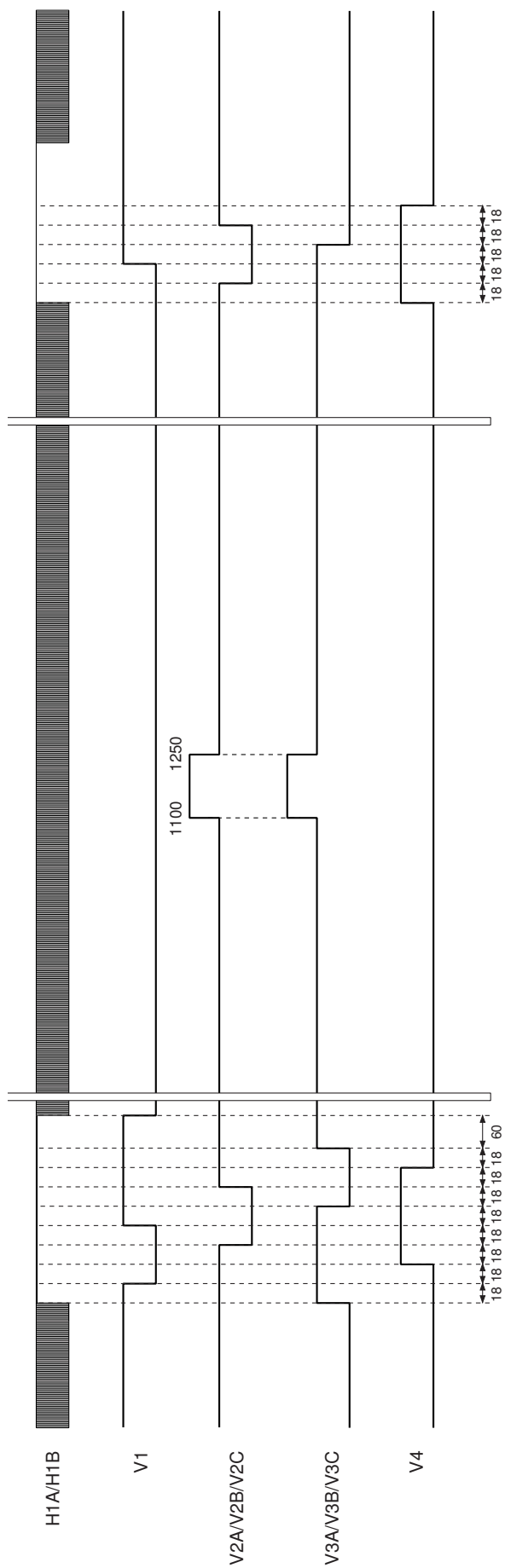
Note) The 626H horizontal period is 1200clk.

Drive Timing Chart (Horizontal Sync) Center Scan Mode (3)



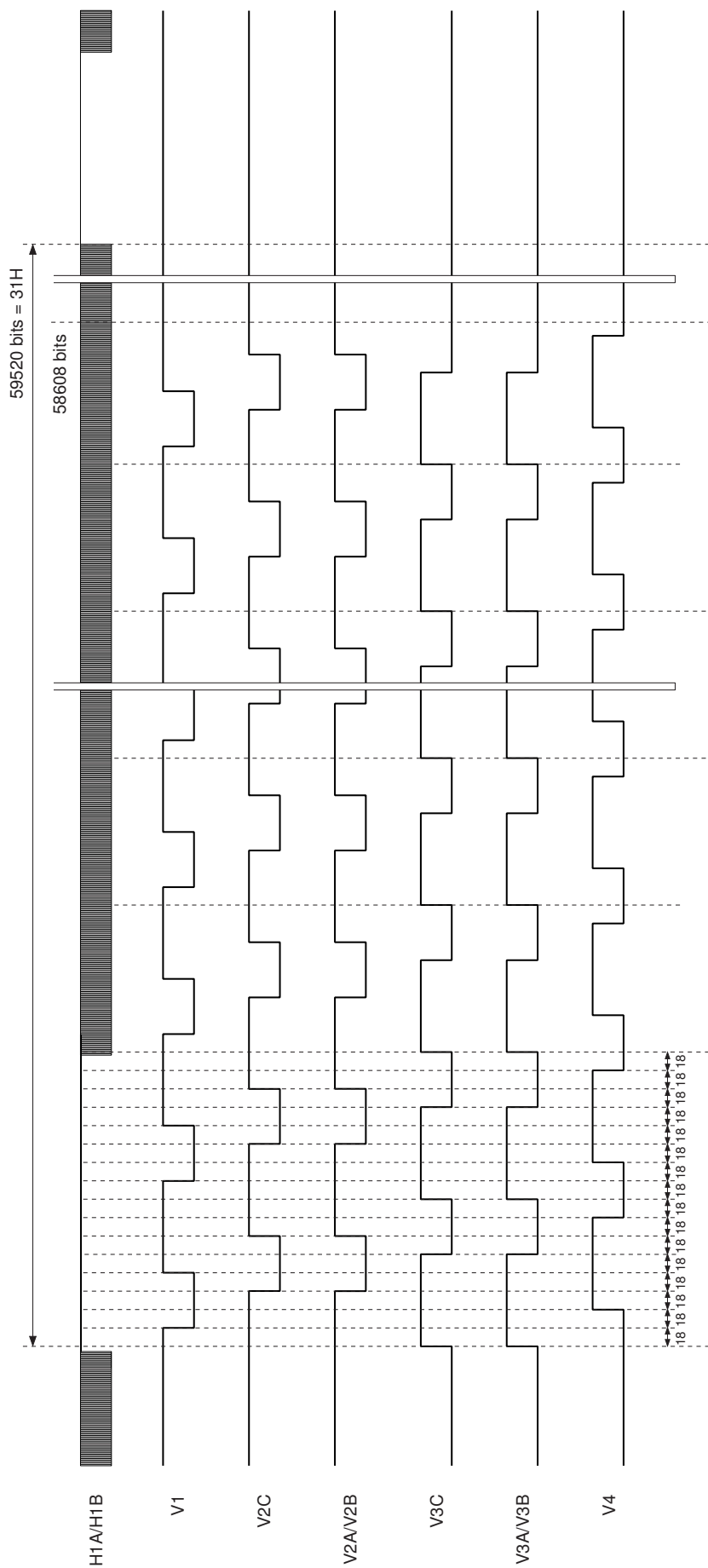
Drive Timing Chart (Vertical Sync)

"a" enlarged

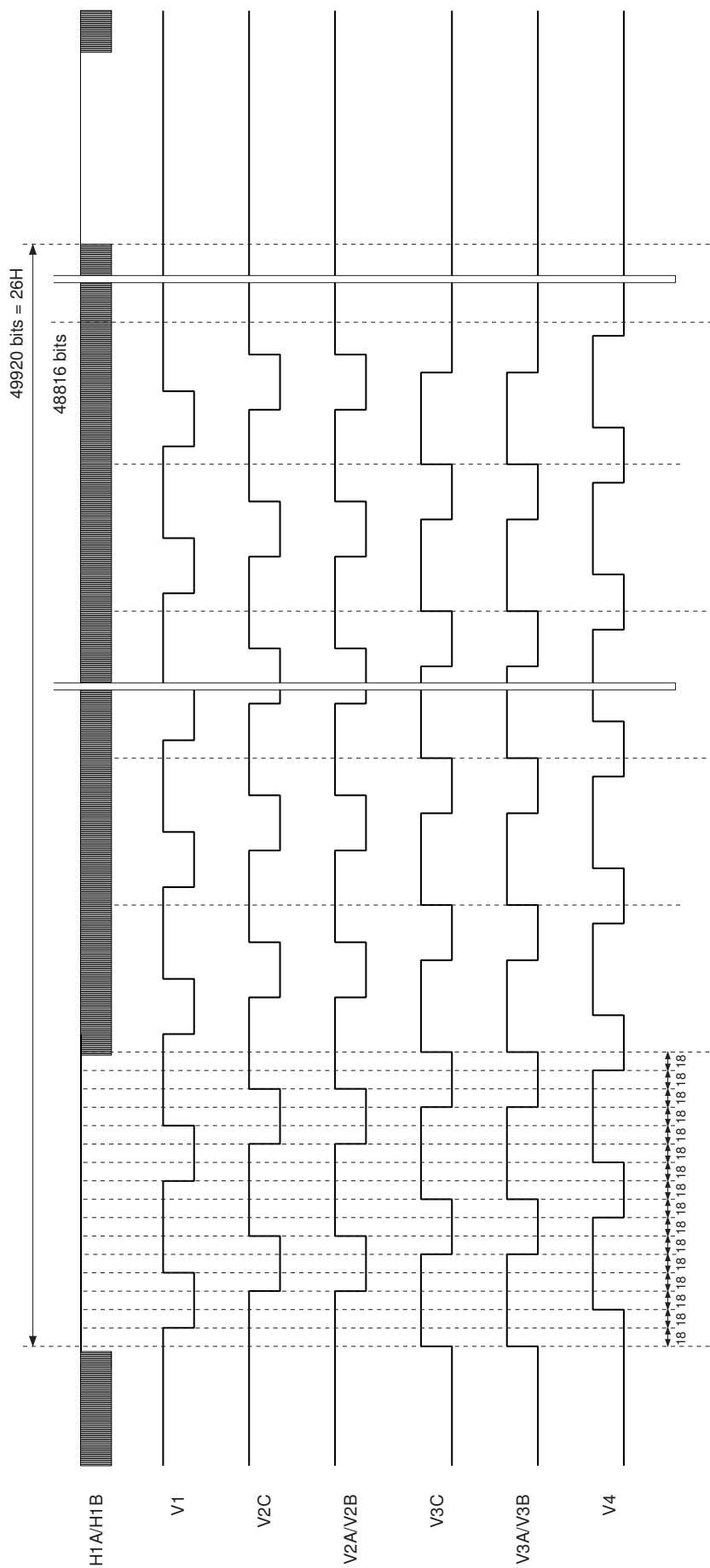


Drive Timing Chart (Vertical Sync)

"b" enlarged

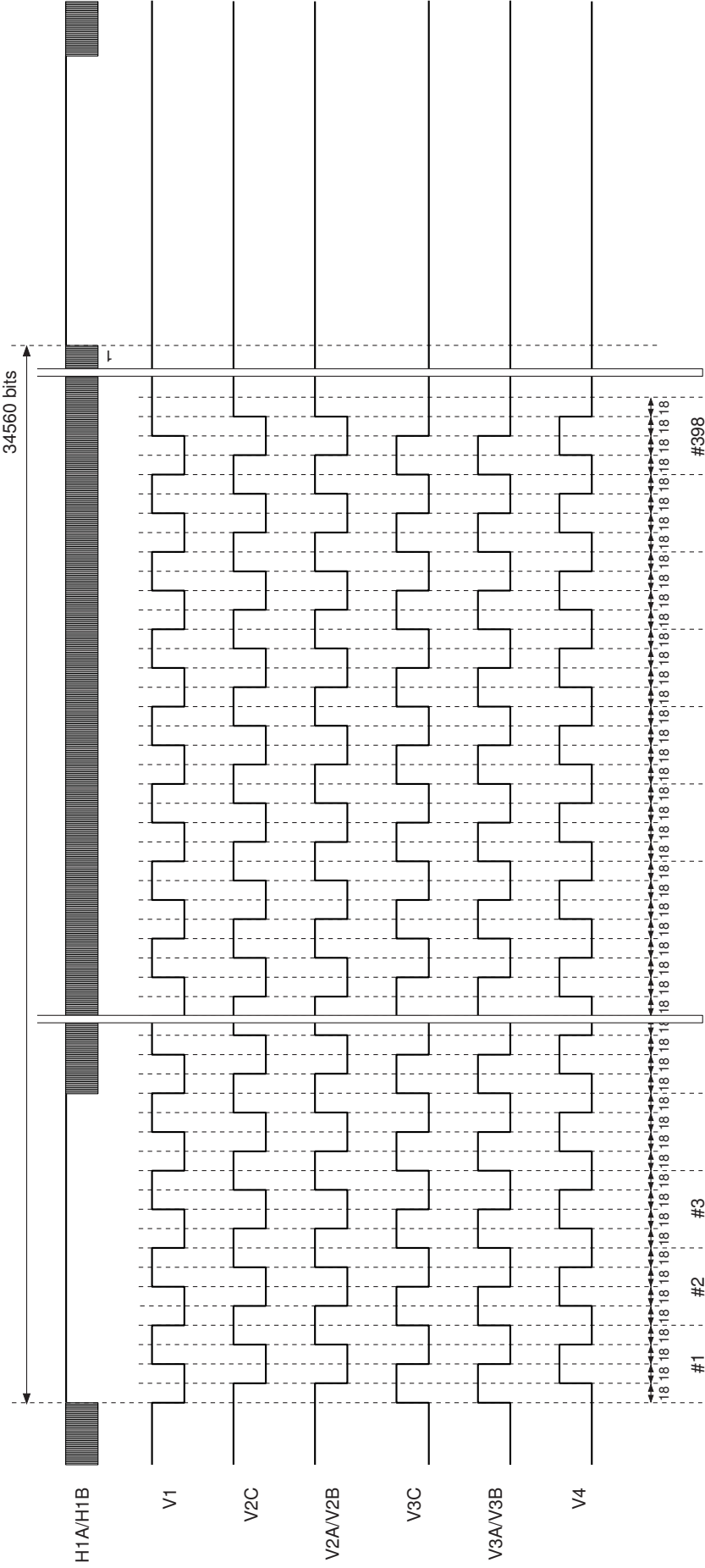


"b" enlarged



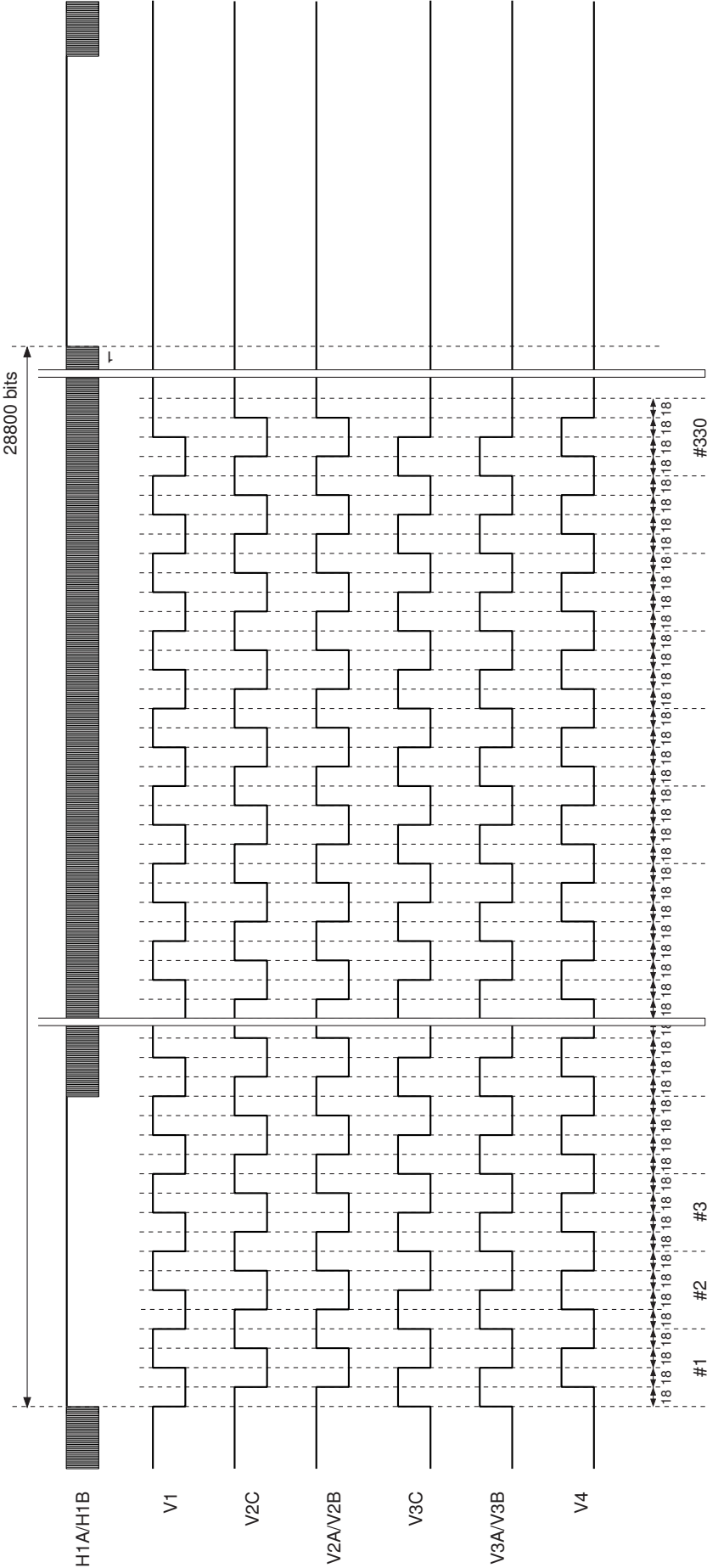
Drive Timing Chart (Vertical Sync) Center Scan Mode (3)/(28.6MHz)

"d" enlarged

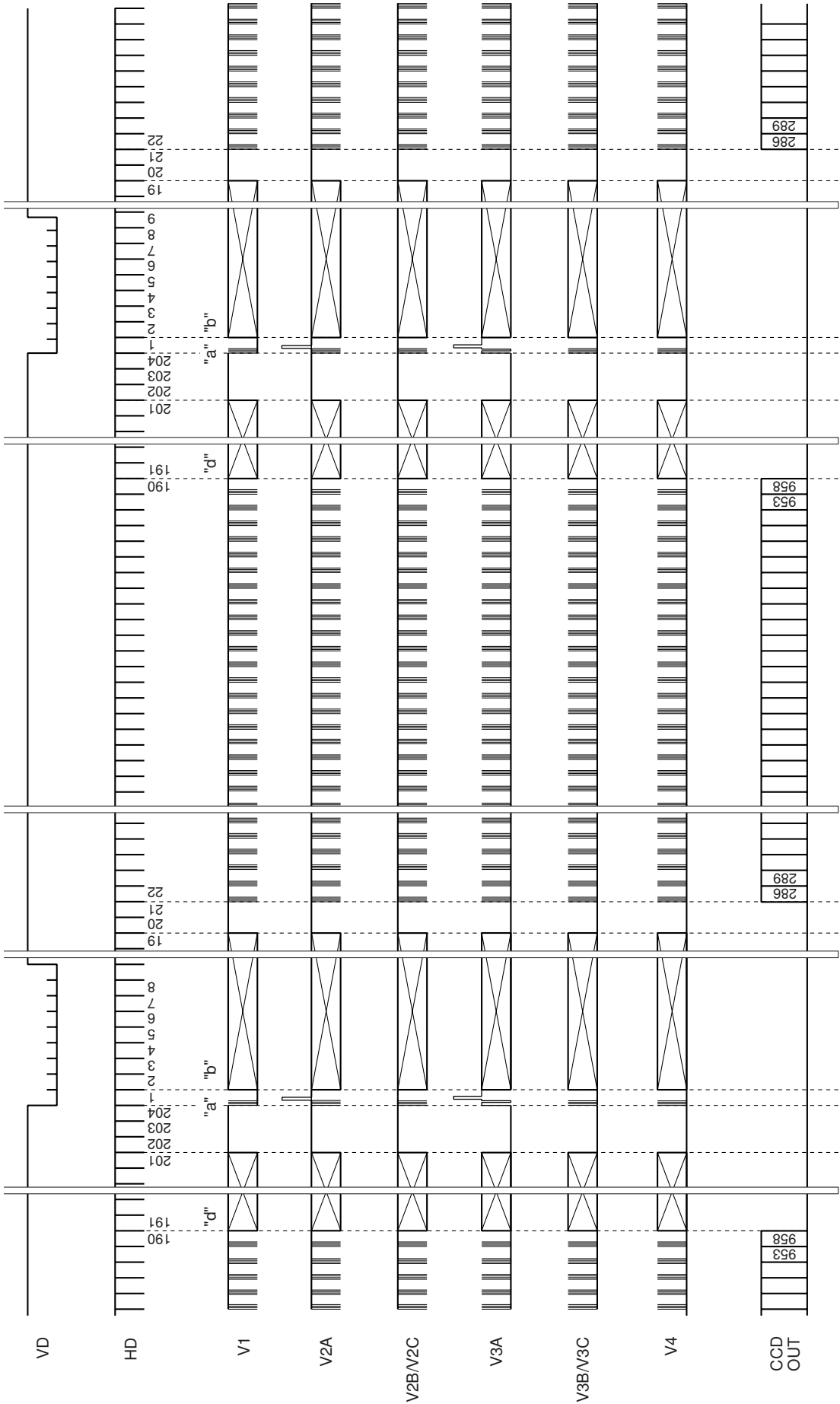


Drive Timing Chart (Vertical Sync) Center Scan Mode (3)/(36MHz)

"d" enlarged

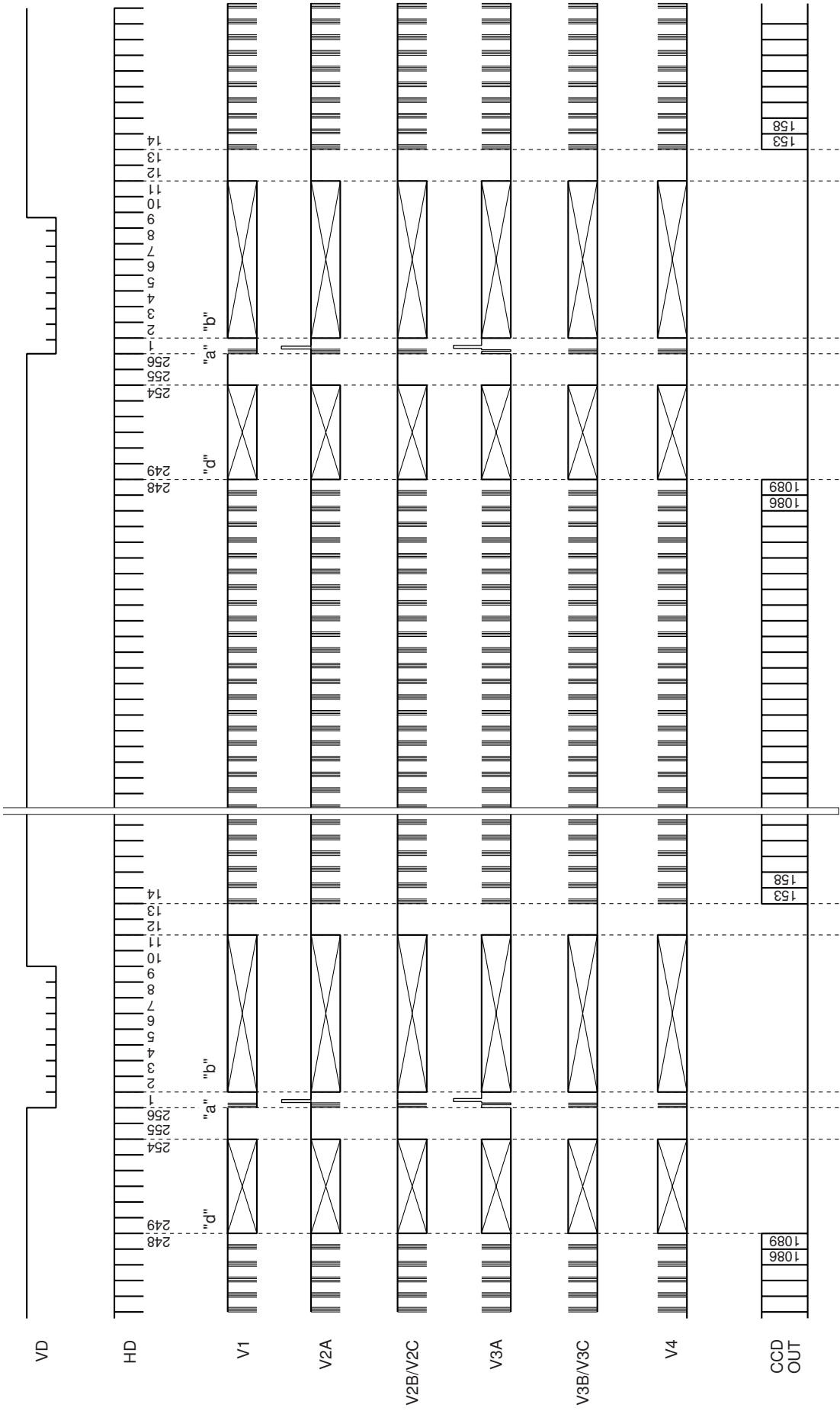


Drive Timing Chart (Vertical Sync) AF Mode (1)/(28.6MHz)



Note) The 203 and 204H horizontal periods are 1323clk.

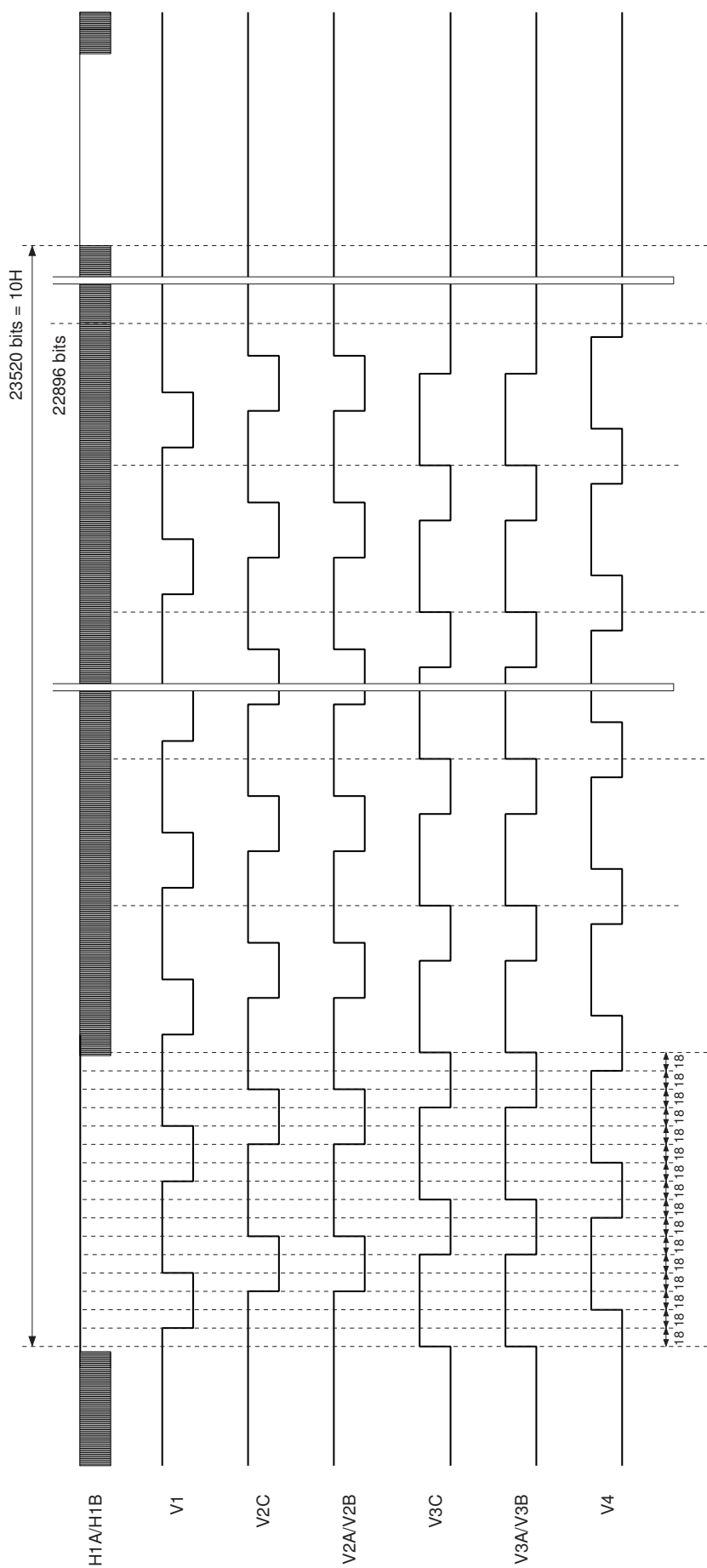
Drive Timing Chart (Vertical Sync) AF Mode (1)/(36MHz)



Note) The 256H horizontal period is 840clk.

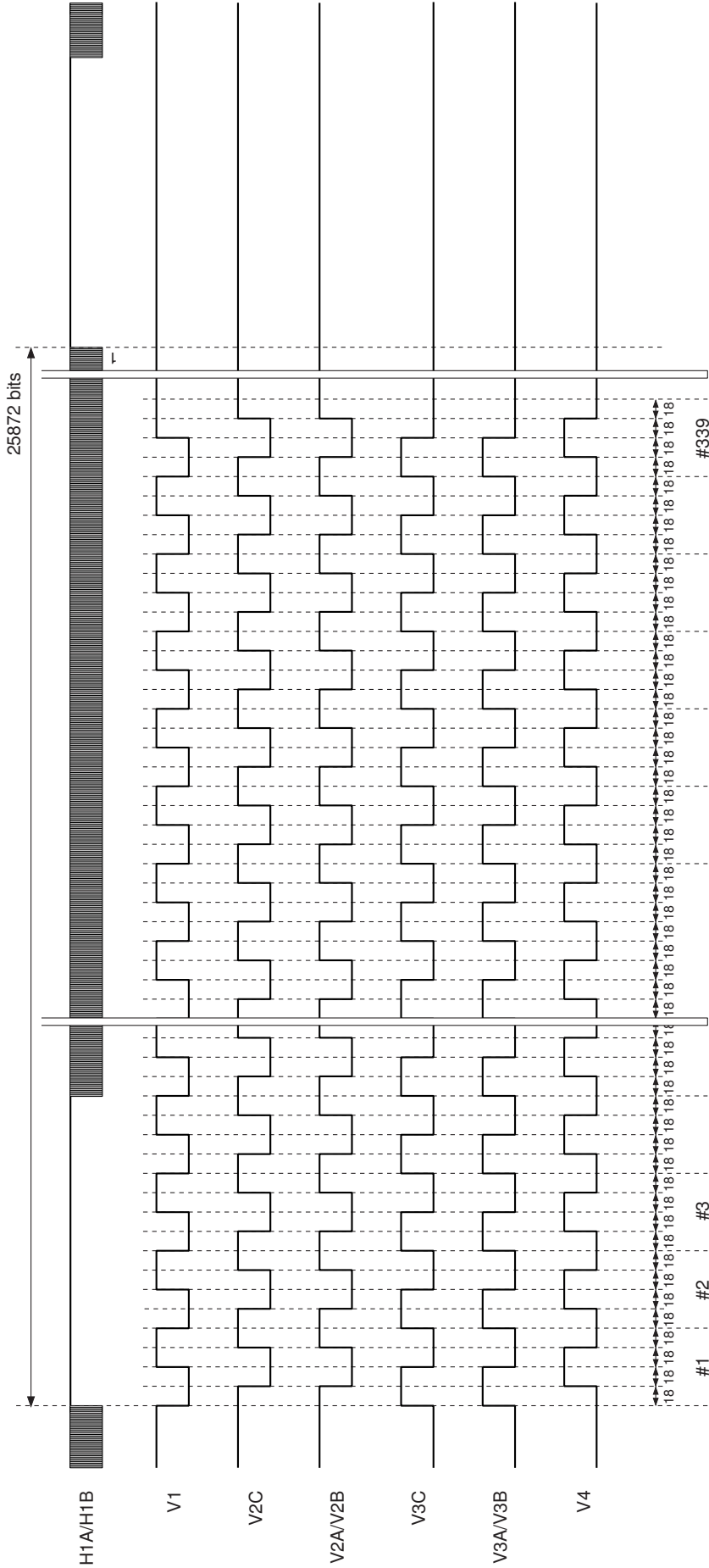
Drive Timing Chart (Vertical Sync)

"b" enlarged



Drive Timing Chart (Vertical Sync) AF Mode (1)/(28.6MHz)

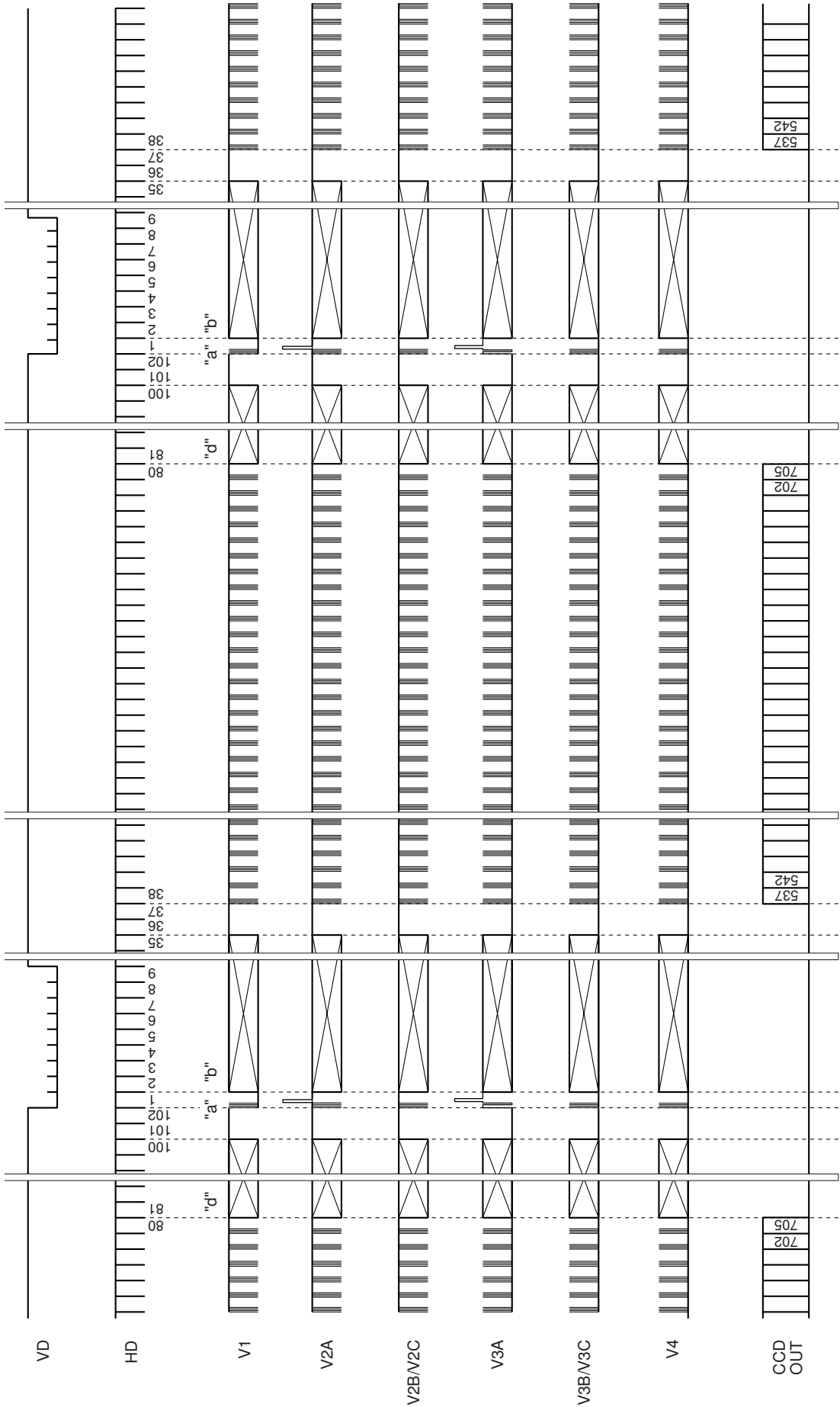
"d" enlarged



"d" enlarged

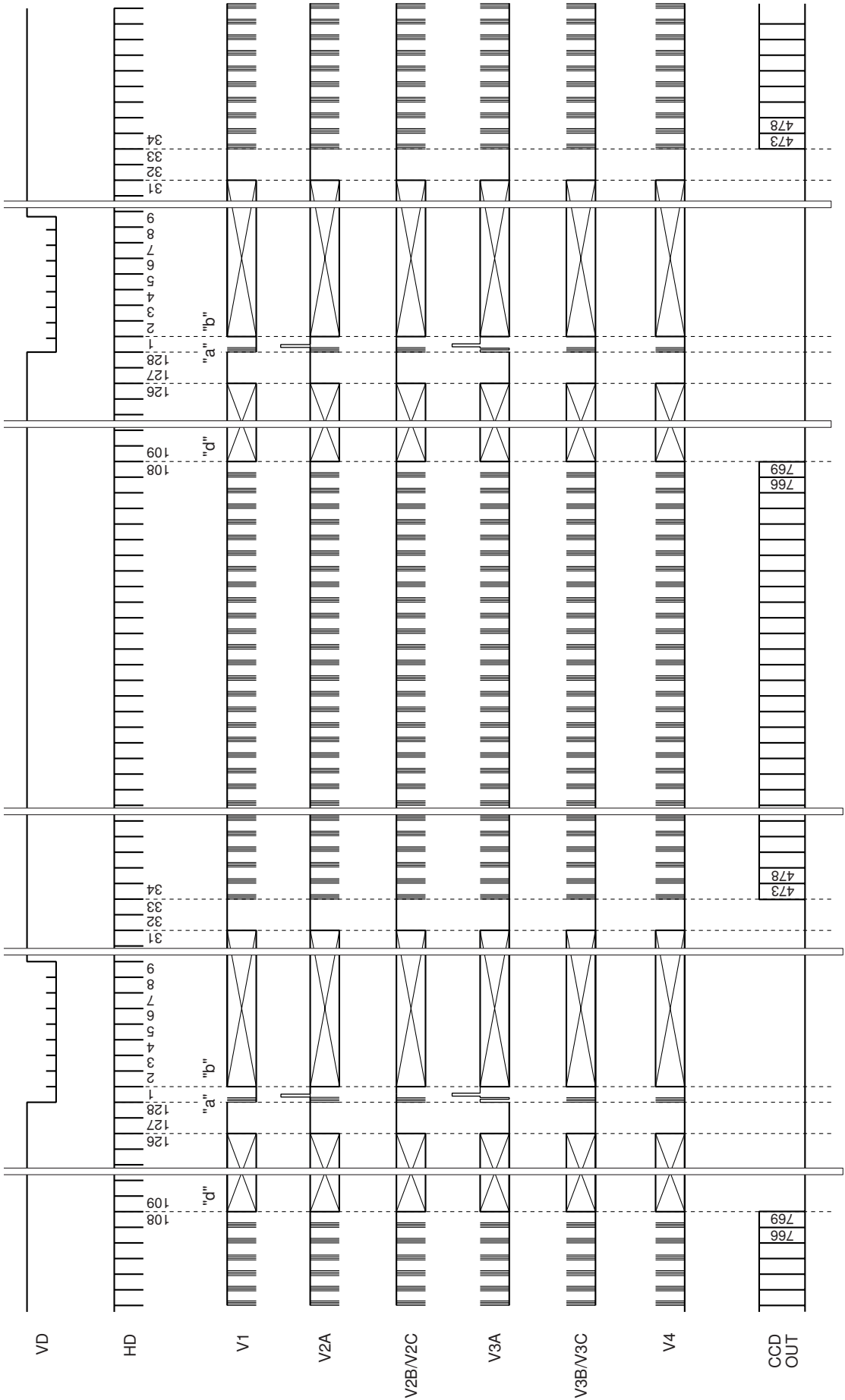


Drive Timing Chart (Vertical Sync) AF Mode (2)/(28.6MHz)



Note) The 102H horizontal period is 1323clk.

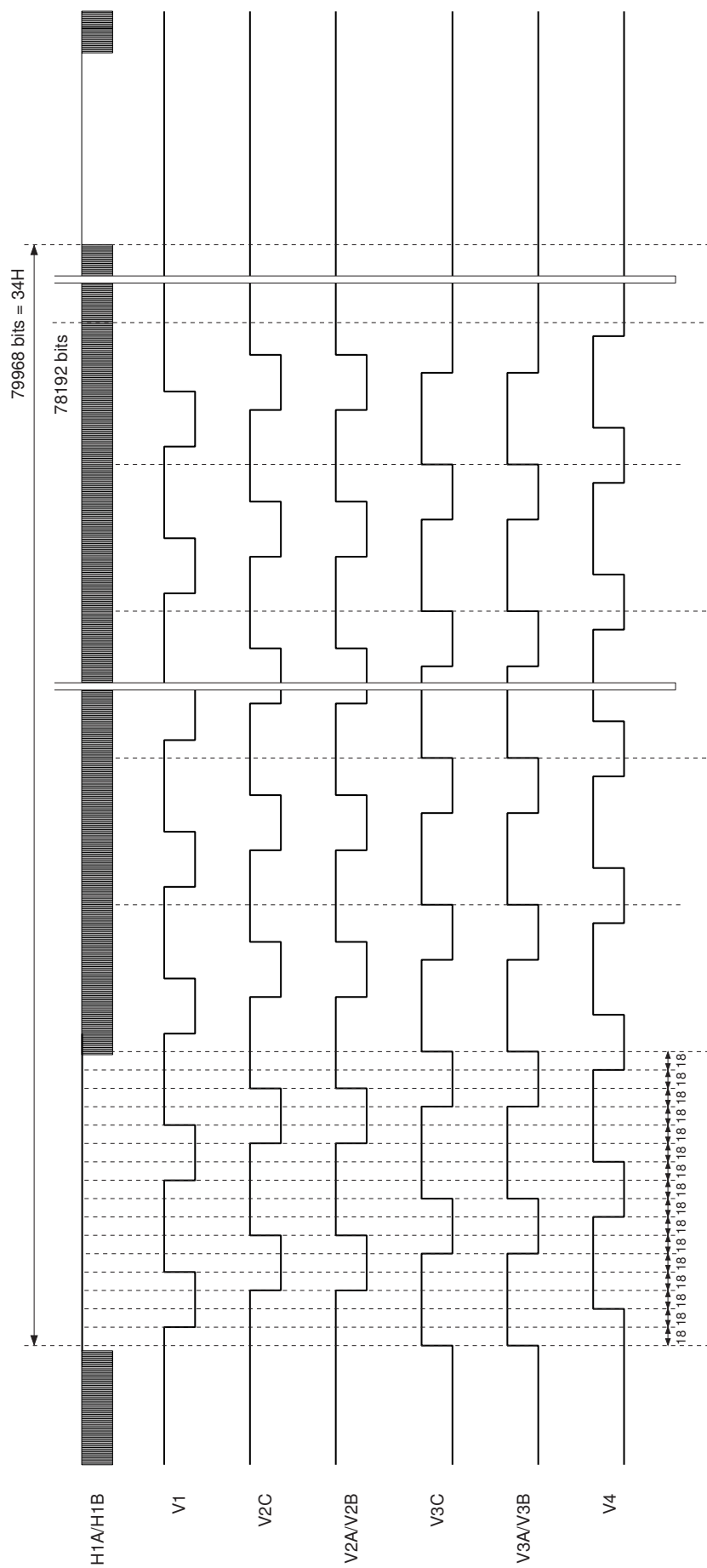
Drive Timing Chart (Vertical Sync) AF Mode (2)/(36MHz)



Note) The 128H horizontal period is 1596clk.

Drive Timing Chart (Vertical Sync)

"b" enlarged

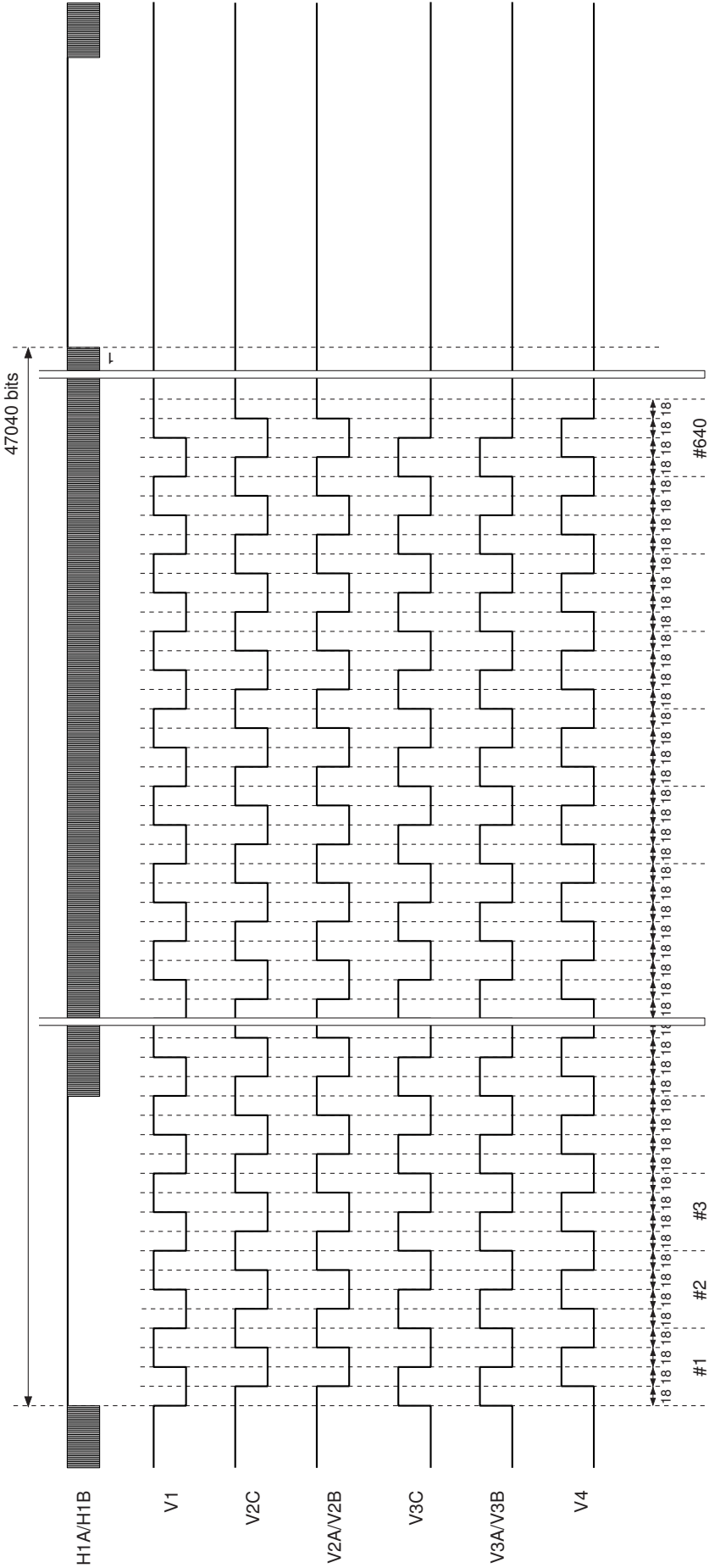


"b" enlarged



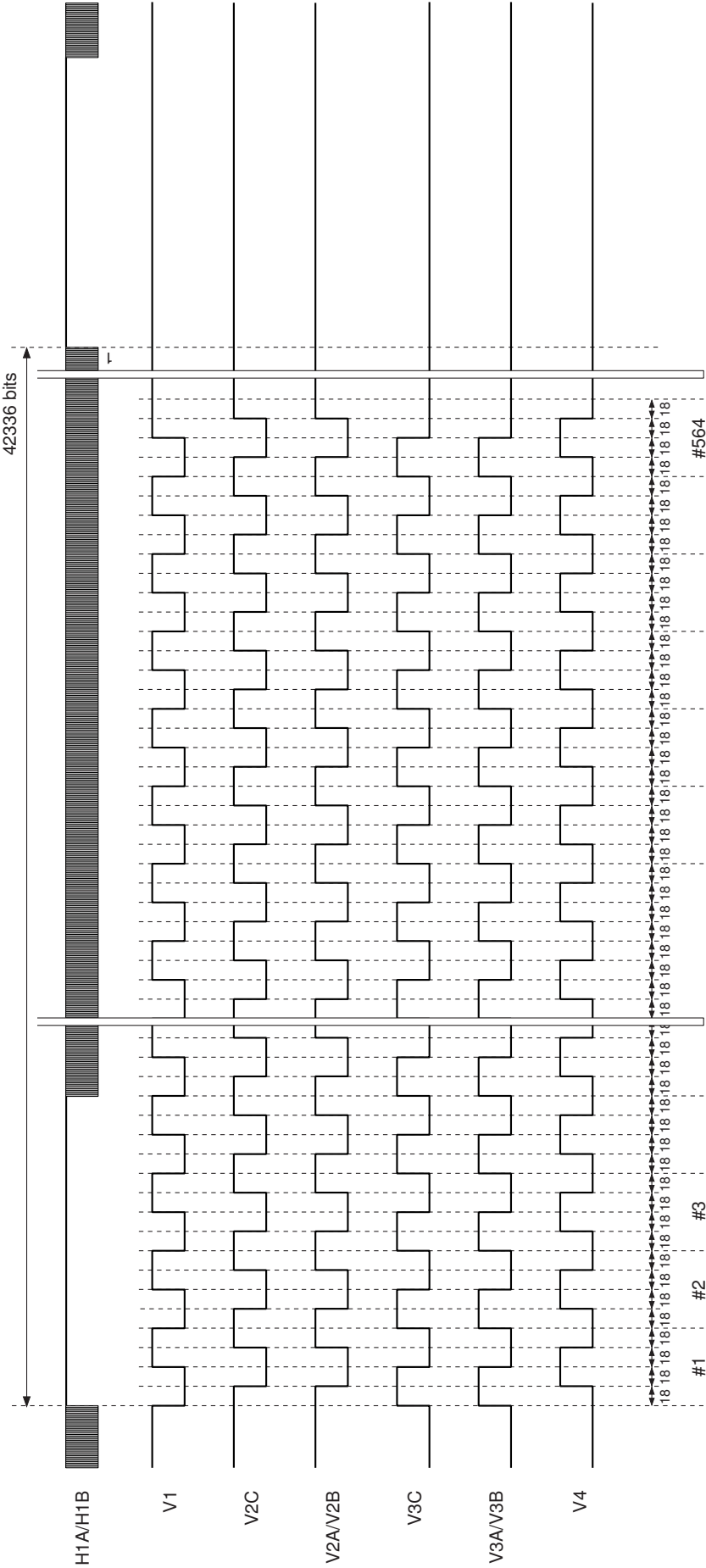
Drive Timing Chart (Vertical Sync) AF Mode (2)/(28.6MHz)

"d" enlarged

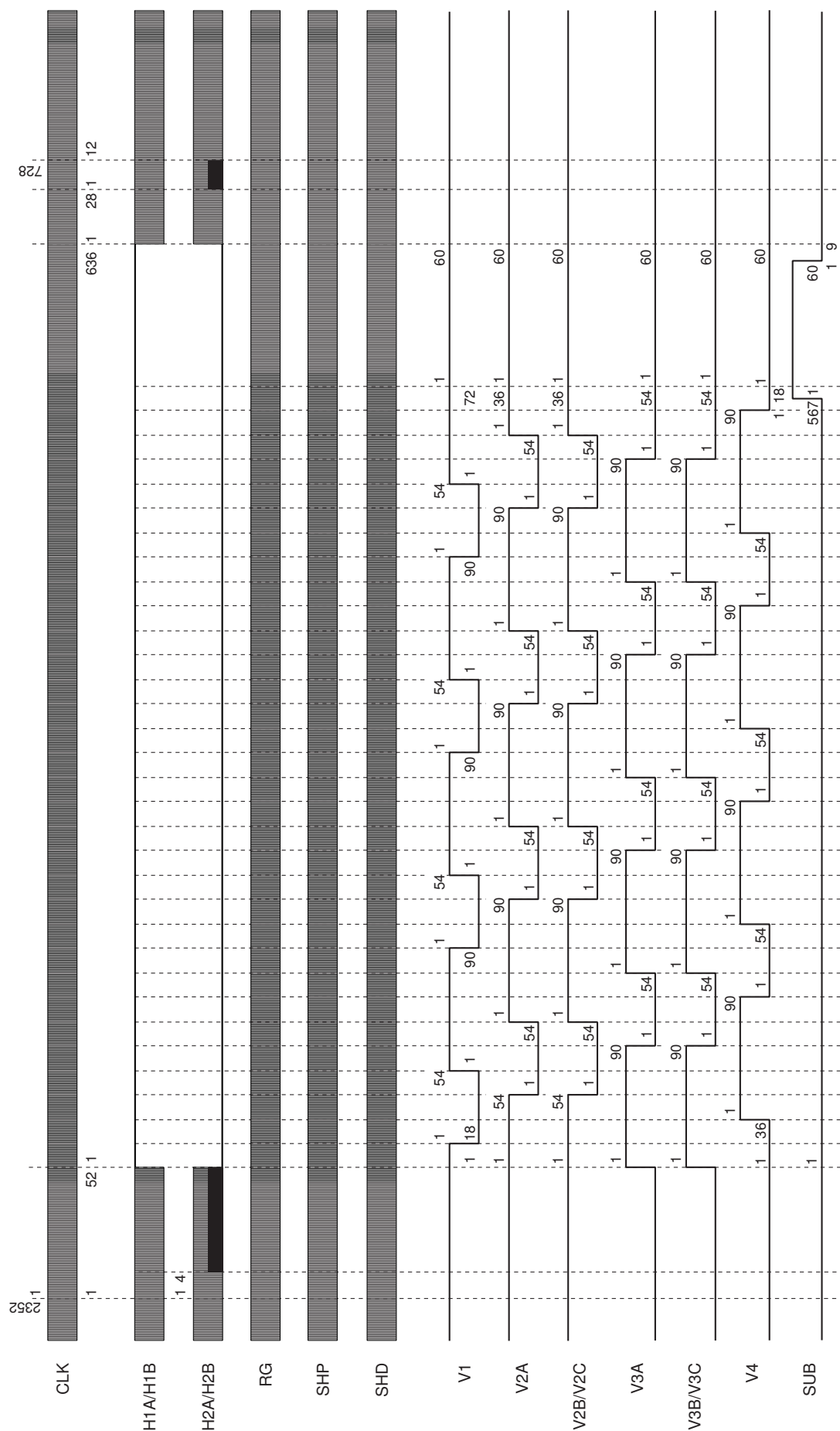


Drive Timing Chart (Vertical Sync) AF Mode (2)/(36MHz)

"d" enlarged

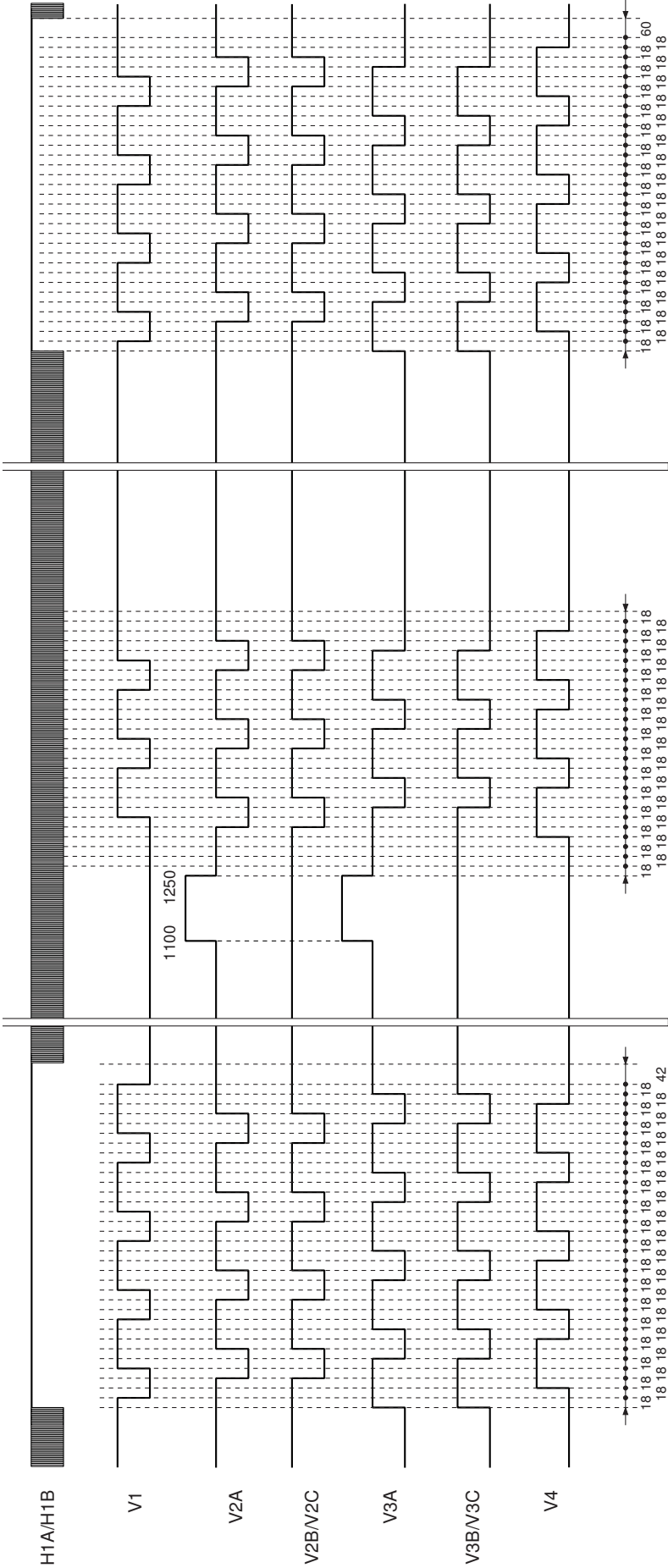


Drive Timing Chart (Horizontal Sync)



Drive Timing Chart (Vertical Sync) AF Modes (1) and (2)

"a" enlarged



Notes of Handling

1) Static charge prevention

CCD image sensors are easily damaged by static discharge. Before handling be sure to take the following protective measures.

- Either handle bare handed or use non-chargeable gloves, clothes or material.
Also use conductive shoes.
- When handling directly use an earth band.
- Install a conductive mat on the floor or working table to prevent the generation of static electricity.
- Ionized air is recommended for discharge when handling CCD image sensors.
- For the shipment of mounted substrates, use boxes treated for the prevention of static charges.

2) Soldering

- Make sure the package temperature does not exceed 80°C.
- Solder dipping in a mounting furnace causes damage to the glass and other defects. Use a ground 30W soldering iron and solder each pin in less than 2 seconds. For repairs and remount, cool sufficiently.
- To dismount an image sensor, do not use a solder suction equipment. When using an electric desoldering tool, use a thermal controller of the zero-cross On/Off type and connect it to ground.

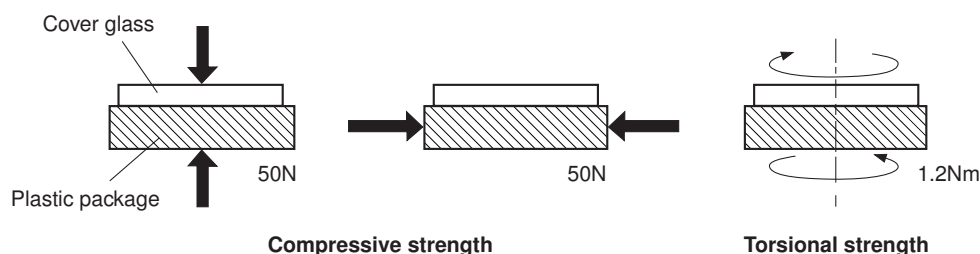
3) Dust and dirt protection

Image sensors are packed and delivered by taking care of protecting its glass plates from harmful dust and dirt. Clean glass plates with the following operations as required, and use them.

- Perform all assembly operations in a clean room (class 1000 or less).
- Do not either touch glass plates by hand or have any object come in contact with glass surfaces. Should dirt stick to a glass surface, blow it off with an air blower. (For dirt stuck through static electricity ionized air is recommended.)
- Clean with a cotton bud and ethyl alcohol if grease stained. Be careful not to scratch the glass.
- Keep in a case to protect from dust and dirt. To prevent dew condensation, preheat or precool when moving to a room with great temperature differences.
- When a protective tape is applied before shipping, just before use remove the tape applied for electrostatic protection. Do not reuse the tape.

4) Installing (attaching)

- Remain within the following limits when applying a static load to the package. Do not apply any load more than 0.7mm inside the outer perimeter of the glass portion, and do not apply any load or impact to limited portions. (This may cause cracks in the package.)

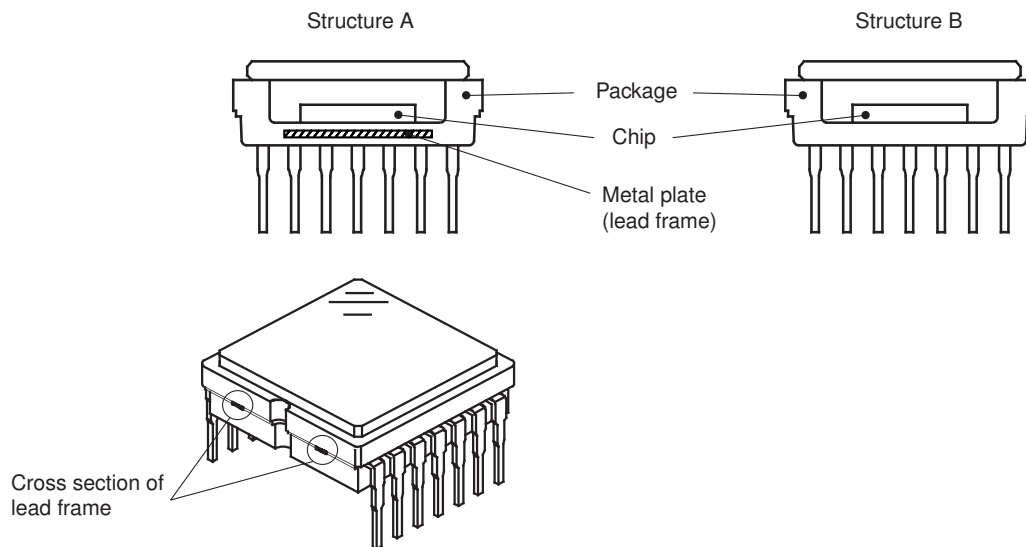


- If a load is applied to the entire surface by a hard component, bending stress may be generated and the package may fracture, etc., depending on the flatness of the bottom of the package. Therefore, for installation, use either an elastic load, such as a spring plate, or an adhesive.

- c) The adhesive may cause the marking on the rear surface to disappear, especially in case the regulated voltage value is indicated on the rear surface. Therefore, the adhesive should not be applied to this area, and indicated values should be transferred to other locations as a precaution.
- d) The notch of the package is used for directional index, and that can not be used for reference of fixing. In addition, the cover glass and seal resin may overlap with the notch of the package.
- e) If the leads are bent repeatedly and metal, etc., clash or rub against the package, the dust may be generated by the fragments of resin.
- f) Acrylate anaerobic adhesives are generally used to attach CCD image sensors. In addition, cyanoacrylate instantaneous adhesives are sometimes used jointly with acrylate anaerobic adhesives. (reference)

5) Others

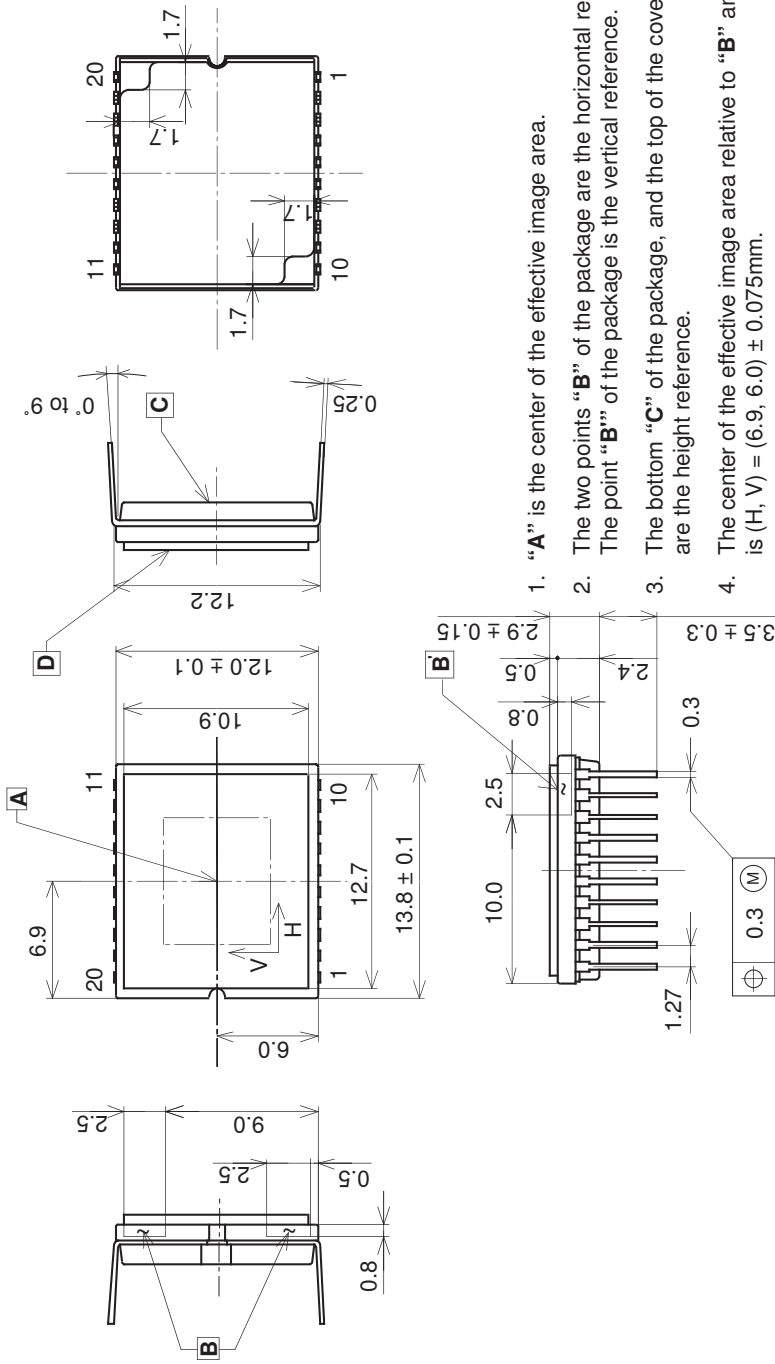
- a) Do not expose to strong light (sun rays) for long periods. For continuous using under cruel condition exceeding the normal using condition, consult our company.
- b) Exposure to high temperature or humidity will affect the characteristics. Accordingly avoid storage or usage in such conditions.
- c) Brown stains may be seen on the bottom or side of the package. But this does not affect the CCD characteristics.
- d) This package has 2 kinds of internal structure. However, their package outline, optical size, and strength are the same.



The cross section of lead frame can be seen on the side of the package for structure A.

Package Outline Unit: mm

20 pin DIP



1. "A" is the center of the effective image area.
2. The two points "B" of the package are the horizontal reference. The point "B" of the package is the vertical reference.
3. The bottom "C" of the package, and the top of the cover glass "D" are the height reference.
4. The center of the effective image area relative to "B" and "B'" is (H, V) = (6.9, 6.0) ± 0.075mm.
5. The rotation angle of the effective image area relative to H and V is ± 1°.
6. The height from the bottom "C" to the effective image area is 1.41 ± 0.10mm.
7. The height from the top of the cover glass "D" to the effective image area is 1.49 ± 0.15mm.
8. The tilt of the effective image area relative to the bottom "C" is less than 50µm.
9. The tilt of the effective image area relative to the top "D" of the cover glass is less than 50µm.
10. The thickness of the cover glass is 0.5mm, and the refractive index is 1.5.
11. The notches on the bottom of the package are used only for directional index, they must not be used for reference of fixing.

PACKAGE STRUCTURE

PACKAGE MATERIAL	Plastic
LEAD TREATMENT	GOLD PLATING
LEAD MATERIAL	42 ALLOY
PACKAGE MASS	0.95g
DRAWING NUMBER	AS-B6-04(E)